DSP56301

Advance Information 24-BIT DIGITAL SIGNAL PROCESSOR

The DSP56301 is a member of the DSP56300 core family of programmable CMOS Digital Signal Processors (DSPs). This family uses a high performance, single-clock-cycle-per-instruction engine providing a twofold performance increase over Motorola's popular DSP56000 core family, while retaining code compatibility. Significant architectural enhancements in the DSP56300 core family include a barrel shifter, 24-bit addressing, instruction cache, and Direct Memory Access (DMA). The DSP56301 offers 66/80/100 MIPS using an internal 66/80/100 MHz clock at 3.0–3.6 volts. The DSP56300 core family offers a new level of performance in speed and power provided by its rich instruction set and low power dissipation, enabling a new generation of wireless, telecommunications, and multimedia products.

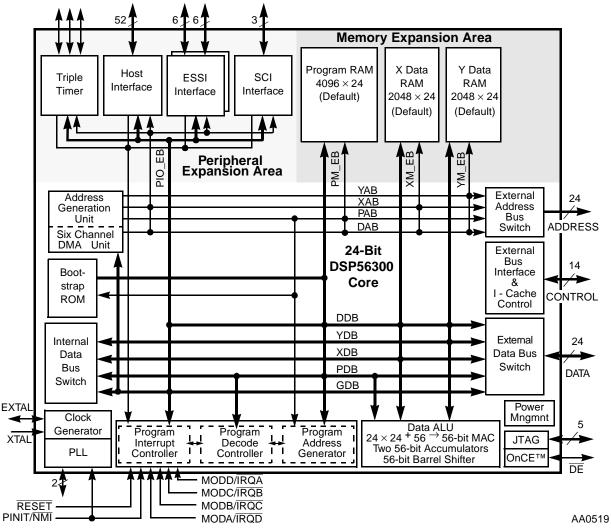


Figure 1 DSP56301 Block Diagram

This document contains information on a new product. Specifications and information herein are subject to change without notice.



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Data Sheet Conventions

This data sheet uses the following conventions:

OVERBAR	Used to indicate a signal that is active when pulled low (For example, the $\overline{\mbox{RESET}}$ pin is active when low.)					
"asserted"	Means that a high true (active high) signal is high or that a low true (active low) signal is low					
"deasserted"	Means that a high tru signal is high	Means that a high true (active high) signal is low or that a low true (active low) signal is high				
Examples:	Signal/Symbol Logic State		Signal State	Voltage ¹		
	PIN	True	Asserted	$V_{\rm IL}/V_{\rm OL}$		
	PIN	False	Deasserted	V_{IH}/V_{OH}		
	PIN	True	Asserted	V_{IH}/V_{OH}		
	PIN	False	Deasserted	V_{IL}/V_{OL}		

Note: Values for V_{IL} , V_{OL} , V_{IH} , and V_{OH} are defined by individual product specifications.

FEATURES

High Performance DSP56300 Core

- 66/80/100 Million Instructions Per Second (MIPS) with a 66/80/100 MHz clock at 3.0–3.6 V
- Object code compatible with the DSP56000 core
- Highly parallel instruction set
- Data Arithmetic Logic Unit (Data ALU)
 - Fully pipelined 24 x 24-bit parallel Multiplier-Accumulator (MAC)
 - 56-bit parallel barrel shifter (fast shift and normalization; bit stream generation and parsing)
 - Conditional ALU instructions
 - 24-bit or 16-bit arithmetic support under software control
- Program Control Unit (PCU)
 - Position Independent Code (PIC) support
 - Addressing modes optimized for DSP applications (including immediate offsets)
 - On-chip instruction cache controller
 - On-chip memory-expandable hardware stack
 - Nested hardware DO loops
 - Fast auto-return interrupts
- Direct Memory Access (DMA)
 - Six DMA channels supporting internal and external accesses
 - One-, two-, and three- dimensional transfers (including circular buffering)
 - End-of-block-transfer interrupts
 - Triggering from interrupt lines and all peripherals
- Phase Lock Loop (PLL)
 - Allows change of low power Divide Factor (DF) without loss of lock
 - Output clock with skew elimination

Features

- Hardware debugging support
 - On-Chip Emulation (OnCETM) module
 - Joint Action Test Group (JTAG) Test Access Port (TAP) port
 - Address Trace mode reflects internal Program RAM accesses at the external port

On-Chip Memories

• Program RAM, instruction cache, X data RAM, and Y data RAM sizes are programmable:

Program RAM Size	Instruction Cache Size	X Data RAM Size	Y Data RAM Size	Instruction Cache ¹	Switch Mode ²
4096×24 -bit	0	2048×24 -bit	2048×24 -bit	$\begin{array}{c} disabled \\ (CE = 0) \end{array}$	disabled (MS = 0)
3072×24 -bit	1024×24 -bit	2048×24 -bit	2048×24 -bit	enabled (CE = 1)	disabled (MS = 0)
2048×24 -bit	0	3072×24 -bit	3072×24 -bit	$\begin{array}{c} disabled \\ (CE = 0) \end{array}$	enabled (MS = 1)
1024×24 -bit	1024×24 -bit	3072×24 -bit	3072×24 -bit	enabled $(CE = 1)$	enabled $(MS = 1)$

Note: 1. Controlled by the Cache Enable (CE) bit in the Status Register (SR)

• 192 × 24-bit bootstrap ROM

Off-Chip Memory Expansion

- Data memory expansion to two 16 M \times 24-bit word memory spaces in 24-Bit mode or two 64 K \times 16-bit memory spaces in 16-Bit Compatibility mode
- Program memory expansion to one 16 M \times 24-bit words memory space in 24-Bit mode or 64 K \times 16-bit in 16-Bit Compatibility mode
- External memory expansion port
- Chip Select Logic for glueless interface to SRAMs
- On-chip DRAM Controller for glueless interface to DRAMs

^{2.} Controlled by the Memory Select (MS) bit in the Operating Mode Register (OMR)

On-Chip Peripherals

- 32-bit parallel PCI/Universal Host Interface (HI32), PCI Rev. 2.1 compliant with glueless interface to other DSP563xx buses
- ISA interface requires only 74LS45-style buffer
- Two Enhanced Synchronous Serial Interfaces (ESSI0 and ESSI1)
- Serial Communications Interface (SCI) with baud rate generator
- Triple timer module
- Up to forty-two programmable General Purpose Input/Output (GPIO) pins, depending on which peripherals are enabled

Reduced Power Dissipation

- Very low power CMOS design
- · Wait and Stop low power standby modes
- Fully-static logic, operation frequency down to 0 Hz (DC)
- Optimized power management circuitry (instruction-dependent, peripheraldependent, and mode-dependent)

TARGET APPLICATIONS

The DSP56301 is intended for general-purpose digital signal processing, particularly in multimedia and telecommunication applications, such as videoconferencing and cellular telephony.

PRODUCT DOCUMENTATION

The three documents listed in the following table are required for a complete description of the DSP56301 and are necessary to design properly with the part. Documentation is available from one of the following locations (see back cover for detailed information):

- A local Motorola distributor
- A Motorola semiconductor sales office
- A Motorola Literature Distribution Center
- The World Wide Web (WWW)

See the **Additional Support** section of the *DSP56300 Family Manual* for detailed information on the multiple support options available to you.

Table 1 DSP56301 Documentation

Name	Description	Order Number
DSP56300 Family Manual	Detailed description of the DSP56300 family processor core and instruction set	DSP56300FM/AD
DSP56301 User's Manual	Detailed functional description of the DSP56301 memory configuration, operation, and register programming	DSP56301UM/AD
DSP56301 Technical Data	DSP56301 features list and physical, electrical, timing, and package specifications	DSP56301/D



SECTION 1

SIGNAL/CONNECTION DESCRIPTIONS

SIGNAL GROUPINGS

The input and output signals of the DSP56301 are organized into functional groups, as shown in **Table 1-1** and as illustrated in **Figure 1-1**.

The DSP56301 is operated from a 3 V supply; however, some of the inputs can tolerate 5 V. A special notice for this feature is added to the signal descriptions of those inputs.

Table 1-1 DSP56301 Functional Signal Groupings

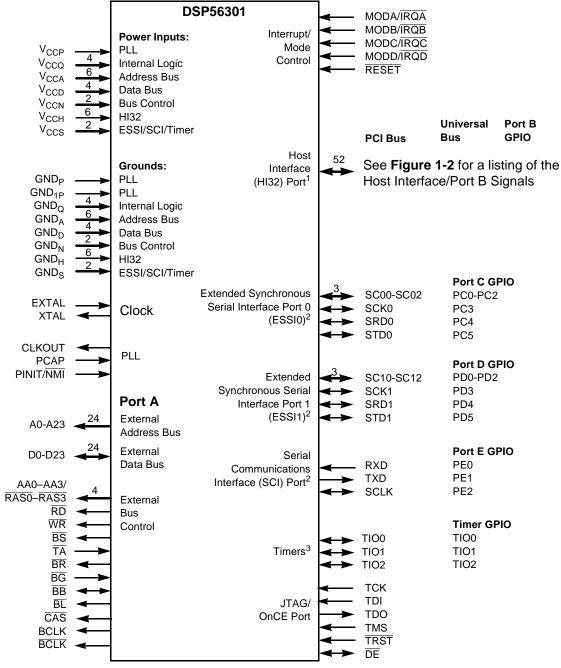
Functional Group	Number of Signals	Detailed Description	
Power (V _{CC})		25	Table 1-2
Ground (GND)		26	Table 1-3
Clock		2	Table 1-4
PLL	<u> </u>	3	Table 1-5
Address Bus	Port A ¹	24	Table 1-6
Data Bus	24	Table 1-7	
Bus Control	15	Table 1-8	
Interrupt and Mode Control		5	Table 1-9
Host Interfac <mark>e (HI32)</mark>	Port B ²	52	Table 1-11
Extended Synchronous Serial Interface (ESSI)	Ports C and D ³	12	Table 1-12 and Table 1-13
Serial Communication Interface (SCI)	Port E ⁴	3	Table 1-14
Timer	3	Table 1-15	
JTAG/OnCE Port		6	Table 1-16

Note: 1. Port A signals define the external memory interface port, including the external address bus, data bus, and control signals.

- 2. Port B signals are the HI32 port signals multiplexed with the GPIO signals.
- 3. Port C and D signals are the two ESSI port signals multiplexed with the GPIO signals.
- 4. Port E signals are the SCI port signals multiplexed with the GPIO signals.

Figure 1-1 is a diagram of DSP56301 signals by functional group.

Signal Groupings



Note:

- The HI32 port supports PCI and non-PCI bus configurations. Twenty-four of these HI32 signals can also be configured alternately as GPIO signals (PB0–PB23).
- 2. The ESSI0, ESSI1, and SCI signals are multiplexed with the Port C GPIO signals (PC0–PC5), Port D GPIO signals (PD0–PD5), and Port E GPIO signals (PE0–PE2), respectively.
- 3. TIO0-TIO2 can be configured as GPIO signals.

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Figure 1-1 Signals Identified by Functional Group

DSP56301	PCI Bus	Universal Bus	Port B GPIO	Host Port (HP) Reference
20.000.	HAD0	HA3	PB0	HP0
	HAD1	HA4	PB1	HP1
	HAD2	HA5	PB2	HP2
	HAD3	HA6	PB3	HP3
	HAD4	HA7	PB4	HP4
	HAD5	HA8	PB5	HP5
	HAD6	HA9	PB6	HP6
	HAD7	HA10	PB7	HP7
	HAD8	HD0	PB8	HP8
	HAD9	HD1	PB9	HP9
	HAD10	HD2	PB10	HP10
	HAD11	HD3	PB11	HP11
	HAD12	HD4	PB12	HP12
	HAD13	HD5	PB13	HP13
	HAD14	HD6	PB14	HP14
	HAD15	HD7	PB15	HP15
	HC0/HBE0	HA0	PB16	HP16
	HC1/HBE1	HA1	PB17	HP17
	HC2/HBE2	HA2	PB18	HP18
Host Interface (HI32)/	HC3/HBE3	Tie to pull-up or V _{CC}	PB19	HP19
nost interface (ni32)/	HTRDY	HDBEN	PB20	HP20
D . D . D . D . D . D . D . D . D . D .	HIRDY	HDBDR	PB21	HP21
Port B Signals	HDEVSEL	HSAK	PB22	HP22
	HLOCK	HBS	PB23	HP23
	HPAR	HDAK	Internal disconnect	HP24
	HPERR	HDRQ	Internal disconnect	HP25
	HGNT	HAEN	Internal disconnect	HP26
	HREQ	HTA	Internal disconnect	HP27
	HSERR	HIRQ	Internal disconnect	HP28
	HSTOP	HWR/HRW	Internal disconnect	HP29
	HIDSEL	HRD/HDS	Internal disconnect	HP30
	HFRAME	Tie to pull-up or V _{CC}	Internal disconnect	HP31
	HCLK	Tie to pull-up or V _{CC}	Internal disconnect	HP32
	HAD16	HD8	Internal disconnect	HP33
	HAD17	HD9	Internal disconnect	HP34
	HAD18	HD10	Internal disconnect	HP35
	HAD19	HD11	Internal disconnect	HP36
	HAD20	HD12	Internal disconnect	HP37
	HAD21	HD13	Internal disconnect	HP38
	HAD22	HD14	Internal disconnect	HP39
	HAD23	HD15	Internal disconnect	HP40
	HAD24	HD16	Internal disconnect	HP41
	HAD25	HD17	Internal disconnect	HP42
	HAD26	HD18	Internal disconnect	HP43
	HAD27	HD19	Internal disconnect	HP44
	HAD28	HD20	Internal disconnect	HP45
	HAD29	HD21	Internal disconnect	HP46
	HAD30	HD22	Internal disconnect	HP47
	HAD31	HD23	Internal disconnect	HP48
	HRST	HRST	Internal disconnect	HP49
	HINTA	HINTA	Internal disconnect	HP50
	PVCL	Leave unconnected	Leave unconnected	PVCL

Note: HPxx is a reference only and is not a signal name. GPIO references formerly designated as HIOxx have been renamed PBxx for consistency with other Motorola DSPs.

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Figure 1-2 Host Interface/Port B Detail Signal Diagram

Power

POWER

 Table 1-2
 Power Inputs

Power Name	Description		
V _{CCP}	PLL Power $-V_{CCP}$ provides isolated power for the Phase Lock Loop (PLL). The voltage should be well-regulated and the input should be provided with an extremely low impedance path to the V_{CC} power rail. There is one V_{CCP} input.		
V _{CCQ} (4)	Quiet Power — V_{CCQ} provides isolated power for the internal processing logic. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are four V_{CCQ} inputs.		
V _{CCA} (6)	Address Bus Power — V_{CCA} provides isolated power for sections of the address bus I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are six V_{CCA} inputs.		
V _{CCD} (4)	Data Bus Power $-V_{CCD}$ provides isolated power for sections of the data bus I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are four V_{CCD} inputs.		
V _{CCN} (2)	Bus Control Power — V_{CCN} provides isolated power for the bus control I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are two V_{CCN} inputs.		
V _{CCH} (6)	Host Power —V _{CCH} provides isolated power for the HI32 I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There is one V _{CCH} input.		
V _{CCS} (2) ESSI, SCI, and Timer Power —V _{CCS} provides isolated power for the ESSI, SCI, and timer I/O drivers. This input must be tied externally to all other chip power inputs. The user must provide adequate external decoupling capacitors. There are two V _{CCS} inputs.			
other interr	Note: These designations are package-dependent. Some packages connect all V_{CC} inputs except V_{CCP} to each other internally. On those packages, all power input, except V_{CCP} , are labeled V_{CC} . The numbers of connections indicated in this table are minimum values; the total V_{CC} connections are package-dependent.		

GROUND

Table 1-3 Grounds

Ground Name	Description			
GND_P	PLL Ground —GND _P is ground dedicated for PLL use. The connection should be provided with an extremely low-impedance path to ground. V_{CCP} should be bypassed to GND _P by a 0.47 μF capacitor located as close as possible to the chip package. There is one GND _P connection.			
GND _{1P}	PLL Ground 1 —GND _{1P} is ground dedicated for PLL use. The connection should be provided with an extremely low-impedance path to ground. There is one GND_{P1} connection.			
GND _Q (4)	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$			
GND _A (6)	Address Bus Ground — GND_A provides isolated ground for sections of the address bus I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are four GND_A connections.			
GND _D (4)	Data Bus Ground —GND _D provides isolated ground for sections of the data bus I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are four GND _D connections.			
GND _N (2)	Bus Control Ground — GND $_{\rm N}$ provides isolated ground for the bus control I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are two GND $_{\rm N}$ connections.			
GND _H (6)	Host Ground —GND $_{\rm H}$ provides isolated ground for the HI32 I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There is one GND $_{\rm H}$ connection.			
GND _S (2)	ESSI, SCI, and Timer Ground —GND _S provides isolated ground for the ESSI, SCI, and timer I/O drivers. This connection must be tied externally to all other chip ground connections. The user must provide adequate external decoupling capacitors. There are two GND_{S} connections.			
GN <mark>D_{1P} to ea</mark> GND. The n	<u> </u>			

CLOCK

Table 1-4 Clock Signals

Signal Name	Туре	State During Reset	Signal Description
EXTAL	Input	Input	External Clock/Crystal Input —EXTAL interfaces the internal crystal oscillator input to an external crystal or an external clock.
XTAL	Output	Chip Driven	Crystal Output —XTAL connects the internal crystal oscillator output to an external crystal. If an external clock is used, leave XTAL unconnected.

PHASE LOCK LOOP (PLL)

Table 1-5 Phase Lock Loop Signals

Signal Name	Туре	State During Reset	Signal Description
PCAP	Input	Input	PLL Capacitor — PCAP is an input connecting an off-chip capacitor to the PLL filter. Connect one capacitor terminal to PCAP and the other terminal to V_{CCP} . If the PLL is not used, PCAP may be tied to V_{CC} , GND, or left floating.
CLKOUT	Output	Chip-driven	Clock Output —CLKOUT provides an output clock synchronized to the internal core clock phase. If the PLL is enabled and both the multiplication and division factors equal one, then CLKOUT is also synchronized to EXTAL. If the PLL is disabled, the CLKOUT frequency is half the frequency of EXTAL.
PINIT/NMI	Input	Input	PLL Initial/Non-Maskable Interrupt — During assertion of RESET, the value of PINIT/NMI is written into the PLL Enable (PEN) bit of the PLL control register, determining whether the PLL is enabled or disabled. After RESET deassertion and during normal instruction processing, the PINIT/NMI Schmitt-trigger input is a negative-edgetriggered Non-Maskable Interrupt (NMI) request internally synchronized to CLKOUT. PINIT/NMI can tolerate 5 V.

EXTERNAL MEMORY EXPANSION PORT (PORT A)

Note: When the DSP56301 enters a low-power standby mode (Stop or Wait), it releases bus mastership and tri-states the relevant Port A signals: A0–A23, D0–D23, AA0/RAS0–AA3/RAS3, RD, WR, BB, CAS, BCLK, and BCLK. If hardware refresh of external DRAM is enabled, Port A exits the Wait mode to allow the refresh to occur and then returns to the Wait mode.

EXTERNAL ADDRESS BUS

Table 1-6 External Address Bus Signals

Signal Name	Туре	State During Reset	Signal Description
A0-A23	Output	Tri-stated	Address Bus — When the DSP is the bus master, A0–A23 are active-high outputs that specify the address for external program and data memory accesses. Otherwise, the signals are tri-stated. To minimize power dissipation, A0–A23 do not change state when external memory spaces are not being accessed.

EXTERNAL DATA BUS

Table 1-7 External Data Bus Signals

Signal Name	Туре	State During Reset	Signal Description
D0-D23	Input/ Output	Tri-stated	Data Bus —When the DSP is the bus master, D0–D23 are active-high, bidirectional input/outputs that provide the bidirectional data bus for external program and data memory accesses. Otherwise, D0–D23 are tri-stated.

EXTERNAL BUS CONTROL

Table 1-8 External Bus Control Signals

Signal Name	Туре	State During Reset	Signal Description
AA0-AA3/ RAS0-RAS3	Output	Tri-stated	Address Attribute or Row Address Strobe — When defined as AA, these signals can be used as chip selects or additional address lines. When defined as RAS, these signals can be used as RAS for Dynamic Random Access Memory (DRAM) interface. These signals are tri-statable outputs with programmable polarity.
RD	Output	Tri-stated	Read Enable —When the DSP is the bus master, \overline{RD} is an active-low output that is asserted to read external memory on the data bus (D0 – D23). Otherwise, \overline{RD} is tri-stated.

External Memory Expansion Port (Port A)

 Table 1-8 External Bus Control Signals (Continued)

Signal Name	Туре	State During Reset	Signal Description
WR	Output	Tri-stated	Write Enable —When the DSP is the bus master, \overline{WR} is an active-low output that is asserted to write external memory on the data bus (D0 – D23). Otherwise, the signals are tri-stated.
BS	Output	Tri-stated	Bus Strobe—When the DSP is the bus master, BS is asserted for half a clock cycle at the start of a bus cycle to provide an "early bus start" signal for a bus controller. If the external bus is not used during an instruction cycle, BS remains deasserted until the next external bus cycle.
TĀt	Input	Ignored Input	Transfer Acknowledge —If the DSP56301 is the bus master and there is no external bus activity, or the DSP56301 is not the bus master, the TA input is ignored. The TA input is a Data Transfer Acknowledge (DTACK) function that can extend an external bus cycle indefinitely. Any number of wait states (1, 2,, infinity) may be added to the wait states inserted by the BCR by keeping TA deasserted. In typical operation, TA is deasserted at the start of a bus cycle, is asserted to enable completion of the bus cycle, and is deasserted before the next bus cycle. The current bus cycle completes one clock period after TA is asserted synchronous to CLKOUT. The number of wait states is determined by the TA input or by the Bus Control Register (BCR), whichever is longer. The BCR can be used to set the minimum number of wait states in external bus cycles. In order to use the TA functionality, the BCR must be programmed to at least one wait state. A zero wait state access can not be extended by TA deassertion, otherwise improper operation may result. TA can operate synchronously or asynchronously depending on the setting of the TAS bit in the
	8	, ,	Operating Mode Register (OMR). TA functionality may not be used while performing DRAM type accesses, otherwise improper operation may result.

 Table 1-8 External Bus Control Signals (Continued)

Signal Name	Туре	State During Reset	Signal Description
BR	Output	Output (deasserted)	Bus Request — \overline{BR} is an active-low output, never tri-stated. \overline{BR} is asserted when the DSP requests bus mastership. \overline{BR} is deasserted when the DSP no longer needs the bus. \overline{BR} may be asserted or deasserted independent of whether the DSP56301 is a bus master or a bus slave. Bus "parking" allows \overline{BR} to be deasserted even though the DSP56301 is the bus master (see the description of bus "parking" in the \overline{BB} signal description). The Bus Request Hold (BRH) bit in the BCR allows \overline{BR} to be asserted under software control even though the DSP does not need the bus. \overline{BR} is typically sent to an external bus arbitrator that controls the priority, parking, and tenure of each master on the same external bus. \overline{BR} is only affected by DSP requests for the external bus, never for the internal bus. During hardware reset, \overline{BR} is deasserted and the arbitration is reset to the bus slave state.
BG	Input	Ignored Input	Bus Grant — \overline{BG} is asserted by an external bus arbitration circuit when the DSP56301 becomes the next bus master. \overline{BG} must be asserted/deasserted synchronous to CLKOUT for proper operation. When \overline{BG} is asserted, the DSP56301 must wait until \overline{BB} is deasserted before taking bus mastership. When \overline{BG} is deasserted, bus mastership is typically given up at the end of the current bus cycle. This may occur in the middle of an instruction that requires more than one external bus cycle for execution.
BB	Input/ Output	Input	Bus Busy —BB indicates that the bus is active. BB must be asserted and deasserted synchronous to CLKOUT. Only after BB is deasserted can the pending bus master become the bus master (and then assert the signal again). The bus master may keep BB asserted after ceasing bus activity regardless of whether BR is asserted or deasserted. This is called "bus parking" and allows the current bus master to reuse the bus without re-arbitration until another device requires the bus. The deassertion of BB is done by an "active pull-up" method (i.e., BB is driven high and then released and held high by an external pull-up resistor). BB requires an external pull-up resistor.

External Memory Expansion Port (Port A)

 Table 1-8 External Bus Control Signals (Continued)

Signal Name	Туре	State During Reset	Signal Description
BL	Output	Driven high	Bus Lock—BL is asserted at the start of an external divisible Read-Modify-Write (RMW) bus cycle, remains asserted between the read and write cycles, and is deasserted at the end of the write bus cycle. This provides an "early bus start" signal for the bus controller. BL may be used to "resource lock" an external multi-port memory for secure semaphore updates. Early deassertion provides an "early bus end" signal useful for external bus control. If the external bus is not used during an instruction cycle, BL remains deasserted until the next external indivisible RMW cycle. The only instructions that assert BL automatically are BSET, CLR, and BCHG when the access external memory. An operation can also assert BL by setting the BLH bit in the Bus Control Register.
CAS	Output	Tri-stated	Column Address Strobe — When the DSP is the bus master, CAS is used by DRAM to strobe the column address. Otherwise, if the Bus Mastership Enable (BME) bit in the DRAM Control Register is cleared, the signal is tri-stated.
BCLK	Output	Tri-stated	Bus Clock —When the DSP is the bus master, BCLK is an active-high output that is active when the ATE bit in the OMR is set. When BCLK is active and synchronized to CLKOUT by the internal PLL, BCLK precedes CLKOUT by one-fourth of a clock cycle.
BCLK	Output	Tri-stated	Bus Clock Not—When the DSP is the bus master, BCLK is an active-low output that is the inverse of the BCLK signal. Otherwise, the signal is tri-stated.

INTERRUPT AND MODE CONTROL

The interrupt and mode control signals select the chip's operating mode as it comes out of hardware reset. After $\overline{\text{RESET}}$ is deasserted, these inputs are hardware interrupt request lines.

 Table 1-9
 Interrupt and Mode Control

Signal Name	Туре	State During Reset	Signal Description
RESET	Input	Input	Reset—RESET is an active-low, Schmitt-trigger input. Deassertion of RESET is internally synchronized to the clock out (CLKOUT). When asserted, the chip is placed in the Reset state and the internal phase generator is reset. The Schmitt-trigger input allows a slowly rising input (such as a capacitor charging) to reset the chip reliably. If RESET is deasserted synchronous to CLKOUT, exact start-up timing is guaranteed, allowing multiple processors to start synchronously and operate together in "lock-step." When the RESET signal is deasserted, the initial chip operating mode is latched from the MODA, MODB, MODC, and MODD inputs. The RESET signal must be asserted after power up.
MODA	Input	Input	Mode Select A—MODA selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input IRQA during normal instruction processing. MODA, MODB, MODC, and MODD select one of sixteen initial chip operating modes, latched into the OMR when the RESET signal is deasserted.
ĪRQĀ	Input		External Interrupt Request A — \overline{IRQA} is an active-low Schmitt-trigger input, internally synchronized to CLKOUT. If \overline{IRQA} is asserted synchronous to CLKOUT, multiple processors can be re-synchronized using the WAIT instruction and asserting \overline{IRQA} to exit the Wait state. If the processor is in the Stop standby state and \overline{IRQA} is asserted, the processor will exit the Stop state. These inputs are 5 V tolerant.

 Table 1-9 Interrupt and Mode Control (Continued)

Signal Name	Туре	State During Reset	Signal Description
MODB	Input	Input	Mode Select B—MODB selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input IRQB during normal instruction processing. MODA, MODB, MODC, and MODD select one of sixteen initial chip operating modes, latched into the OMR when the RESET signal is deasserted.
ĪRQB	Input		External Interrupt Request B—IRQB is an active-low Schmitt-trigger input, internally synchronized to CLKOUT. If IRQB is asserted synchronous to CLKOUT, multiple processors can be re-synchronized using the WAIT instruction and asserting IRQB to exit the Wait state. If the processor is in the Stop standby state and IRQC is asserted, the processor will exit the Stop state. These inputs are 5 V tolerant.
MODC	Input	Input	Mode Select C—MODC selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input IRQC during normal instruction processing. MODA, MODB, MODC, and MODD select one of sixteen initial chip operating modes, latched into the OMR when the RESET signal is deasserted.
ĪRQC	Input		External Interrupt Request C—IRQC is an active-low Schmitt-trigger input, internally synchronized to CLKOUT. If IRQC is asserted synchronous to CLKOUT, multiple processors can be re-synchronized using the WAIT instruction and asserting IRQC to exit the Wait state. If the processor is in the Stop standby state and IRQC is asserted, the processor will exit the Stop state. These inputs are 5 V tolerant.

 Table 1-9
 Interrupt and Mode Control (Continued)

Signal Name	Туре	State During Reset	Signal Description
MODD	Input	Input	Mode Select D—MODD selects the initial chip operating mode during hardware reset and becomes a level-sensitive or negative-edge-triggered, maskable interrupt request input IRQD during normal instruction processing. MODA, MODB, MODC, and MODD select one of sixteen initial chip operating modes, latched into the OMR when the RESET signal is deasserted.
ĪRQD	Input		External Interrupt Request D—IRQD is an active-low Schmitt-trigger input, internally synchronized to CLKOUT. If IRQD is asserted synchronous to CLKOUT, multiple processors can be re-synchronized using the WAIT instruction and asserting IRQD to exit the Wait state. If the processor is in the Stop standby state and IRQD is asserted, the processor will exit the Stop state. These inputs are 5 V tolerant.



Host Interface (HI32)

HOST INTERFACE (HI32)

The Host Interface (HI32) provides a fast parallel data to 32-bit port, which may be connected directly to the host bus.

The HI32 supports a variety of standard buses, and provides a glueless connection to a PCI bus and a number of industry-standard microcomputers, microprocessors, DSPs, and DMA hardware.

Host Port Usage Considerations

Careful synchronization is required when reading multiple-bit registers that are written by another asynchronous system. This is a common problem when two asynchronous systems are connected (as they are in the Host port). The considerations for proper operation are discussed in the following table:

Table 1-10 Host Port Usage Considerations

Action	Description
Asynchronous read of receive byte registers	When reading the receive byte registers, Receive register High (RXH), Receive register Middle (RXM), or Receive register Low (RXL), the host interface programmer should use interrupts or poll the Receive register Data Full (RXDF) flag which indicates that data is available. This assures that the data in the receive byte registers will be valid.
Asynchronous write to transmit byte registers	The host interface programmer should not write to the transmit byte registers, Transmit register High (TXH), Transmit register Middle (TXM), or Transmit register Low (TXL), unless the Transmit register Data Empty (TXDE) bit is set indicating that the transmit byte registers are empty. This guarantees that the transmit byte registers will transfer valid data to the Host Receive (HRX) register.
Asynchronous write to host vector	The host interface programmer should change the Host Vector (HV) register only when the Host Command bit (HC) is clear. This will guarantee that the DSP interrupt control logic will receive a stable vector.

Host Port Configuration

The functions of the signals associated with the HI32 vary according to the programmed configuration of the interface as determined by the 24-bit DSP Control Register (DCTR). Refer to the *DSP56301 User's Manual* for detailed descriptions of this and the other configuration registers used with the HI32.

Table 1-11 Host Interface

Signal Name	Туре	State During Reset	Signal Description
HAD0-HAD7	Input/ Output	Tri-stated	Host Address/Data 0-7—When the HI32 is programmed to interface a PCI bus and the HI function is selected, these signals are lines 0-7 of the bidirectional, multiplexed Address/Data bus.
НА3-НА10	Input		Host Address 3–10—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, these signals are lines 3–10 of the input Address bus.
PB0-PB7	Input or Output		Port B 0-7—When the HI32 is configured as GPIO through the DCTR, these signals are individually programmed as inputs or outputs through the HI32 Data Direction Register (DIRH). These inputs are 5 V tolerant.
HAD8-HAD15 HD0-HD7	Input/ Output	Tri-stated	Host Address/Data 8–15—When the HI32 is programmed to interface a PCI bus and the HI function is selected, these signals are lines 8–15 of the bidirectional, multiplexed Address/Data bus.
PB8-PB15	Input/ Output		Host Data 0–7 —When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, these signals are lines 0–7 of the bidirectional Data bus.
L DO-L D13	Input or Output		Port B 8–15 —When the HI32 is configured as GPIO through the DCTR, these signals are individually programmed as inputs or outputs through the HI32 DIRH.
			These inputs are 5 V tolerant.

 Table 1-11 Host Interface (Continued)

Signal Name	Туре	State During Reset	Signal Description
HC0-HC3/ HBE0-HBE3	Input/ Output	Tri-stated	Command 0-3/Byte Enable 0-3—When the HI32 is programmed to interface a PCI bus and the HI function is selected, these signals are lines 0-7 of the bidirectional, multiplexed Address/Data bus.
НА0-НА2	Input		Host Address 0-2—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, these signals are lines 0-2 of the input Address bus.
PB16-PB19	Input or		Note: The fourth signal in this set should be connected to a pull-up resistor or directly to V _{CC} when using a non-PCI bus. Port B 16–19—When the HI32 is configured as GPIO
	Output		through the DCTR, these signals are individually programmed as inputs or outputs through the HI32 DIRH. These inputs are 5 V tolerant.
HTRDY	Input/ Output	Tri-stated	Host Target Ready—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Target Ready signal.
HDBEN	Output		Host Data Bus Enable —When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Data Bus Enable output.
PB20	Input or Output		Port B 20 —When the HI32 is configured as GPIO through the DCTR, this signal is individually programmed as an input or output through the HI32 DIRH.
			This input is 5 V tolerant.
HIRDY	Input/ Output	Tri-stated	Host Initiator Ready —When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Initiator Ready signal.
HDBDR	Output		Host Data Bus Direction —When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Data Bus Direction output.
PB21	Input or Output		Port B 21 —When the HI32 is configured as GPIO through the DCTR, this signal is individually programmed as an input or output through the HI32 DIRH.
			This input is 5 V tolerant.

 Table 1-11 Host Interface (Continued)

Signal Name	Туре	State During Reset	Signal Description
HDEVSEL	Input/ Output	Tri-stated	Host Device Select —When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Device Select signal.
HSAK	Output		Host Select Acknowledge—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Select Acknowledge output.
PB22	Input or Output		Port B 22—When the HI32 is configured as GPIO through the DCTR, this signal is individually programmed as an input or output through the HI32 DIRH. This input is 5 V tolerant.
HLOCK	Input/ Output	Tri-stated	Host Lock—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Lock signal.
HBS	Input		Host Bus Strobe—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Bus Strobe Schmitt-trigger input.
PB23	Input or Output		Port B 23 —When the HI32 is configured as GPIO through the DCTR, this signal is individually programmed as an input or output through the HI32 DIRH.
			This input is 5 V tolerant.
HPAR	Input/ Output	Tri-stated	Host Parity —When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Parity signal.
HDAK	Input		Host DMA Acknowledge —When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host DMA Acknowledge Schmitttrigger input.
>			Port B —When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected.
			This input is 5 V tolerant.

Host Interface (HI32)

 Table 1-11 Host Interface (Continued)

Signal Name	Туре	State During Reset	Signal Description
HPERR	Input/ Output	Tri-stated	Host Parity Error —When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Parity Error signal.
HDRQ	Output		Host DMA Request—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host DMA Request output.
			Port B — When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected.
			This input is 5 V toleran <mark>t.</mark>
HGNT	Input	Input	Host Bus Grant—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Bus Grant signal.
HAEN	Input		Host Address Enable—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Address Enable output.
			Port B—When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected.
			This input is 5 V tolerant.
HREQ	Output	Tri-stated	Host Bus Request—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Bus Request signal.
НТА	Output		Host Transfer Acknowledge—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Data Bus Enable output.
			Port B —When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected.
			This input is 5 V tolerant.

 Table 1-11 Host Interface (Continued)

Signal Name	Туре	State During Reset	Signal Description
HSERR	Output, open drain	Tri-stated	Host System Error —When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host System Error signal.
HIRQ	Output, open drain		Host Interrupt Request—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Interrupt Request output.
			Port B —When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected.
			This input is 5 V tolerant.
HSTOP	Input/ Output	Tri-stated	Host Stop—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Stop signal.
HWR/HRW	Input		Host Write/Host Read-Write—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Write/Host Read-Write Schmitt-trigger input.
			Port B —When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected.
			This input is 5 V tolerant.
HIDSEL	Input	Input	Host Initialization Device Select —When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Initialization Device Select signal.
HRD/HDS	Input		Host Read/Host Data Strobe—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is Host Data Read/Host Data Strobe Schmitt-trigger input.
			Port B —When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected.
_			This input is 5 V tolerant.

Host Interface (HI32)

 Table 1-11 Host Interface (Continued)

Signal Name	Туре	State During Reset	Signal Description
HFRAME	Input/ Output	Tri-stated	Host Frame—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host cycle Frame signal. Non-PCI bus—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal must be connected to a pull-up resistor or directly to V _{CC} . Port B —When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected. This input is 5 V tolerant.
HCLK	Input	Input	Host Clock—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Host Bus Clock input. Non-PCI bus—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal must be connected to a pull-up resistor or directly to V _{CC} . Port B—When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected. This input is 5 V tolerant.
HAD16- HAD31	Input/ Output	Tri-stated	Host Address/Data 16–31—When the HI32 is programmed to interface a PCI bus and the HI function is selected, these signals are lines 16–31 of the bidirectional, multiplexed Address/Data bus.
HD8-HD23	Input/ Output		Host Data 8–23—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, these signals are lines 8–23 of the bidirectional Data bus. Port B —When the HI32 is configured as GPIO through the DCTR, these signals are internally disconnected.
			These inputs are 5 V tolerant.

 Table 1-11 Host Interface (Continued)

Signal Name	Туре	State During Reset	Signal Description
HRST	Input	Tri-stated	Hardware Reset—When the HI32 is programmed to interface a PCI bus and the HI function is selected, this is the Hardware Reset input.
HRST	Input		Hardware Reset—When HI32 is programmed to interface a universal non-PCI bus and the HI function is selected, this signal is the Hardware Reset Schmitt-trigger input. Port B—When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected. This input is 5 V tolerant.
HINTA	Output, open drain	Tri-stated	Host Interrupt A—When the HI function is selected, this signal is the Interrupt A open-drain output. Port B —When the HI32 is configured as GPIO through the DCTR, this signal is internally disconnected. This input is 5 V tolerant.
PVCL	Input	Input	PCI Voltage Clamp—When the HI32 is programmed to interface a PCI bus and the HI function is selected and the PCI bus uses a 3 V signal environment, connect this pin to V _{CC} (3.3 V) to enable the high voltage clamping required by the PCI specifications. In all other cases, including a 5 V PCI signal environment, leave the input unconnected.

ENHANCED SYNCHRONOUS SERIAL INTERFACE 0 (ESSI0)

There are two synchronous serial interfaces (ESSI0 and ESSI1) that provide a full-duplex serial port for serial communication with a variety of serial devices, including one or more industry-standard codecs, other DSPs, microprocessors, and peripherals which implement the Motorola Serial Peripheral Interface (SPI).

Table 1-12 Enhanced Synchronous Serial Interface 0 (ESSI0)

Signal Name	Туре	State During Reset	Signal Description
SC00 PC0	Input or Output	Input	Serial Control 0 —The function of SC00 is determined by the selection of either Synchronous or Asynchronous mode. For Asynchronous mode, this signal will be used for the receive clock I/O (Schmitt-trigger input). For Synchronous mode, this signal is used either for Transmitter 1 output or for Serial I/O Flag 0. Port C 0—The default configuration following reset is GPIO input PC0. When configured as PC0, signal direction is controlled through the Port Directions Register (PRR0). The signal can be configured as ESSI signal SC00 through the Port Control Register (PCR0).
SC01	Input/Output	Input	This input is 5 V tolerant. Serial Control 1 —The function of this signal is determined by the selection of either Synchronous or Asynchronous mode. For Asynchronous mode, this signal is the receiver frame sync I/O. For Synchronous mode, this signal is used either for Transmitter 2 output or for Serial I/O Flag 1.
PC1	Input or Output		Port C 1 —The default configuration following reset is GPIO input PC1. When configured as PC1, signal direction is controlled through PRR0. The signal can be configured as an ESSI signal SC01 through PCR0. This input is 5 V tolerant.

Enhanced Synchronous Serial Interface 0 (ESSI0)

 Table 1-12
 Enhanced Synchronous Serial Interface 0 (ESSI0) (Continued)

Signal Name	Туре	State During Reset	Signal Description
SC02	Input/Output	Input	Serial Control Signal 2 —SC02 is used for frame sync I/O. SC02 is the frame sync for both the transmitter and receiver in Synchronous mode, and for the transmitter only in Asynchronous mode. When configured as an output, this signal is the internally generated frame sync signal. When configured as an input, this signal receives an external frame sync signal for the transmitter (and the receiver in synchronous operation).
PC2	Input or Output		Port C 2—The default configuration following reset is GPIO input PC2. When configured as PC2, signal direction is controlled through PRR0. The signal can be configured as an ESSI signal SC02 through PCR0. This input is 5 V tolerant.
SCK0	Input/Output	Input	Serial Clock —SCK0 is a bidirectional Schmitt-trigger input signal providing the serial bit rate clock for the ESSI interface. The SCK0 is a clock input or output used by both the transmitter and receiver in Synchronous modes, or by the transmitter in Asynchronous modes. Although an external serial clock can be independent of and asynchronous to the DSP system clock, it must exceed the minimum clock cycle time of 6 T (i.e., the system clock frequency must be at least three times the external ESSI clock frequency). The ESSI needs at least three DSP phases inside each half of the serial
PC3	Input or Output		clock. Port C 3 —The default configuration following reset is GPIO input PC3. When configured as PC3, signal direction is controlled through PRR0. The signal can be configured as an ESSI signal SCK0 through PCR0. This input is 5 V tolerant.

Enhanced Synchronous Serial Interface 0 (ESSI0)

 Table 1-12
 Enhanced Synchronous Serial Interface 0 (ESSI0) (Continued)

Signal Name	Туре	State During Reset	Signal Description
SRD0	Input/Output Input or Output	Input	Serial Receive Data —SRD0 receives serial data and transfers the data to the ESSI receive shift register. SRD0 is an input when data is being received. Port C 4—The default configuration following reset is GPIO input PC4. When configured as PC4, signal direction is controlled through PRR0. The signal can be configured as an ESSI signal SRD0 through PCR0. This input is 5 V tolerant.
STD0 PC5	Input/Output Input or Output	Input	Serial Transmit Data — STD0 is used for transmitting data from the serial transmit shift register. STD0 is an output when data is being transmitted. Port C 5—The default configuration following reset is GPIO input PC5. When configured as PC5, signal direction is controlled through PRR0. The signal can be configured as an ESSI signal STD0 through PCR0. This input is 5 V tolerant.



ENHANCED SYNCHRONOUS SERIAL INTERFACE 1 (ESSI1)

 Table 1-13
 Enhanced Synchronous Serial Interface 1 (ESSI1)

Signal Name	Туре	State During Reset	Signal Description
SC10	Input or Output	Input	Serial Control 0 — The function of SC10 is determined by the selection of either Synchronous or Asynchronous mode. For Asynchronous mode, this signal will be used for the receive clock I/O (Schmitt-trigger input). For Synchronous mode, this signal is used either for Transmitter 1 output or for Serial I/O Flag 0. Port D 0—The default configuration following reset is GPIO input PD0. When configured as PD0, signal direction is controlled through the Port Directions Register (PRR1). The signal can be configured as an ESSI signal SC10 through the Port Control Register (PCR1).
			This input is 5 V tolerant.
SC11	Input/Output	Input	Serial Control 1 —The function of this signal is determined by the selection of either Synchronous or Asynchronous mode. For Asynchronous mode, this signal is the receiver frame sync I/O. For Synchronous mode, this signal is used either for Transmitter 2 output or for Serial I/O Flag 1.
PD1	Input or Output		Port D 1 —The default configuration following reset is GPIO input PD1. When configured as PD1, signal direction is controlled through PRR1. The signal can be configured as an ESSI signal SC11 through PCR1.
			This input is 5 V tolerant.

 Table 1-13
 Enhanced Synchronous Serial Interface 1 (ESSI1) (Continued)

Signal Name	Туре	State During Reset	Signal Description
SC12	Input/Output	Input	Serial Control Signal 2 —SC12 is used for frame sync I/O. SC12 is the frame sync for both the transmitter and receiver in Synchronous mode, and for the transmitter only in Asynchronous mode. When configured as an output, this signal is the internally generated frame sync signal. When configured as an input, this signal receives an external frame sync signal for the transmitter (and the receiver in Synchronous operation).
PD2	Input or Output		Port D 2—The default configuration following reset is GPIO input PD2. When configured as PD2, signal direction is controlled through PRR1. The signal can be configured as an ESSI signal SC12 through PCR1. This input is 5 V tolerant.
SCK1	Input/Output	Input	Serial Clock —SCK1 is a bidirectional Schmitt-trigger input signal providing the serial bit rate clock for the ESSI interface. The SCK1 is a clock input or output used by both the transmitter and receiver in Synchronous modes, or by the transmitter in Asynchronous modes. Although an external serial clock can be independent of and asynchronous to the DSP system clock, it must exceed the minimum clock cycle time of 6 T (i.e., the system clock frequency must be at least three times the external ESSI clock frequency). The ESSI needs at least three DSP phases inside each half of the serial clock.
PD3	Input or Output		Port D 3 —The default configuration following reset is GPIO input PD3. When configured as PD3, signal direction is controlled through PRR1. The signal can be configured as an ESSI signal SCK1 through PCR1. This input is 5 V tolerant.

 Table 1-13
 Enhanced Synchronous Serial Interface 1 (ESSI1) (Continued)

Signal Name	Туре	State During Reset	Signal Description
SRD1	Input/Output Input or Output	Input	Serial Receive Data —SRD1 receives serial data and transfers the data to the ESSI receive shift register. SRD1 is an input when data is being received. Port D 4—The default configuration following reset is GPIO input PD4. When configured as PD4, signal direction is controlled through PRR1. The signal can be configured as an ESSI signal SRD1 through PCR1.
STD1 PD5	Input/Output Input or Output	Input	This input is 5 V tolerant. Serial Transmit Data —STD1 is used for transmitting data from the serial transmit shift register. STD1 is an output when data is being transmitted. Port D 5—The default configuration following reset is GPIO input PD5. When configured as PD5, signal direction is controlled through PRR1. The signal can be configured as an ESSI signal STD1 through PCR1. This input is 5 V tolerant.



SERIAL COMMUNICATION INTERFACE (SCI)

The Serial Communication interface (SCI) provides a full duplex port for serial communication to other DSPs, microprocessors, or peripherals such as modems.

 Table 1-14 Serial Communication Interface (SCI)

Signal Name	Туре	State During Reset	Signal Description
RXD	Input	Input	Serial Receive Data — This input receives byte oriented serial data and transfers it to the SCI receive shift register.
PE0	Input or Output		Port E 0—The default configuration following reset is GPIO input PE0. When configured as PE0, signal direction is controlled through the SCI Port Directions Register (PRR). The signal can be configured as an SCI signal RXD through the SCI Port Control Register (PCR). This input is 5 V tolerant.
TXD	Output	Input	Serial Transmit Data — This signal transmits data from SCI transmit data register.
PE1	Input or Output		Port E1—The default configuration following reset is GPIO input PE1. When configured as PE1, signal direction is controlled through the SCI PRR. The signal can be configured as an SCI signal TXD through the SCI PCR.
SCLK	Input/Output	Input	This input is 5 V tolerant. Serial Clock —This is the bidirectional Schmitt-
	mput Sutput		trigger input signal providing the input or output clock used by the transmitter and/or the receiver.
PE2	Input or Output		Port E 2—The default configuration following reset is GPIO input PE2. When configured as PE2, signal direction is controlled through the SCI PRR. The signal can be configured as an SCI signal SCLK through the SCI PCR. This input is 5 V tolerant.

TIMERS

Three identical and independent timers are implemented in the DSP56301. Each timer can use internal or external clocking, and can interrupt the DSP56301 after a specified number of events (clocks), or can signal an external device after counting a specific number of internal events.

Table 1-15 Triple Timer Signals

	1	I	
Signal Name	Туре	State During Reset	Signal Description
TIO0	Input or Output	Input	Timer 0 Schmitt-Trigger Input/Output —When Timer 0 functions as an external event counter or in measurement mode, TIO0 is used as input. When Timer 0 functions in watchdog, timer, or pulse modulation mode, TIO0 is used as output. The default mode after reset is GPIO input. This can be changed to output or configured as a Timer Input/Output through the Timer 0 Control/Status Register (TCSR0). This input is 5 V tolerant.
TIO1	Input or Output	Input	Timer 1 Schmitt-Trigger Input/Output —When Timer 1 functions as an external event counter or in measurement mode, TIO1 is used as input. When Timer 1 functions in watchdog, timer, or pulse modulation mode, TIO1 is used as output. The default mode after reset is GPIO input. This can be changed to output or configured as a Timer Input/Output through the Timer 1 Control/Status Register (TCSR1). This input is 5 V tolerant.
TIO2	Input or Output	Input	Timer 2 Schmitt-Trigger Input/Output —When Timer 2 functions as an external event counter or in measurement mode, TIO2 is used as input. When Timer 2 functions in watchdog, timer, or pulse modulation mode, TIO2 is used as output. The default mode after reset is GPIO input. This can be changed to output or configured as a Timer Input/Output through the Timer 2 Control/Status Register (TCSR2). This input is 5 V tolerant.

JTAG/ONCE INTERFACE

Table 1-16 JTAG/OnCE Interface

Signal Name	Туре	State During Reset	Signal Description
TCK	Input	Input	Test Clock —TCK is a test clock input si gnal used to synchronize the JTAG test logic. This input is 5 V tolerant.
TDI	Input	Input	Test Data Input —TDI is a test data serial input signal used for test instructions and data. TDI is sampled on the rising edge of TCK and has an internal pull-up resistor. This input is 5 V tolerant.
TDO	Output	Tri-stated	Test Data Output —TDO is a test data serial output signal used for test instructions and data. TDO is tristatable and is actively driven in the shift-IR and shift-DR controller states. TDO changes on the falling edge of TCK.
TMS	Input	Input	Test Mode Select —TMS is an input signal used to sequence the test controller's state machine. TMS is sampled on the rising edge of TCK and has an internal pull-up resistor. This input is 5 V tolerant.
TRST	Input	Input	Test Reset — TRST is an active-low Schmitt-trigger input signal used to asynchronously initialize the test controller. TRST has an internal pull-up resistor. TRST must be asserted after power up. This input is 5 V tolerant.

Table 1-16 JTAG/OnCE Interface (Continued)

Signal Name	Туре	State During Reset	Signal Description
DE	Input/Output	Input	Debug Event — DE is an open-drain bidirectional active-low signal providing, as an input, a means of entering the Debug mode of operation from an external command controller, and, as an output, a means of acknowledging that the chip has entered the Debug mode. This signal, when asserted as an input, causes the DSP56300 core to finish the current instruction being executed, save the instruction pipeline information, enter the Debug mode, and wait for commands to be entered from the debug serial input line. This signal is asserted as an output for three clock cycles when the chip enters the Debug mode as a result of a debug request or as a result of meeting a breakpoint condition. The DE has an internal pull-up resistor. This is not a standard part of the JTAG Test Access Port (TAP) Controller. The signal connects directly to the OnCE module to initiate Debug mode directly or to provide a direct external indication that the chip has entered the Debug mode. All other interface with the OnCE module must occur through the JTAG port. This input is 5 V tolerant.





SECTION 2 **SPECIFICATIONS**

INTRODUCTION

The DSP56301 is fabricated in high density CMOS with Transistor-Transistor Logic (TTL) compatible inputs and outputs. The DSP56301 specifications are preliminary and are from design simulations, and may not be fully tested or guaranteed at this early stage of the product life cycle. Finalized specifications will be published after full characterization and device qualifications are complete.

MAXIMUM RATINGS

CAUTION

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, normal precautions should be taken to avoid exceeding maximum voltage ratings. Reliability is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either GND or V_{CC}).

Note: In the calculation of timing requirements, adding a maximum value of one specification to a minimum value of another specification does not yield a reasonable sum. A maximum specification is calculated using a worst case variation of process parameter values in one direction. The minimum specification is calculated using the worst case for the same parameters in the opposite direction. Therefore, a "maximum" value for a specification will never occur in the same device that has a "minimum" value for another specification; adding a maximum to a minimum represents a condition that can never exist.

Table 2-1 Maximum Ratings

Rating ¹	Symbol	Value ^{1, 2}	Unit
Supply Voltage	V_{CC}	-0.3 to +4.0	V
All input voltages excluding "5 V tolerant" inputs ³	V _{IN}	$GND - 0.3$ to $V_{CC} + 0.3$	V
All "5 V tolerant" input voltages ³	$V_{\rm IN5}$	GND -0.3 to $V_{CC} + 3.95$	V
Current drain per pin excluding V _{CC} and GND	I	10	mA
Operating temperature range	T_{J}	-40 to +100	°C
Storage temperature	T _{STG}	-55 to +150	°C

Notes:

- 1. GND = 0 V, V_{CC} = 3.3 V ± 0.3 V, T_{J} = -40°C to +100°C, CL = 50 pF + 2 TTL Loads
- 2. Absolute maximum ratings are stress ratings only, and functional operation at the maximum is not guaranteed. Stress beyond the maximum rating may affect device reliability or cause permanent damage to the device.
- 3. **CAUTION**: All "5 V Tolerant" input voltages cannot be more than 3.95 V greater than the supply voltage; this restriction applies to "power on", as well as during normal operation. In any case, the input voltages can not be more than 5.75 V. "5 V Tolerant" inputs are inputs that tolerate 5 V.

THERMAL CHARACTERISTICS

Table 2-2 Thermal Characteristics

Characteristic	Symbol	TQFP Value	PBGA ³ Value	PBGA ⁴ Value	Unit
Junction-to-ambient thermal resistance ¹	$R_{\theta JA}$ or θ_{JA}	49.5	48.4	25.2	°C/W
Junction-to-case thermal resistance ²	$R_{\theta JC}$ or θ_{JC}	7.2	9	_	°C/W
Thermal characterization parameter	$\Psi_{ m JT}$	4.7	5	_	°C/W

Notes: 1. Junction-to-ambient thermal resistance is based on measurements on a horizontal single-sided printed circuit board per SEMI G38-87 in natural convection. (SEMI is Semiconductor Equipment and Materials International, 805 East Middlefield Rd., Mountain View, CA 94043, (415) 964-5111)

- 2. Junction-to-case thermal resistance is based on measurements using a cold plate per SEMI G30-88, with the exception that the cold plate temperature is used for the case temperature.
- 3. These are simulated values. Test board has 2-ounce copper traces routed to the outer row of balls.
- 4. These are simulated values. The test board has two, 2-ounce signal layers and two 1-ounce solid ground planes internal to the test board.

DC ELECTRICAL CHARACTERISTICS

 $\textbf{Table 2-3} \quad \text{DC Electrical Characteristics}^6$

Characteristics	Symbol	Min	Тур	Max	Unit
Supply voltage	V _{CC}	3.0	3.3	3.6	V
Input high voltage • D(0:23), \overline{BG}, \overline{BB}, \overline{TA}, \overline{BL} • MOD\overline{IRQ}\overline{1}, \overline{RESET}, PINIT/\overline{NMI} and all JTAG/ESSI/SCI/Timer/HI08 pins	V _{IH} V _{IHP}	2.0 2.0	=	V _{CC} V _{CC} + 3.95	V V
• EXTAL ⁸	V_{IHX}	$0.8 \times V_{CC}$	_	V _{CC}	V
Input low voltage • $\underline{D(0:23)}$, \overline{BG} , \overline{BB} , \overline{TA} , \overline{BL} , MOD^1/\overline{IRQ}^1 , \overline{RESET} , PINIT	V_{IL}	- 0.3		0.8	V
All JTAG/ESSI/SCI/Timer/HI08 pins	V_{ILP}	- 0.3	\ 	0.8	V
• EXTAL ⁸	V_{ILX}	- 0.3	_	$0.2 \times V_{CC}$	V
Input leakage current	I _{IN}	- 10	_	10	μΑ
High impedance (off-state) input current (@ 2.4 V / 0.4 V)	I _{TSI}	-10	_	10	μА
Output high voltage • TTL $(I_{OH} = -0.4 \text{ mA})^{5,7}$ • CMOS $(I_{OH} = -10 \mu\text{A})^5$	V _{OH}	V _{CC} - 0.4 V _{CC} - 0.01			V V
Output low voltage • TTL ($I_{OL} = 3.0 \text{ mA}$, open-drain pins $I_{OL} = 6.7 \text{ mA}$) ^{5,7}	\hat{V}_{OL}	_	_	0.4	V
• CMOS ($I_{OL} = 10 \mu\text{A}$) ⁵		_	_	0.01	V
Internal supply current ² : • In Normal mode	I _{CCI}	_	66 MHz: 84 80 MHz: 102	66 MHz: 120 80 MHz: 145	mA mA
• In Wait mode ³	I_{CCW}	_	100 MHz: 127 66 MHz: 5 80 MHz: 6	100 MHz: 181 66 MHz: 7 80 MHz: 9	mA mA mA
• In Stop mode ⁴	I_{CCS}	_	100 MHz: 7.5 66 MHz: 100 80 MHz: 100 100 MHz: 100	100 MHz: 11 66 MHz: 150 80 MHz: 150 100 MHz: 150	mA μA μA μA

AC Electrical Characteristics

Table 2-3 DC Electrical Characteristics⁶ (Continued)

Characteristics	Symbol	Min	Тур	Max	Unit
PLL supply current		_	1	2.5	mA
Input capacitance ⁵	C _{IN}	_	_	10	pF

Notes:

- 1. Refers to MODA/ \overline{IRQA} , MODB/ \overline{IRQB} , MODC/ \overline{IRQC} , and MODD/ \overline{IRQD} pins
- 2. **Power Consumption Considerations** on page 4-4 provides a formula to compute the estimated current requirements in Normal mode. In order to obtain these results, all inputs must be terminated (i.e., not allowed to float). Measurements are based on synthetic intensive DSP benchmarks (see **Appendix A**). The power consumption numbers in this specification are 90% of the measured results of this benchmark. This reflects typical DSP applications. Typical internal supply current is measured with $V_{CC} = 3.0 \text{ V}$ at $T_J = 100^{\circ}\text{C}$. Maximum internal supply current is measured with $V_{CC} = 3.6 \text{ V}$ at $T_J = 100^{\circ}\text{C}$.
- In order to obtain these results, all inputs must be terminated (i.e., not allowed to float). PLL and XTAL signals are disabled during Stop state.
- 4. In order to obtain these results, all inputs, which are not disconnected at Stop mode, must be terminated (i.e., not allowed to float).
- 5. Periodically sampled and not 100% tested
- 6. $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$; $T_{J} = -40 ^{\circ}\text{C}$ to $+100 ^{\circ}\text{C}$, $C_{L} = 50 \text{ pF} + 2 \text{ TTL Loads}$
- This characteristic does not apply to XTAL and PCAP.
- 8. Driving EXTAL to the low V_{IHX} or the high V_{ILX} value may cause additional power consumption (DC current). To minimize power consumption, the minimum V_{IHX} should be no lower than $0.9 \times V_{CC}$ and the maximum V_{ILX} should be no higher than $0.1 \times V_{CC}$.

AC ELECTRICAL CHARACTERISTICS

The timing waveforms shown in the AC electrical characteristics section are tested with a V_{IL} maximum of 0.3 V and a V_{IH} minimum of 2.4 V for all pins except EXTAL, which is tested using the input levels shown in **Note 6** of the previous table. AC timing specifications, which are referenced to a device input signal, are measured in production with respect to the 50% point of the respective input signal's transition. DSP56301 output levels are measured with the production test machine V_{OL} and V_{OH} reference levels set at 0.8 V and 2.0 V, respectively.



INTERNAL CLOCKS

Table 2-4 Internal Clocks, CLKOUT

Characteristics	Symb		Expression ^{1, 2}	
Characteristics	ol	Min	Тур	Max
Internal operation frequency and CLKOUT with PLL enabled	f	_	(Ef×MF)/ (PDF×DF)	_
Internal operation frequency and CLKOUT with PLL disabled	f	_	Ef/2	\
 Internal clock and CLKOUT high period With PLL disabled With PLL enabled and MF ≤ 4 With PLL enabled and MF > 4 	T _H	$\begin{matrix} - \\ 0.49 \times \mathrm{ET_C} \times \\ \mathrm{PDF} \times \mathrm{DF} / \mathrm{MF} \\ 0.47 \times \mathrm{ET_C} \times \\ \mathrm{PDF} \times \mathrm{DF} / \mathrm{MF} \end{matrix}$	ET _C —	$\begin{array}{c} -\\ 0.51\times \mathrm{ET_C}\times\\ \mathrm{PDF}\times \mathrm{DF}/\mathrm{MF}\\ 0.53\times \mathrm{ET_C}\times\\ \mathrm{PDF}\times \mathrm{DF}/\mathrm{MF} \end{array}$
 Internal clock and CLKOUT low period With PLL disabled With PLL enabled and MF ≤ 4 With PLL enabled and MF > 4 	TL	$\begin{array}{c} -\\ 0.49 \times \text{ET}_{\text{C}} \times\\ \text{PDF} \times \text{DF}/\text{MF}\\ 0.47 \times \text{ET}_{\text{C}} \times\\ \text{PDF} \times \text{DF}/\text{MF} \end{array}$	ET _C — —	$\begin{array}{c} -\\ 0.51\times \mathrm{ET_{C}}\times\\ \mathrm{PDF}\times \mathrm{DF}/\mathrm{MF}\\ 0.53\times \mathrm{ET_{C}}\times\\ \mathrm{PDF}\times \mathrm{DF}/\mathrm{MF} \end{array}$
Internal clock and CLKOUT cycle time with PLL enabled	T _C	_	$ET_{C} \times PDF \times \\DF/MF$	_
Internal clock and CLKOUT cycle time with PLL disabled	T_{C}	_	$2 \times \mathrm{ET}_\mathrm{C}$	_
Instruction cycle time	I_{CYC}	_	T _C	_

Notes: 1. DF = Division Factor

Ef = External frequency

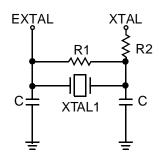
ET_C = External clock cycle MF = Multiplication Factor

PDF = Predivision Factor

 T_C = internal clock cycle See the **PLL and Clock Generation** section in the *DSP56300 Family Manual* for a detailed discussion of the PLL.

EXTERNAL CLOCK OPERATION

The DSP56301 system clock may be derived from the on–chip crystal oscillator, as shown in **Figure 1** on the cover page, or it may be externally supplied. An externally supplied square wave voltage source should be connected to EXTAL, leaving XTAL physically not connected to the board or socket.



Fundamental Frequency Fork Crystal Oscillator

Suggested Component Values:

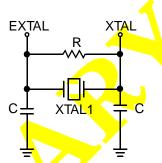
$$\begin{split} f_{OSC} &= 32.768 \text{ kHz} \\ \text{R1} &= 3.9 \text{ M}\Omega \pm 10\% \\ \text{C} &= 22 \text{ pF} \pm 20\% \\ \text{R2} &= 200 \text{ k}\Omega \pm 10\% \end{split}$$

Calculations were done for a 32.768 kHz crystal with the following parameters:

a load capacitance (C_L) of 12.5 pF,

a shunt capacitance (C_0) of 1.8 pF, a series resistance of 40 k Ω , and

a drive level of 1 µW.



Fundamental Frequency
Crystal Oscillator

Suggested Component Values:

 $f_{OSC} = 4 \text{ MHz}$ $f_{OSC} = 20 \text{ MHz}$ $R = 680 \text{ k}\Omega \pm 10\%$ $R = 680 \text{ k}\Omega \pm 10\%$ $C = 56 \text{ pF} \pm 20\%$ $C = 22 \text{ pF} \pm 20\%$

Calculations were done for a 4/20 MHz crystal with the following parameters:

- a C_I of 30/20 pF,
- a C_0^- of 7/6 pF,
- a series resistance of 100/20 $\Omega,\,\text{and}$
- a drive level of 2 mW.

AA1071

Figure 2-1 Crystal Oscillator Circuits

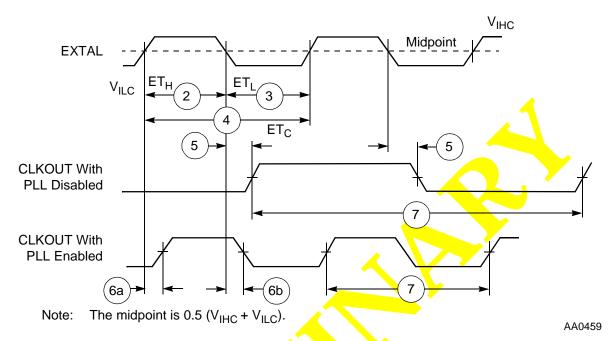


Figure 2-2 External Clock Timing

Table 2-5 Clock Operation

No	Characteristics	Combal	66 N	ИHz	80 N	ИHz	100 MHz	
No.	Characteristics	Symbol	Min	Max	Min	Max	Min	Max
1	Frequency of EXTAL (EXTAL Pin Frequency) The rise and fall time of this external clock should be 3 ns maximum.	Ef	0	66.0	0	80.0	0	100.0
2	EXTAL input high ¹ , ² • With PLL disabled (46.7%–53.3% duty cycle ⁶) • With PLL enabled (42.5%–57.5% duty cycle ⁶)	ET _H	7.08 ns 6.44 ns	∞ 157.0 μs	5.84 ns 5.31 ns	∞ 157.0 μs	4.67 ns 4.25 ns	∞ 157.0 μs
3	 EXTAL input low^{1, 2} With PLL disabled (46.7%-53.3% duty cycle⁶) With PLL enabled (42.5%-57.5% duty cycle⁶) 	ET _L	7.08 ns 6.44 ns	∞ 157.0 μs	5.84 ns 5.31 ns	∞ 157.0 μs	4.67 ns 4.25 ns	∞ 157.0 μs

 Table 2-5
 Clock Operation (Continued)

NT.		G 1.1	66 N	ИHz	80 N	ИHz	100 N	МНz
No.	Characteristics	Symbol	Min	Max	Min	Max	Min	Max
4	 EXTAL cycle time² With PLL disabled With PLL enabled 	ET _C	15.15 ns 15.15 ns	∞ 273.1 μs	12.50 ns 12.50 ns	∞ 273.1 μs	10.00 ns 10.0 <mark>0</mark> ns	∞ 273.1 μs
5	CLKOUT change from EXTAL fall with PLL disabled		4.3 ns	11.0 ns	4.3 ns	11.0 ns	4.3 ns	11.0 ns
6	CLKOUT rising edge from EXTAL rising edge with PLL enabled (MF = 1, PDF = 1, Ef > 15 MHz) ^{3,5}		0.0 ns	1.8 ns	0.0 ns	1.8 ns	0.0 ns	1.8 ns
	CLKOUT falling edge from EXTAL rising edge with PLL enabled (MF = 2 or 4, PDF = 1, Ef > 15 MHz) 3,5		0.0 ns	1.8 ns	0.0 ns	1.8 ns	0.0 ns	1.8 ns
	CLKOUT falling edge from EXTAL falling edge with PLL enabled (MF \leq 4, PDF \neq 1, Ef / PDF > 15 MHz) ^{3,5}		0.0 ns	1.8 ns	0 .0 ns	1.8 ns	0.0 ns	1.8 ns
7	Instruction cycle time = $I_{CYC} = T_C^4$ (See Table 2-4 .) (46.7%–53.3% duty cycle) • With PLL disabled • With PLL enabled	I _{CYC}	30.3 ns 15.15 ns	∞ 8.53 μs	25.0 ns 12.50 ns	∞ 8.53 μs	20.0 ns 10.00 ns	∞ 8.53 μs

- Notes: 1. Measured at 50% of the input transition
 - The maximum value for PLL enabled is given for minimum V_{CO} and maximum MF.
 - 3. Periodically sampled and not 100% tested
 - 4. The maximum value for PLL enabled is given for minimum V_{CO} and maximum DF.
 - 5. The skew is not guaranteed for any other MF value.
 - 6. The indicated duty cycle is for the specified maximum frequency for which a part is rated. The minimum clock high or low time required for correction operation, however, remains the same at lower operating frequencies; therefore, when a lower clock frequency is used, the signal symmetry may vary from the specified duty cycle as long as the minimum high time and low time requirements are met.

PHASE LOCK LOOP (PLL) CHARACTERISTICS

Table 2-6 PLL Characteristics

Characteristics	66 N	ИHz	80 N	ИHz	100]	Unit	
Characteristics	Min	Max	Min	Max	Min	Max	
$\begin{array}{c} V_{CO} \ \text{frequency} \\ \text{when PLL} \\ \text{enabled} \\ \text{(MF} \times E_f \times 2/\\ \text{PDF)} \end{array}$	30	132	30	160	30	200	MHz
PLL external capacitor (PCAP pin to V_{CCP}) (C_{PCAP}^{1}) • @ MF \leq 4	(MF×425) – 125	(MF×590) – 175	(MF×425) – 125	(MF×590) –	(MF×425) – 125	(MF×590) – 175	pF
• @ MF > 4	$MF \times 520$	$MF \times 920$	MF × 520	$MF \times 920$	$MF \times 520$	$MF \times 920$	pF

 C_{PCAP} is the value of the PLL capacitor (connected between the PCAP pin and V_{CCP}). The recommended value in pF for C_{PCAP} can be computed from one of the following equations: $(500 \times MF) - 150$, for $MF \le 4$, or Note:

 $690 \times MF$, for MF > 4.



RESET, STOP, MODE SELECT, ND INTERRUPT TIMING

Table 2-7 Reset, Stop, Mode Select, and Interrupt Timing 6

No	Characteristics	Europagaion	66 N	ИНz	80 N	1Hz	100 N	ИНz	Unit
No.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
8	Delay from RESET assertion to all pins at reset value ³	_		26.0	_	26.0	W.	26.0	ns
9	Required RESET duration ⁴ • Power on, external clock generator,	$50 imes \mathrm{ET_C}$	760.0	_	625.0		500.0		ns
	 PLL disabled Power on, external clock generator, PLL enabled 	$1000 \times \mathrm{ET}_\mathrm{C}$	15.2	4	12.5	-	10.0	_	μs
	Power on, internal oscillatorDuring STOP,	$75000 \times \text{ET}_{\text{C}}$ $75000 \times \text{ET}_{\text{C}}$	1.14 1.14		1.0	_	0.75 0.75	_	ms ms
	XTAL disabled (PCTL Bit 16 = 0) During STOP, XTAL enabled	$73000 \times E1_{C}$ $2.5 \times T_{C}$	38.0	_	31.3	_	25.0	_	ns
	(PCTL Bit 16 = 1) • During normal operation	2.5×T _C	38.0	_	31.3	_	25.0	_	ns
10	Delay from asynchronous RESET deassertion to first external address output (internal reset deassertion) ⁵ • Minimum	66 MHz:							
		$3.25 \times T_{C} + 2.0$ 80 MHz :	51.0	_	_	_	_	-	ns
•		$3.25 \times T_{C} + 2.0$ 100 MHz :	_	_	42.6	_	_	_	ns
	Maximum	$3.25 \times T_{C} + 2.0$ 66 MHz :	_	_	_	_	34.5	_	ns
		20.25 T _C + 11.0 80 MHz :	_	318.0	_	_	_	_	ns
		$20.25 T_C + 9.95$ 100 MHz:	_	_	_	263.1	_	_	ns
		20.25 T _C + 7.50	_	_	_	_	_	211.5	ns

 Table 2-7
 Reset, Stop, Mode Select, and Interrupt Timing⁶ (Continued)

N.T.		ъ.	66 N	ИНz	80 N	ИHz	100 N	MHz	T I •
No.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
11	Synchronous reset setup time from RESET deassertion to CLKOUT Transition 1	${ m T_C}$	9.0	 15.2	7.4	— 12.5	5.9 —	10.0	ns ns
12	Synchronous reset deasserted, delay time from the CLKOUT Transition 1 to the first external address output • Minimum • Maximum	$3.25 \times T_{C} + 1.0$ $20.25 T_{C} + 5.0$	50.0	312.0	41.6	258.1	33.5		ns ns
13	Mode select setup time		30.0	_	30.0	_	30.0		ns
14	Mode select hold time		0.0	_	0.0	_	0.0	_	ns
15	Minimum edge- triggered interrupt request assertion width		10.0		8.25	_	6.6		ns
16	Minimum edge- triggered interrupt request deassertion width		10.0	_	8.25	_	6.6	_	ns
17	Delay from IRQA, IRQB, IRQC, IRQD, NMI assertion to external memory access address out valid Caused by first interrupt instruction fetch Caused by first	$4.25 \times T_{C} + 2.0$ $7.25 \times T_{C} + 2.0$	66.0 112.0	_	55.1 92.6	_	44.5 74.5	_	ns ns
	interrupt instruction execution								
18	Delay from IRQA, IRQB, IRQC, IRQD, NMI assertion to general-purpose transfer output valid caused by first interruptruction	$10 \times T_{\rm C} + 5.0$	157.0	_	130.0	_	105.0	_	ns

 Table 2-7
 Reset, Stop, Mode Select, and Interrupt Timing⁶ (Continued)

No.	Characteristics	Expression -	66 N	66 MHz		80 MHz		100 MHz	
100.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
19	Delay from address output valid caused by first interrupt	66 MHz ⁸ : $3.75 \times T_C + WS \times T_C - 14$	_				4		ns
	instruction execute to interrupt request deassertion for level	80 MHz ⁸ : $3.75 \times T_C + WS \times T_C -$ 12.4			_				ns
	sensitive fast interrupts ¹	$ \begin{array}{c} \textbf{100 MHz}^{8} \\ 3.75 \times T_{C} + WS \times T_{C} - \\ 10.94 \end{array} $			•	Q			ns
20	Delay from RD assertion to interrupt request deassertion for	66 MHz ⁸ : $3.25 \times T_C + WS \times T_C - 14$	_						ns
	level sensitive fast interrupts ¹	80 MHz ⁸ : $3.25 \times T_C + WS \times T_C -$ 12.4			<u></u>				ns
		$ \begin{vmatrix} \textbf{100 MHz}^8: \\ 3.25 \times T_C + WS \times T_C - \\ 10.94 \end{vmatrix} $					_		ns

No.	Characteristics	Expression	66 N	ИНz	80 N	ИHz	100 N	MHz	Unit
NO.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
21	Delay from WR assertion to interrupt request deassertion for level sensitive fast interrupts ¹								
	DRAM for all WS	66 MHz ⁸ : $(WS + 3.5) \times T_C - 14$ 80 MHz ⁸ : $(WS + 3.5) \times T_C - 12.4$ 100 MHz ⁸ :	_		_			>	ns ns
	• SRAM WS = 1	$\begin{aligned} &(WS+3.5)\times T_C-10.94\\ &\textbf{66 MHz}^{\textbf{8}}:\\ &(WS+3.5)\times T_C-14\\ &\textbf{80 MHz}^{\textbf{8}}:\\ &(WS+3.5)\times T_C-12.4 \end{aligned}$	_	1			_		ns ns
	• SRAM WS = 2, 3	100 MHz ⁸ : $(WS + 3.5) \times T_C - 10.94$ 66 MHz ⁸ : $(WS + 3) \times T_C - 14$ 80 MHz ⁸ :					_		ns ns
	• SRAM WS ≥ 4	(WS + 3) \times T _C = 12.4 100 MHz ⁸ : (WS + 3) \times T _C = 10.94 66 MHz ⁸ :			_		_		ns ns
		$(WS + 2.5) \times T_C - 14$ 80 MHz ⁸ : $(WS + 2.5) \times T_C - 12.4$ 100 MHz ⁸ : $(WS + 2.5) \times T_C - 10.94$	_		_		_		ns ns ns
22	Synchronous interrupt setup time from IRQA, IRQB, IRQC, IRQD, NMI assertion to the CLKOUT Transition 2		9.0	T _C	7.4	T _C	5.9	T _C	ns

 Table 2-7
 Reset, Stop, Mode Select, and Interrupt Timing⁶ (Continued)

 Table 2-7
 Reset, Stop, Mode Select, and Interrupt Timing⁶ (Continued)

Nie	Chamatawistics	Evenuession	66 N	ИНz	80 N	ИHz	100 I	МНz	T Inc. 24
No.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
23	Synchronous interrupt delay time from the CLKOUT Transition 2 to the first external address output valid caused by the first instruction fetch after coming out of Wait Processing state							>	
	MinimumMaximum	$9.25 \times T_{C} + 1.0$ $24.75 \times T_{C} + 5.0$	141.0	380.0	116.6	314.4	93.5		ns ns
24	Duration for IRQA assertion to recover from Stop state	Ç	9.0	1	7.4	7	5.9		ns
25	Delay from IRQA assertion to fetch of first instruction (when exiting Stop) ^{2, 3} • PLL is not active during Stop (PCTL Bit 17 = 0) and Stop delay is enabled (OMR Bit 6 = 0) • PLL is not active during Stop (PCTL Bit 17 = 0) and Stop delay is not enabled (OMR Bit 6 = 1) • PLL is active during Stop (PCTL Bit 17 = 1) (Implies No Stop Delay)	PLC × ET _C × PDF + (128 K – PLC/2) × T _C PLC × ET _C × PDF + (23.75 \pm 0.5) × T _C	2.0 352.3 ns	64.1 62.1 ms	1.6 290.6 ns	17.0 15.4 ms	1.3 232.5 ns	13.6 12.3 ms	ns

 Table 2-7
 Reset, Stop, Mode Select, and Interrupt Timing⁶ (Continued)

No.	Characteristics	Europagion	66 N	ИНz	80 N	ИHz	100 N	MHz	Unit
NO.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
26	Duration of level sensitive IRQA assertion to ensure interrupt service (when exiting Stop) ^{2, 3} • PLL is not active during Stop (PCTL Bit 17 = 0) and Stop	$PLC \times ET_C \times PDF + (128K - PLC/2) \times T_C$	64.1	_	17.0		13.6	>	ms
	delay is enabled (OMR Bit 6 = 0) • PLL is not active during Stop (PCTL Bit 17 = 0) and Stop delay is not enabled (OMR Bit 6 = 1)	PLC × ET _C × PDF + $(20.5 \pm 0.5) \times T_{C}$	62.1	-	15.4		12.3	_	ms
	• PLL is active during Stop (PCTL Bit 17 = 1) (implies no Stop delay)	$5.5 \times T_{\rm C}$	83.4		68.8	1	55.0	_	ns
27	Interrupt Requests Rate • HI08, ESSI, SCI, Timer	12T _C		181.8	_	150.0	_	120.0	ns
	DMA TRQ, NMI (edge trigger)	8T _C 8T _C	_	121.2 121.2	_ _	100.0 100.0	_ _	80.0 80.0	ns ns
	• IRQ, NMI (level trigger)	12T _C		181.8	_	150.0	_	120.0	ns
28	DMA Requests Rate • Data read from HI08, ESSI, SCI	$6T_{ m C}$	_	90.9	_	75.0	_	60.0	ns
	• Data write to HI08, ESSI, SCI	7T _C	_	106.1	_	87.5	_	70.0	ns
•	• Timer • IRQ, NMI (edge trigger)	$2T_{ m C} \ 3T_{ m C}$	_ _	30.3 45.5	_ _	25.0 37.5		20.0 30.0	ns ns

Reset, Stop, Mode Select, nd Interrupt Timing

Table 2-7 Reset, Stop, Mode Select, and Interrupt Timing⁶ (Continued)

No.	Characteristics	naracteristics Expression	66 N	ИНz	80 MHz		100 MHz		Unit
NO.		Expression	Min	Max	Min	Max	Min	Max	UIII
	Delay from IRQA, IRQB, IRQC, IRQD, NMI assertion to external memory (DMA source) access address out valid	$4.25 \times T_C + 2.0$	66.0	_	55.1	_	44.0	-	ns

Notes:

- 1. When using fast interrupts and \overline{IRQA} , \overline{IRQB} , \overline{IRQC} , and \overline{IRQD} are defined as level-sensitive, timings 19 through 21 apply to prevent multiple interrupt service. To avoid these timing restrictions, the deasserted Edge-triggered mode is recommended when using fast interrupts. Long interrupts are recommended when using Level-sensitive mode.
- 2. This timing depends on several settings:

For PLL disable, using internal oscillator (PLL Control Register (PCTL) Bit 16 = 0) and oscillator disabled during Stop (PCTL Bit 17 = 0), a stabilization delay is required to assure the oscillator is stable before executing programs. In that case, resetting the Stop delay (OMR Bit 6 = 0) will provide the proper delay. While it is possible to set OMR Bit 6 = 1, it is not recommended and these specifications do not guarantee timings for that case.

For PLL disable, using internal oscillator (PCTL Bit 16 = 0) and oscillator enabled during Stop (PCTL Bit 17=1), no stabilization delay is required and recovery time will be minimal (OMR Bit 6 setting is ignored).

For PLL disable, using external clock (PCTL Bit 16 = 1), no stabilization delay is required and recovery time will be defined by the PCTL Bit 17 and OMR Bit 6 settings.

For PLL enable, if PCTL Bit 17 is 0, the PLL is shutdown during Stop. Recovering from Stop requires the PLL to get locked. The PLL lock procedure duration, PLL Lock Cycles (PLC), may be in the range of 0 to 1000 cycles. This procedure occurs in parallel with the stop delay counter, and stop recovery will end when the last of these two events occurs. The stop delay counter completes count or PLL lock procedure completion.

PLC value for PLL disable is 0.

The maximum value for ET_C is 4096 (maximum MF) divided by the desired internal frequency (i.e., for 66 MHz it is 4096/66 MHz = 62 μ s). During the stabilization period, T_C, T_H, and T_L will not be constant, and their width may vary, so timing may vary as well.

3. Periodically sampled and not 100% tested

Table 2-7 Reset, Stop, Mode Select, and Interrupt Timing⁶ (Continued)

No.	Characteristics	Expression	66 N	66 MHz		80 MHz		100 MHz	
INO.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit

4. For an external clock generator, \overline{RESET} duration is measured during the time in which \overline{RESET} is asserted, V_{CC} is valid, and the EXTAL input is active and valid.

For internal oscillator, \overline{RESET} duration is measured during the time in which \overline{RESET} is asserted and V_{CC} is valid. The specified timing reflects the crystal oscillator stabilization time after power-up. This number is affected both by the specifications of the crystal and other components connected to the oscillator and reflects worst case conditions.

When the V_{CC} is valid, but the other "required \overline{RESET} duration" conditions (as specified above) have not been yet met, the device circuitry will be in an uninitialized state that can result in significant power consumption and heat-up. Designs should minimize this state to the shortest possible duration.

- 5. If PLL does not lose lock
- 6. $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$; $T_{J} = -40^{\circ}\text{C}$ to $+100^{\circ}\text{C}$, $C_{L} = 50 \text{ pF} + 2 \text{ TTL Loads}$
- WS = number of wait states (measured in clock cycles, number of T_C)
- 8. Use expression to compute maximum value.

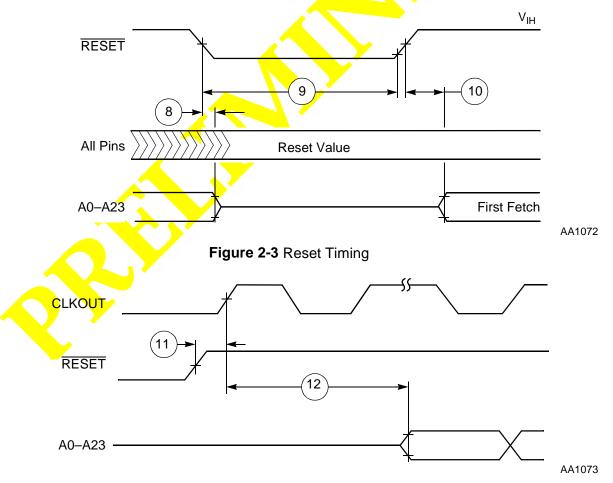


Figure 2-4 Synchronous Reset Timing

Reset, Stop, Mode Select, nd Interrupt Timing

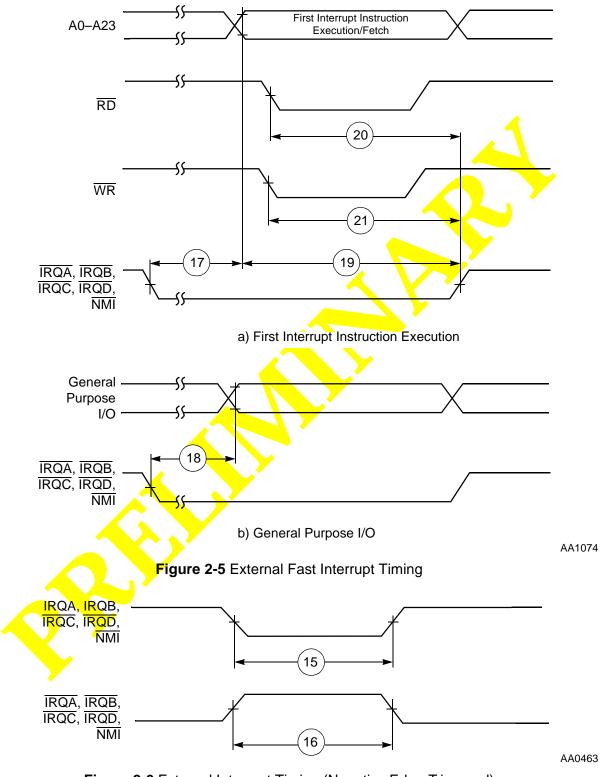


Figure 2-6 External Interrupt Timing (Negative Edge-Triggered)

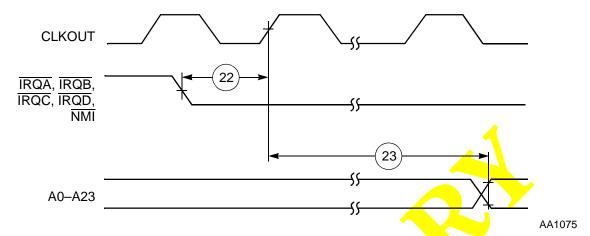


Figure 2-7 Synchronous Interrupt from Wait State Timing

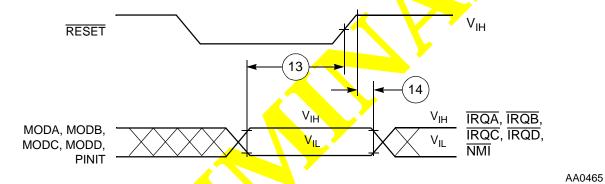
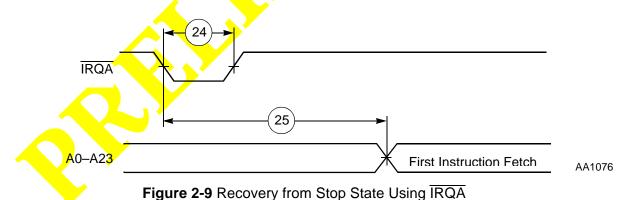


Figure 2-8 Operating Mode Select Timing



Reset, Stop, Mode Select, nd Interrupt Timing

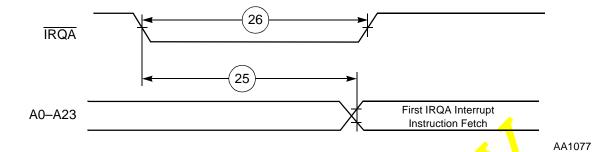


Figure 2-10 Recovery from Stop State Using IRQA Interrupt Service

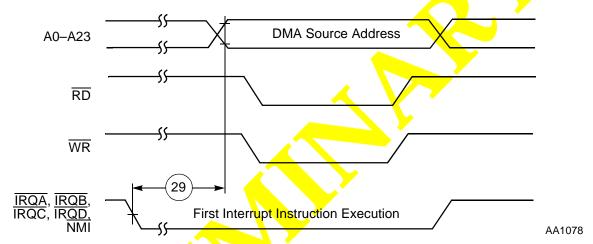


Figure 2-11 External Memory Access (DMA Source) Timing

EXTERNAL MEMORY EXPANSION PORT (PORT A)

SRAM Timing

 Table 2-8
 SRAM Read and Write Accesses

	ı	ı	T	1						
No.	Characteristics	Symbol	Expression ¹	66 N	ИHz	80 N	ИHz	100 1	MHz	Unit
110.	Characteristics	Бушьог	Expression	Min	Max	Min	Max	Min	Max	
100	Address valid and AA assertion	t _{RC} , t _{WC}	$(WS + 1) \times T_C - 4.0$ $[1 \le WS \le 3]$	26.3	_	21.0	7	16.0	_	ns
	pulse width		$(WS + 2) \times T_C - 4.0$ $[4 \le WS \le 7]$	86.9	1	71.0	-	56.0	_	ns
			$(WS + 3) \times T_C - 4.0$ $[WS \ge 8]$	162.7	-	133.5	_	106.0	_	ns
101	Address and AA valid to WR	t _{AS}	66 MHz: 0.25 × T _C – 3.7	0.1		_		_	_	ns
	assertion		[WS = 1] 80 MHz :	0.2	•					
			$0.25 \times T_{C} - 3.0$ [WS = 1]		_	0.1	_	—	_	ns
			100 MHz: $0.25 \times T_C - 2.4$ [WS = 1]	_	_	_	_	0.1	_	ns
			All frequencies: $0.75 \times T_C - 4.0$ $[2 \le WS \le 3]$	7.4	_	5.4	_	3.5	_	ns
			$1.25 \times T_{C} - 4.0$ $[WS \ge 4]$	14.9	_	11.6	_	8.5	_	ns
102	WR assertion pulse width	t _{WP}	$1.5 \times T_{C} - 4.5$ [WS = 1]	18.2		14.3		10.5	_	ns
		7	$WS \times T_C - 4.0$ $[2 \le WS \le 3]$	26.3	_	21.0	_	16.0	_	ns
•			$(WS - 0.5) \times T_C - 4.0$ $[WS \ge 4]$	49.0	_	39.8	_	31.0	_	ns

 Table 2-8
 SRAM Read and Write Accesses (Continued)

			1	66 N	ИHz	80 N	ИHz	100	MHz	
No.	Characteristics	Symbol	Expression ¹	Min	Max	Min	Max	Min	Max	Unit
103	WR deassertion to address not valid	t _{WR}	66 MHz: $0.25 \times T_C - 3.8$ $[1 \le WS \le 3]$	0.1						ns
			80 MHz: $0.25 \times T_C - 3.0$ $[1 \le WS \le 3]$ 100 MHz:	_	_	0.1	-	_	-	ns
			$0.25 \times T_C - 2.4$ $[1 \le WS \le 3]$ All frequencies:	_	_	-		0.1	_	ns
			1.25 × T_C – 4.0 [4 ≤ WS ≤ 7]	14.9	-	11.6	7	8.5	_	ns
			$[WS \ge 8]$	30.1	1	24.1		18.5		ns
104	Address and AA valid to input data valid	t_{AA}, t_{AC}	66 MHz: $(WS + 0.75) \times T_C - 11.0$ $[WS \ge 1]$ 80 MHz:		15.5			_		ns
			WHZ: $(WS + 0.75) \times T_C - 9.5$ $[WS \ge 1]$ 100 MHz: $(WS + 0.75) \times T_C - 8.0$	_	_	_	12.4	_	9.5	ns ns
			[WS ≥ 1]							
105	RD assertion to input data valid	t _{OE}	66 MHz: (WS + 0.25) × T_C – 11.0 [WS \geq 1] 80 MHz:	_	7.9	_	_	_	_	ns
			(WS + 0.25) \times T _C - 9.5 [WS \geq 1] 100 MHz :	_	_	_	6.1	_	_	ns
			$(WS + 0.25) \times T_C - 8.0$ $[WS \ge 1]$	_	_	_	_	_	4.5	ns
106	RD deassertion to data not valid (data hold time)	t _{OHZ}		0.0	_	0.0	_	0.0	_	ns
107	Address valid to WR deassertion	t _{AW}	$\begin{aligned} &(WS+0.75)\times T_C-4.0\\ &[WS\geq 1] \end{aligned}$	22.5	_	17.9	_	13.5	_	ns

 Table 2-8
 SRAM Read and Write Accesses (Continued)

No	Chamatawistics	Comb al	1	66 N	ИHz	80 N	ИHz	100 l	МНz	T I *4
No.	Characteristics	Symbol	Expression ¹	Min	Max	Min	Max	Min	Max	Unit
108	Data valid to WR deassertion (data setup time)	$t_{\rm DS}(t_{\rm DW})$	66 MHz: $(WS - 0.25) \times T_C - 3.9$ $[WS \ge 1]$ 80 MHz:	7.5	_	_	_		_	ns
			(WS $-$ 0.25) \times T _C $-$ 3.3 [WS \geq 1] 100 MHz :	_	_	6.1	1	_	_	ns
			$(WS - 0.25) \times T_C - 2.75$ $[WS \ge 1]$	_	_	-	150	4.8	_	ns
109	Data hold time from WR deassertion	t _{DH}	66 MHz: $0.25 \times T_C - 3.7$ $[1 \le WS \le 3]$	0.1	-	7		_	_	ns
			80 MHz:	_		0.1	—	_	_	ns
			$0.25 \times T_C - 2.4$ $[1 \le WS \le 3]$ All frequencies:		<u> </u>	_	_	0.1	_	ns
			$ \begin{array}{c} 1.25 \times T_{C} - 3.8 \\ [4 \le WS \le 7] \\ 2.25 \times T_{C} - 3.8 \end{array} $	15.2 30.4	_	11.8 24.3	_	8.7 18.7	_	ns ns
			[WS ≥ 8]	30.4		24.5		10.7		113
110	WR assertion to data active		$0.75 \times T_C - 3.7$ [WS = 1]	7.7	_	5.7	_	3.8	_	ns
			$0.25 \times T_{C} - 3.7$ [2 \leq WS \leq 3]	0.1	_	-0.6	_	-1.2	_	ns
			$-0.25 \times T_{C} - 3.7$ $[WS \ge 4]$	-7.5	_	-6.8	l	-6.2	l	ns
111	WR deassertion to data high	7	$0.25 \times T_{C} + 0.2$ [1 \le WS \le 3]	_	4.0	_	3.3	_	2.7	ns
4	impedance		$1.25 \times T_{C} + 0.2$ $[4 \le WS \le 7]$	_	19.1	_	15.8	_	12.7	ns
			$2.25 \times T_C + 0.2$ $[WS \ge 8]$	_	34.3	_	28.3	_	22.7	ns
112	Previous RD deassertion to		$1.25 \times T_{C} - 4.0$ [1 \le WS \le 3]	14.9	_	11.6	_	8.5	_	ns
	data active (write)		$2.25 \times T_{C} - 4.0$ $[4 \le WS \le 7]$	30.1	_	24.1	_	18.5	_	ns
	· · · · · · · · · · · · · · · · · · ·		$3.25 \times T_C - 4.0$ $[WS \ge 8]$	45.2	_	36.6	_	28.5	_	ns

External Memory Expansion Port (Port A)

 Table 2-8
 SRAM Read and Write Accesses (Continued)

No.	Classistics	C	1	66 N	ИHz	80 N	ИHz	100 I	MHz	Unit
NO.	Characteristics	Symbol	Expression ¹	Min	Max	Min	Max	Min	Max	Unit
113	RD deassertion		$0.75 \times T_C - 4.0$	7.4	_	5.4	_	3.5	_	ns
	time		[$1 \le WS \le 3$] $1.75 \times T_C - 4.0$ [$4 \le WS \le 7$]	22.5	_	17.9	_	13.5	_	ns
				37.7	_	30.4		23.5	_	ns
114	WR deassertion time		$0.5 \times T_{C} - 3.5$ [WS = 1]	4.1	_	2.8		1.5	_	ns
			$T_C - 3.5$	11.7	_	9.0	_	6.5	_	ns
			$ [2 \le WS \le 3] $ $2.5 \times T_C - 3.5 $ $[4 \le WS \le 7] $	34.4	-/	27.8		21.5	_	ns
			$ \begin{vmatrix} 14 \le WS \le 7 \\ 3.5 \times T_C - 3.5 \\ [WS \ge 8] \end{vmatrix} $	49.5	_	40.3	_	31.5	_	ns
115	Address valid to RD assertion		$0.5 \times T_C - 4$	3.5	_	2.3	_	1.0	_	ns
116	RD assertion pulse width		$(WS + 0.25) \times T_C - 3.8$	15.1	_	11.8	_	8.7	_	ns
117	RD deassertion to address not valid		$ \begin{array}{c c} 0.25 \times T_{C} - 3.0 \\ 1 \leq WS \leq 3 \end{array} $	0.7	_	0.1	_	0.0		ns
	The second secon		$1.25 \times T_{C} - 3.0$ $[4 \le WS \le 7]$	15.9	_	12.6	_	9.5	_	ns
		A	$ \begin{array}{c} 1 - 3 \times 3 = 1 \\ 2.25 \times T_{C} - 3.0 \\ [WS \ge 8] \end{array} $	31.0	_	25.1	_	19.5	_	ns

Notes: 1. WS is the number of wait states specified in the BCR. 2. $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$; $T_J = -40 ^{\circ}\text{C}$ to +100 °C, $C_L = 50 \text{ pF} + 2 \text{ TTL Loads}$



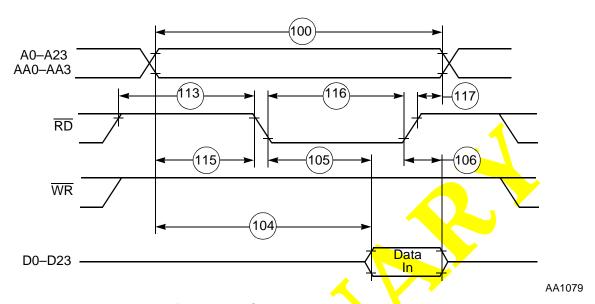


Figure 2-12 SRAM Read Access

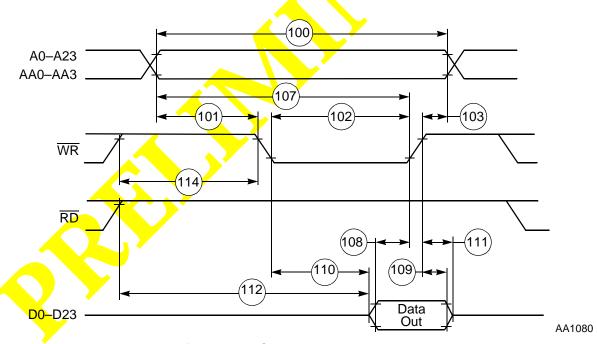


Figure 2-13 SRAM Write Access

DRAM Timing

The selection guides provided in **Figure 2-14** and **Figure 2-17** on page 2-37 should be used for primary selection only. Final selection should be based on the timing provided in the following tables. As an example, the selection guide suggests that 4 wait states must be used for 100 MHz operation when using Page Mode DRAM. However, by using the information in the appropriate table, a designer may choose to evaluate whether fewer wait states might be used by determining which timing prevents operation at 100 MHz, running the chip at a slightly lower frequency (e.g., 95 MHz), using faster DRAM (if it becomes available), and control factors such as capacitive and resistive load to improve overall system performance.

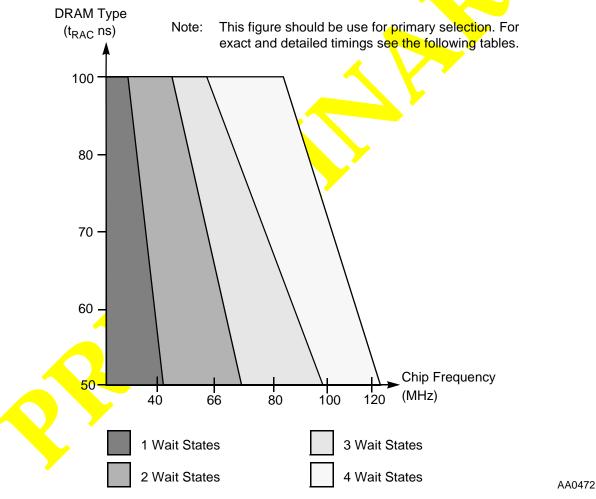


Figure 2-14 DRAM Page Mode Wait States Selection Guide

 $\textbf{Table 2-9} \quad \text{DRAM Page Mode Timings, One Wait State (Low-Power Applications)}^{1,\;2,\;3}$

No	Characteristics	Cymbol	Eunnession	20 MHz ⁶		30 M	IHz ⁶	Unit
No.	Characteristics	Symbol	Expression	Min	Max	Min	Max	Unit
131	Page mode cycle time	t _{PC}	$1.25 \times T_{\rm C}$	62.5	_	41.7	_	ns
132	CAS assertion to data valid (read)	t _{CAC}	$T_{\rm C} - 7.5$	_	42.5		25.8	ns
133	Column address valid to data valid (read)	t _{AA}	$1.5 \times T_{\rm C} - 7.5$	_	67.5		42.5	ns
134	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0		0.0	_	ns
135	Last $\overline{\text{CAS}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{RSH}	$0.75 \times T_C - 4.0$	33.5	-	21.0	_	ns
136	$\frac{\text{Previous }\overline{\text{CAS}} \text{ deassertion to}}{\overline{\text{RAS}} \text{ deassertion}}$	t _{RHCP}	$2 \times T_{\rm C} - 4.0$	96.0		62.7	_	ns
137	CAS assertion pulse width	t _{CAS}	$0.75 \times T_{\rm C} - 4.0$	33.5	_	21.0	_	ns
138	$\begin{array}{c c} \underline{Last} \ \overline{CAS} \ deassertion \ to \\ \overline{RAS} \ deassertion^4 \\ \bullet \ BRW[1:0] = 00 \\ \bullet \ BRW[1:0] = 01 \\ \bullet \ BRW[1:0] = 10 \\ \bullet \ BRW[1:0] = 11 \end{array}$	t _{CRP}		81.5 156.5 206.5 306.5	_ _ _ _	52.3 102.2 135.5 202.1	_ _ _ _	ns ns ns ns
139	CAS deassertion pulse width	t _{CP}	$0.5 \times T_{\mathrm{C}} - 4.0$	21.0	_	12.7	_	ns
140	Column address valid to CAS assertion	tASC	$0.5 \times T_{C} - 4.0$	21.0	_	12.7	_	ns
141	CAS assertion to column address not valid	t _{CAH}	$0.75 \times T_{\rm C} - 4.0$	33.5	_	21.0	_	ns
142	Last column address valid to RAS deassertion	t _{RAL}	$2 \times T_{\rm C} - 4.0$	96.0	_	62.7	_	ns
143	WR deassertion to CAS assertion	t _{RCS}	$0.75 \times T_{\rm C} - 3.8$	33.7	_	21.2	_	ns
144	CAS deassertion to WR assertion	t _{RCH}	$0.25 \times T_{\rm C} - 3.7$	8.8	_	4.6	_	ns
145	CAS assertion to WR deassertion	t _{WCH}	$0.5 \times T_{C} - 4.2$	20.8	_	12.5	_	ns
146	WR assertion pulse width	t _{WP}	$1.5 \times T_C - 4.5$	70.5	_	45.5	_	ns
147	Last $\overline{\text{WR}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{RWL}	$1.75 \times T_C - 4.3$	83.2	_	54.0	_	ns

External Memory Expansion Port (Port A)

Table 2-9DRAM Page Mode Timings, One Wait State (Low-Power Applications) $^{1, 2, 3}$

No.	Characteristics	Symbol	Expression	20 M	Hz ⁶	30 M	Hz ⁶	Unit
140.	Characteristics	Symbol	LAPICSSION	Min	Max	Min	Max	Ome
148	WR assertion to CAS deassertion	t _{CWL}	$1.75 \times T_C - 4.3$	83.2	_	54.0	_	ns
149	Data valid to CAS assertion (Write)	t _{DS}	$0.25 \times T_C - 4.0$	8.5		4.3	1	ns
150	CAS assertion to data not valid (write)	t _{DH}	$0.75 \times T_C - 4.0$	33.5	_	21.0		ns
151	\overline{WR} assertion to \overline{CAS} assertion	t _{WCS}	$T_C - 4.3$	45.7		29.0	_	ns
152	Last \overline{RD} assertion to \overline{RAS} deassertion	t _{ROH}	$1.5 \times T_{\rm C} - 4.0$	71.0		46.0		ns
153	RD assertion to data valid	t_{GA}	$T_{\rm C} - 7.5$	_	42.5	_	25.8	ns
154	$\overline{ m RD}$ deassertion to data not valid 5	t _{GZ}		0.0	_	0.0	_	ns
155	WR assertion to data active		$0.75 \times T_{\rm C} - 0.3$	37.2		24.7		ns
156	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$	_	12.5	_	8.3	ns

Notes:

- 1. The number of wait states for Page mode access is specified in the DCR.
- 2. The refresh period is spec<mark>ified in the DCR.</mark>
- 3. All the timings are calculated for the worst case. Some of the timings are better for specific cases (e.g., t_{PC} equals $2 \times T_{C}$ for read-after-read or write-after-write sequences).
- 4. BRW[1:0] (DRAM control register bits) defines the number of wait states that should be inserted in each DRAM out-of-page access.
- 5. RD deassertion will always occur after CAS deassertion; therefore, the restricted timing is t_{OFF} and not t_{CZ}.
- Reduced DSP clock speed allows use of Page Mode DRAM with one Wait state (See Figure 2-14.).



 Table 2-10
 DRAM Page Mode Timings, Two Wait States^{1, 2, 3, 7}

N.T.		G 1 1	Б.	66 N	ИHz	80 N	ИHz	T T •.
No.	Characteristics	Symbol	Expression	Min	Max	Min	Max	Unit
131	Page mode cycle time	t _{PC}	$2.75 \times T_{\rm C}$	41.7	_	34.4	_	ns
132	CAS assertion to data valid (read)	t _{CAC}	$\begin{array}{c} \textbf{66 MHz:} \\ 1.5 \times T_{C} - 7.5 \\ \textbf{80 MHz:} \\ 1.5 \times T_{C} - 6.5 \end{array}$	_	15.2	Ī.		ns ns
133	Column address valid to data valid (read)	t _{AA}	$\begin{array}{c} \textbf{66 MHz:} \\ 2.5 \times T_{C} - 7.5 \\ \textbf{80 MHz:} \\ 2.5 \times T_{C} - 6.5 \end{array}$		30.4		24.8	ns
134	CAS deassertion to data not valid (read hold time)	t _{OFF}	4	0.0		0.0	_	ns
135	Last $\overline{\text{CAS}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{RSH}	$1.75 \times T_{\rm C} - 4.0$	22.5	_	17.9	_	ns
136		t _{RHCP}	$3.25 \times T_{C} - 4.0$	45.2	_	36.6	_	ns
137	CAS assertion pulse width	t_{CAS}	$1.5 \times T_{\rm C} - 4.0$	18.7	_	14.8	_	ns
138	Last \overline{CAS} deassertion to \overline{RAS} deassertion ⁵ • BRW[1:0] = 00 • BRW[1:0] = 01 • BRW[1:0] = 10 • BRW[1:0] = 11	t _{CRP}	$\begin{array}{c} 2.0\times T_{\rm C}-6.0\\ 3.5\times T_{\rm C}-6.0\\ 4.5\times T_{\rm C}-6.0\\ 6.5\times T_{\rm C}-6.0 \end{array}$	24.4 47.2 62.4 92.8	_ _ _ _	19.0 37.8 50.3 75.3	_ _ _ _	ns ns ns
139	CAS deassertion pulse width	t _{CP}	$1.25 \times T_{\rm C} - 4.0$	14.9	_	11.6	_	ns
140	Column address valid to CAS assertion	t _{ASC}	$T_C - 4.0$	11.2	_	8.5	_	ns
141	CAS assertion to column address not valid	t _{CAH}	$1.75 \times T_{\rm C} - 4.0$	22.5	_	17.9	_	ns
142	Last column address valid to RAS deassertion	t _{RAL}	$3 \times T_{\rm C} - 4.0$	41.5	_	33.5	_	ns
143	WR deassertion to CAS assertion	t _{RCS}	$1.25 \times T_C - 3.8$	15.1		11.8	_	ns
144	CAS deassertion to WR assertion	t _{RCH}	$0.5 \times T_{\rm C} - 3.7$	3.9	_	2.6	_	ns
145	CAS assertion to WR deassertion	t _{WCH}	$1.5 \times T_{\rm C} - 4.2$	18.5	_	14.6	_	ns
146	WR assertion pulse width	t _{WP}	$2.5 \times T_C - 4.5$	33.4	_	26.8	_	ns

External Memory Expansion Port (Port A)

Table 2-10 DRAM Page Mode Timings, Two Wait States^{1, 2, 3, 7} (Continued)

NI.	Characteristics	Symbol Expression	F	66 MHz		80 N	T124	
No.			Expression	Min	Max	Min	Max	Unit
147	Last $\overline{\text{WR}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{RWL}	$2.75 \times T_C - 4.3$	37.4	_	30.1	_	ns
148	WR assertion to CAS deassertion	t _{CWL}	$2.5 \times T_{\rm C} - 4.3$	33.6	_	27.0	_	ns
149	Data valid to CAS assertion (write)	t _{DS}	$\begin{array}{l} \textbf{66 MHz:} \\ 0.25 \times T_{C} - 3.7 \\ \textbf{80 MHz:} \\ 0.25 \times T_{C} - 3.0 \end{array}$	0.1		0.1	_	ns ns
150	CAS assertion to data not valid (write)	t _{DH}	$1.75 \times T_{\rm C} - 4.0$	22.5	_	17.9	_	ns
151	WR assertion to CAS assertion	t _{WCS}	$T_C - 4.3$	10.9		8.2	_	ns
152	Last \overline{RD} assertion to \overline{RAS} deassertion	t _{ROH}	$2.5 \times T_C - 4.0$	33.9	_	27.3	_	ns
153	RD assertion to data valid	t _{GA}	$\begin{array}{c} \textbf{66 MHz:} \\ \textbf{1.75} \times \textbf{T}_{\text{C}} - \textbf{7.5} \\ \textbf{80 MHz:} \\ \textbf{1.75} \times \textbf{T}_{\text{C}} - \textbf{6.5} \end{array}$	_	19.0	_	_ 15.4	ns ns
154	$\overline{ m RD}$ deassertion to data not valid ⁶	$t_{\rm GZ}$		0.0	_	0.0	_	ns
155	WR assertion to data active		$0.75 \times T_{\rm C} - 0.3$	11.1	_	9.1	_	ns
156	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$	_	3.8		3.1	ns

Notes:

- 1. The number of wait states for Page mode access is specified in the DCR.
- 2. The refresh period is specified in the DCR.
- 3. The asynchronous delays specified in the expressions are valid for DSP56301.
- 4. All the timings are calculated for the worst case. Some of the timings are better for specific cases (e.g., t_{PC} equals $3 \times T_{C}$ for read-after-read or write-after-write sequences).
- 5. BRW[1:0] (DRAM Control Register bits) defines the number of wait states that should be inserted in each DRAM out-of-page access.
- $\overline{\text{RD}}$ deassertion will always occur after $\overline{\text{CAS}}$ deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ} .
- 7. There are no DRAMs fast enough to fit to two wait states Page mode @ 100MHz (See **Figure 2-14**.)

 $\textbf{Table 2-11} \quad \text{DRAM Page Mode Timings, Three Wait States}^{1,\ 2,\ 3}$

NT.	Characteristics	Symbol	Expression	66 MHz		80 MHz		100 MHz		T Iv-24
No.				Min	Max	Min	Max	Min	Max	Unit
131	Page mode cycle time	t _{PC}	$3.5 \times T_{\rm C}$	53.0	_	43.8	_	35.0	_	ns
132	CAS assertion to data valid (read)	t _{CAC}	66 MHz: 2 × T _C - 7.5 80 MHz:	_	22.8	_	_	1	_	ns
			$2 \times T_{C} - 6.5$ 100 MHz : $2 \times T_{C} - 5.7$		_		18.5	_	14.3	ns ns
133	Column address valid to data valid (read)	t _{AA}	66 MHz : 3 × T _C - 7.5 80 MHz :	_	37.9	-	>	_	_	ns
			$3 \times T_{C} - 6.5$ 100 MHz : $3 \times T_{C} - 5.7$	<u></u>			31.0	_	24.3	ns ns
134	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0	_	0.0		0.0		ns
135	Last $\overline{\text{CAS}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{RSH}	$2.5 \times T_{\rm C} - 4.0$	33.9	_	27.3	_	21.0		ns
136	$\frac{\text{Prev}}{\text{RAS}}$ deassertion to $\frac{\text{RAS}}{\text{RAS}}$ deassertion	t _{RHCP}	$4.5 \times T_{\rm C} - 4.0$	64.2	_	52.3	_	41.0		ns
137	CAS assertion pulse width	t _{CAS}	$2 \times T_{\rm C} - 4.0$	26.3		21.0	_	16.0	_	ns
138	Last CAS deassertion to RAS deassertion ⁵	t _{CRP}								
	• BRW[1:0] = 00)	$2.25 \times T_{\rm C} - 6.0$	28.2		22.2	_	16.5	_	ns
	• BRW[1:0] = 01 • BRW[1:0] = 10		$\begin{array}{c} 3.75 \times T_{C} - 6.0 \\ 4.75 \times T_{C} - 6.0 \end{array}$	51.0 66.2	_	40.9 53.4		31.5 41.5		ns ns
	• BRW[1:0] = 11		$6.75 \times T_{\rm C} - 6.0$	96.6		78.4	_	61.5	_	ns
139	CAS deassertion pulse width	t _{CP}	$1.5 \times T_{\rm C} - 4.0$	18.7	_	14.8	_	11.0	_	ns
140	Column address valid to CAS assertion	t _{ASC}	$T_C - 4.0$	11.2	_	8.5	_	6.0	_	ns
141	CAS assertion to column address not valid	t _{CAH}	$2.5 \times T_{\rm C} - 4.0$	33.9	_	27.3	_	21.0	_	ns
142	Last column address valid to RAS deassertion	t _{RAL}	$4 \times T_{\rm C} - 4.0$	56.6	_	46.0	_	36.0	_	ns
143	$\overline{\text{WR}}$ deassertion to $\overline{\text{CAS}}$ assertion	t _{RCS}	$1.25 \times T_{\text{C}} - 3.8$	15.1	_	11.8	_	8.7	_	ns
144	$\overline{\text{CAS}}$ deassertion to $\overline{\text{WR}}$ assertion	t _{RCH}	$0.75 \times T_{C} - 3.7$	7.7	_	5.7	_	3.8	_	ns

External Memory Expansion Port (Port A)

 Table 2-11
 DRAM Page Mode Timings, Three Wait States^{1, 2, 3} (Continued)

No.	Characteristics	Symbol	Expression	66 MHz		80 MHz		100 MHz		Unit
NO.				Min	Max	Min	Max	Min	Max	Oiiit
145	CAS assertion to WR deassertion	t _{WCH}	$2.25 \times T_{\text{C}} - 4.2$	29.9	_	23.9	_	18.3		ns
146	WR assertion pulse width	t_{WP}	$3.5 \times T_C - 4.5$	48.5	_	39.3		3 <mark>0.5</mark>		ns
147	Last \overline{WR} assertion to \overline{RAS} deassertion	t_{RWL}	$3.75 \times T_{C} - 4.3$	52.5	_	42.6	4	33.2		ns
148	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ deassertion	t_{CWL}	$3.25 \times T_{C} - 4.3$	44.9	_	36.3	7	28.2		ns
149	Data valid to CAS assertion (write)	t_{DS}	$0.5 \times T_{\rm C} - 4.0$	3.6	_	2.3		1.0		ns
150	CAS assertion to data not valid (write)	t _{DH}	$2.5 \times T_{\rm C} - 4.0$	33.9	Y	27.3	_	21.0		ns
151	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ assertion	t _{WCS}	$1.25 \times T_C - 4.3$	14.6	_,	11.3	_	8.2	_	ns
152	Last \overline{RD} assertion to \overline{RAS} deassertion	t _{ROH}	$3.5 \times T_{\rm C} - 4.0$	49.0	_	39.8	_	31.0		ns
153	RD assertion to data valid	t _{GA}	66 MHz: 2.5 × T _C – 7.5 80 MHz:	_	30.4	_	_	_		ns
			$\frac{2.5 \times T_{C} - 6.5}{100 \text{ MHz}}$:		_	_	24.8	_	_	ns
			$\frac{2.5}{2.5} \times T_{\rm C} - 5.7$		_		_		19.3	ns
154	RD deassertion to data not valid ⁶	t _{GZ}	· ·	0.0	_	0.0	_	0.0	_	ns
155	WR assertion to data active		$0.75 \times T_C - 0.3$	11.1		9.1		7.2		ns
156	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$		3.8	_	3.1		2.5	ns

Notes: 1. The number of wait states for Page mode access is specified in the DCR.

- The refresh period is specified in the DCR.
 The asynchronous delays specified in the expressions are valid for DSP56301.
 All the timings are calculated for the worst case. Some of the timings are better for specific cases (e.g., t_{PC} equals $4 \times T_C$ for read-after-read or write-after-write sequences).
- 5. BRW[1:0] (DRAM control register bits) defines the number of wait states that should be inserted in each DRAM out-of page-access.
- 6. \overline{RD} deassertion will always occur after \overline{CAS} deassertion; therefore, the restricted timing is t_{OFF} and not

 $\textbf{Table 2-12} \quad \text{DRAM Page Mode Timings, Four Wait States}^{1,\ 2,\ 3}$

	Characteristics	Symbol	Expression	66 MHz		80 N	ИНz	100 MHz		T T
No.				Min	Max	Min	Max	Min	Max	Unit
131	Page mode cycle time	t _{PC}	$4.5 \times T_{C}$	68.2	_	56.3	_	45.0	_	ns
132	CAS assertion to data valid (read)	t _{CAC}	66 MHz: 2.75 × T _C - 7.5 80 MHz:	_	34.2	_	_	1	_	ns
			$ \begin{array}{c} 2.75 \times T_C - 6.5 \\ \textbf{100 MHz} : \\ 2.75 \times T_C - 5.7 \end{array} $	_	_		27.9	-	21.8	ns ns
133	Column address valid to data valid (read)	t _{AA}	66 MHz : 3.75 × T _C – 7.5 80 MHz :	_	49.3	_		_	_	ns
			$3.75 \times T_{C} - 6.5$ 100 MHz :	<u> </u>	V		40.4	_	21.0	ns
104	GAC 1		$3.75 \times T_{\rm C} - 5.7$					_	31.8	ns
134	CAS deassertion to data not valid (read hold time)	t_{OFF}		0.0	_	0.0	_	0.0		ns
135	Last $\overline{\text{CAS}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{RSH}	$3.5 \times T_{\rm C} - 4.0$	49.0	_	39.8	_	31.0	_	ns
136	Previous \overline{CAS} deassertion to \overline{RAS} deassertion	t _{RHCP}	$6 \times T_C - 4.0$	86.9	_	71.0	_	56.0	_	ns
137	CAS assertion pulse width	t _{CAS}	$2.5 \times T_{\rm C} - 4.0$	33.9	_	27.3		21.0	_	ns
138	Last CAS deassertion to RAS deassertion ⁵ BRW[1:0] = 00 BRW[1:0] = 01 BRW[1:0] = 10 BRW[1:0] = 11	t _{CRP}	$2.75 \times T_{C} - 6.0 \\ 4.25 \times T_{C} - 6.0 \\ 5.25 \times T_{C} - 6.0 \\ 6.25 \times T_{C} - 6.0$	35.8 58.6 73.8 89.0		28.4 47.2 59.7 72.2	_ _ _	21.5 36.5 46.5 56.5		ns ns ns
139	CAS deassertion pulse width	t _{CP}	$2 \times T_{\rm C} - 4.0$	26.3	_	21.0	_	16.0	_	ns
140	Column address valid to CAS assertion	t _{ASC}	T _C - 4.0	11.2	_	8.5	_	6.0	_	ns
141	CAS assertion to column address not valid	t _{CAH}	$3.5 \times T_C - 4.0$	49.0	_	39.8	_	31.0	_	ns
142		t _{RAL}	$5 \times T_{\rm C} - 4.0$	71.8	_	58.5	_	46.0	_	ns
143	WR deassertion to CAS assertion	t _{RCS}	$1.25 \times T_{\rm C} - 3.8$	15.1	_	11.8	_	8.7	_	ns
144	CAS deassertion to WR assertion	t _{RCH}	$1.25 \times T_{\rm C} - 3.7$	15.2	_	11.9	_	8.8	_	ns

Table 2-12 DRAM Page Mode Timings, Four Wait States^{1, 2, 3} (Continued)

NI-	Characteristics	Symbol	Expression	66 MHz		80 MHz		100 MHz		Unit
No.				Min	Max	Min	Max	Min	Max	Ome
145	CAS assertion to WR deassertion	t _{WCH}	$3.25 \times T_{\rm C} - 4.2$	45.0	_	36.4	_	28.3	_	ns
146	WR assertion pulse width	t _{WP}	$4.5 \times T_C - 4.5$	63.7	_	51.8		40. <mark>5</mark>	_	ns
147	Last \overline{WR} assertion to \overline{RAS} deassertion	t _{RWL}	$4.75 \times T_{\rm C} - 4.3$	67.7		55.1	1	43.2	-	ns
148	$\overline{ m WR}$ assertion to $\overline{ m CAS}$ deassertion	t _{CWL}	$3.75 \times T_{\rm C} - 4.3$	52.5		42.6	K	33.2	_	ns
149	Data valid to CAS assertion (write)	t _{DS}	$0.5 \times T_C - 4.0$	3.6	<u></u>	2.3		1.0	_	ns
150	CAS assertion to data not valid (write)	t _{DH}	$3.5 \times T_C - 4.0$	49.0	1	39.8	_	31.0	_	ns
151	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ assertion	t _{WCS}	$1.25 \times T_{\rm C} - 4.3$	14.6		11.3	_	8.2	_	ns
152	Last \overline{RD} assertion to \overline{RAS} deassertion	t _{ROH}	$4.5 \times T_{\rm C} - 4.0$	64.2	_	52.3	_	41.0	_	ns
153	RD assertion to data valid	t _{GA}	66 MHz: 3.25 × T _C – 7.5 80 MHz:	_	41.7	_	_	_	_	ns
	•		$3.25 \times T_{\rm C} - 6.5$ 100 MHz :	_		_	34.1		_	ns
			$3.25 \times T_{\rm C} - 5.7$	_	_	_	_	_	26.8	ns
154	RD deassertion to data not valid ⁶	t _{GZ}		0.0	_	0.0	_	0.0	_	ns
155	WR assertion to data active		$0.75 \times T_{C} - 0.3$	11.1		9.1		7.2	_	ns
156	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$	_	3.8	_	3.1	_	2.5	ns

Notes: 1. The number of wait states for Page mode access is specified in the DCR.

- 2. The refresh period is specified in the DCR.
- 3. The asynchronous delays specified in the expressions are valid for DSP56301.
- 4. All the timings are calculated for the worst case. Some of the timings are better for specific cases (e.g., t_{PC} equals $3 \times T_{C}$ for read-after-read or write-after-write sequences).
- 5. BRW[1:0] (DRAM control register bits) defines the number of wait states that should be inserted in each DRAM out-of-page access.
- 6. \overline{RD} deassertion will always occur after \overline{CAS} deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ} .

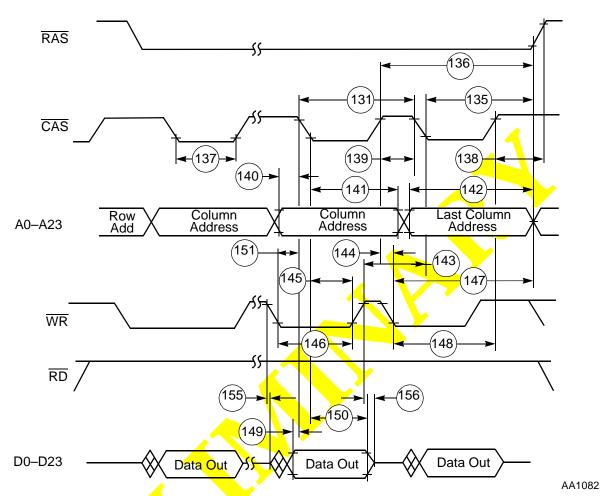


Figure 2-15 DRAM Page Mode Write Accesses

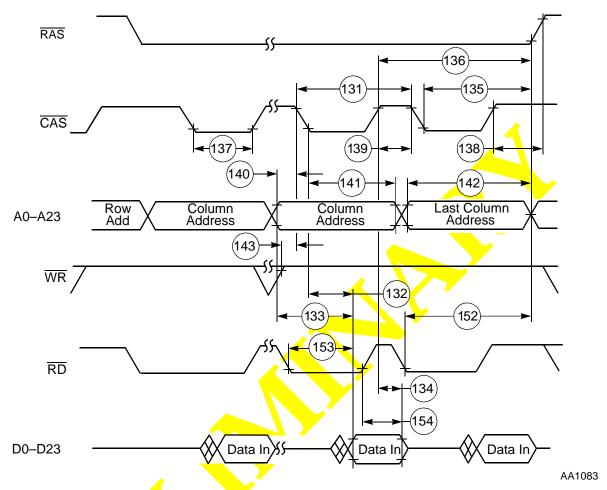


Figure 2-16 DRAM Page Mode Read Accesses

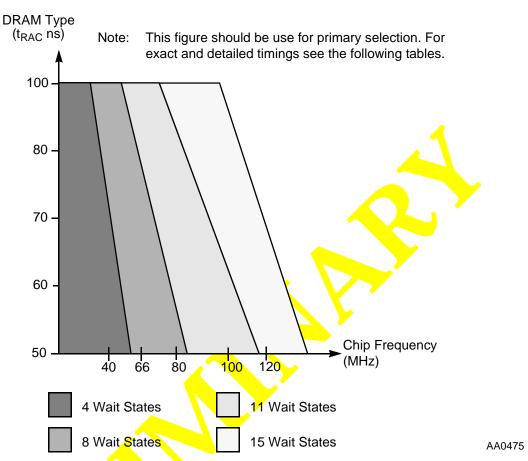


Figure 2-17 DRAM Out-of-Page Wait States Selection Guide

 Table 2-13
 DRAM Out-of-Page and Refresh Timings, Four Wait States^{1, 2}

No.	Characteristics ³	Symbol	-	20 N	1Hz ⁴	30 M	1Hz ⁴	Unit
110.	Characteristics	Symbol	LAPICSSION	Min	Max	Min	Max	Ome
157	Random read or write cycle time	t _{RC}	$5 \times T_{C}$	250.0	_	166.7	_	ns
158	RAS assertion to data valid (read)	t _{RAC}	$2.75 \times T_{\rm C} - 7.5$	_	130.0		84.2	ns
159	CAS assertion to data valid (read)	t _{CAC}	$1.25 \times T_{\rm C} - 7.5$	_	55.0	_	34.2	ns
160	Column address valid to data valid (read)	t _{AA}	$1.5 \times T_{\rm C} - 7.5$	_	67.5		42.5	ns
161	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0	_	0.0	_	ns

Table 2-13 DRAM Out-of-Page and Refresh Timings, Four Wait States^{1, 2} (Continued)

No.	GI 4 1 1 3	Symbol	Expression	20 N	IHz ⁴	30 N	1Hz ⁴	Unit
INU.	Characteristics ³	Symbol	Expression	Min	Max	Min	Max	UIII
162	\overline{RAS} deassertion to \overline{RAS} assertion	t _{RP}	$1.75 \times T_{\text{C}} - 4.0$	83.5	_	54.3	_	ns
163	RAS assertion pulse width	t _{RAS}	$3.25 \times T_{\text{C}} - 4.0$	158.5	_	104.3	1	ns
164	CAS assertion to RAS deassertion	t _{RSH}	$1.75 \times T_{\text{C}} - 4.0$	83.5	_	54.3		ns
165	RAS assertion to CAS deassertion	t _{CSH}	$2.75 \times T_C - 4.0$	133.5	-	87.7) –	ns
166	CAS assertion pulse width	t _{CAS}	$1.25 \times T_{\text{C}} - 4.0$	58.5		37.7	_	ns
167	RAS assertion to CAS assertion	t_{RCD}	$1.5 \times T_{\rm C} \pm 2$	73.0	77.0	48.0	52.0	ns
168	RAS assertion to column address valid	t_{RAD}	$1.25 \times T_C \pm 2$	60.5	64.5	39.7	43.7	ns
169	CAS deassertion to RAS assertion	t _{CRP}	$2.25 \times T_{\rm C} - 4.0$	108.5	_	71.0	_	ns
170	CAS deassertion pulse width	t _{CP}	$1.75 \times T_{\rm C} - 4.0$	83.5	_	54.3	_	ns
171	Row address valid to RAS assertion	t _{ASR}	$1.75 \times T_{\rm C} - 4.0$	83.5	_	54.3	_	ns
172	RAS assertion to row address not valid	t _{RAH}	$1.25 \times T_{\rm C} - 4.0$	58.5	_	37.7	_	ns
173	Column address valid to CAS assertion	t _{ASC}	$0.25 \times T_{C} - 4.0$	8.5	_	4.3	_	ns
174	CAS assertion to column address not valid	t _{CAH}	$1.75 \times T_C - 4.0$	83.5	_	54.3	_	ns
175	RAS assertion to column address not valid	t _{AR}	$3.25 \times T_{\text{C}} - 4.0$	158.5	_	104.3	_	ns
176	Column address valid to RAS deassertion	t_{RAL}	$2 \times T_{\rm C} - 4.0$	96.0	_	62.7	_	ns
177	WR deassertion to CAS assertion	t _{RCS}	$1.5 \times T_{\rm C} - 3.8$	71.2	_	46.2	_	ns
178	$\overline{\text{CAS}}$ deassertion to $\overline{\text{WR}}$ assertion	t _{RCH}	$0.75 \times T_{C} - 3.7$	33.8	_	21.3	_	ns
179	\overline{RAS} deassertion to \overline{WR} assertion	t _{RRH}	$0.25 \times T_{C} - 3.7$	8.8	_	4.6	_	ns

 Table 2-13
 DRAM Out-of-Page and Refresh Timings, Four Wait States^{1, 2} (Continued)

No.	Characteristics ³	Symbol	Expression	20 M	1Hz ⁴	30 M	1Hz ⁴	Unit
110.	Characteristics	Бушьог	Lapression	Min	Max	Min	Max	Omt
180	CAS assertion to WR deassertion	t _{WCH}	$1.5 \times T_C - 4.2$	70.8	_	45.8	_	ns
181	\overline{RAS} assertion to \overline{WR} deassertion	t _{WCR}	$3 \times T_C - 4.2$	145.8	_	95.8		ns
182	WR assertion pulse width	t_{WP}	$4.5 \times T_{\rm C} - 4.5$	220.5	_	145.5		ns
183	\overline{WR} assertion to \overline{RAS} deassertion	t_{RWL}	$4.75 \times T_{C} - 4.3$	233.2	1	154.0		ns
184	WR assertion to CAS deassertion	t_{CWL}	$4.25 \times T_{C} - 4.3$	208.2		137.4	_	ns
185	Data valid to $\overline{\text{CAS}}$ assertion (write)	$t_{ m DS}$	$2.25 \times T_{C} - 4.0$	108.5	\ <u></u>	71.0	_	ns
186	CAS assertion to data not valid (write)	t _{DH}	$1.75 \times T_{\text{C}} - 4.0$	83.5	_	54.3	_	ns
187	RAS assertion to data not valid (write)	t _{DHR}	$3.25 \times T_{\rm C} - 4.0$	158.5	_	104.3	_	ns
188	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ assertion	t _{WCS}	$3 \times T_C - 4.3$	145.7	_	95.7	_	ns
189	$\overline{\text{CAS}}$ assertion to $\overline{\text{RAS}}$ assertion (refresh)	t _{CSR}	$0.5 \times T_C - 4.0$	21.0	_	12.7	_	ns
190	RAS deassertion to CAS assertion (refresh)	t _{RPC}	$1.25 \times T_{\rm C} - 4.0$	58.5	_	37.7	_	ns
191	RD assertion to RAS deassertion	t _{ROH}	$4.5 \times T_C - 4.0$	221.0	_	146.0	_	ns
192	RD assertion to data valid	$t_{ m GA}$	$4 \times T_C - 7.5$	_	192.5	_	125.8	ns
193	RD deassertion to data not valid ³	t_{GZ}		0.0	_	0.0	_	ns
194	WR assertion to data active		$0.75 \times T_{\rm C} - 0.3$	37.2	_	24.7	_	ns
195	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$	_	12.5		8.3	ns

Notes: 1.

- 1. The number of wait states for out of page access is specified in the DCR.
- 2. The refresh period is specified in the DCR.
- 3. \overline{RD} deassertion will always occur after \overline{CAS} deassertion; therefore, the restricted timing is t_{OFF} and not t_{CZ} .
- t_{GZ}.
 4. Reduced DSP clock speed allows use of DRAM out-of-page access with four Wait states (See Figure 2-17.).

 $\textbf{Table 2-14} \quad \text{DRAM Out-of-Page and Refresh Timings, Eight Wait States}^{1,\,2}$

NI-		Ck - 1	3	66 MHz		80 N	ИHz	100 l	MHz	T T 24
No.	Characteristics ⁴	Symbol	Expression ³	Min	Max	Min	Max	Min	Max	Unit
157	Random read or write cycle time	t _{RC}	$9 \times T_{\rm C}$	136.4	1	112.5	1	90.0		ns
158	RAS assertion to data valid (read)	t _{RAC}	66 MHz : $4.75 \times T_C - 7.5$ 80 MHz : $4.75 \times T_C - 6.5$ 100 MHz : $4.75 \times T_C - 5.7$	_	64.5	_	52.9	7 1 7	41.8	ns ns
159	CAS assertion to data valid (read)	t _{CAC}	$\begin{array}{c} \textbf{66 MHz:} \\ \textbf{2.25} \times \textbf{T}_{\text{C}} - 7.5 \\ \textbf{80 MHz:} \\ \textbf{2.25} \times \textbf{T}_{\text{C}} - 6.5 \\ \textbf{100 MHz:} \\ \textbf{2.25} \times \textbf{T}_{\text{C}} - 5.7 \\ \end{array}$		26.6		21.6	_ _ _		ns ns
160	Column address valid to data valid (read)	t _{AA}	66 MHz: $3 \times T_C - 7.5$ 80 MHz: $3 \times T_C - 6.5$ 100 MHz: $3 \times T_C - 5.7$	-	40.0	_ _ _	- 31.0	_ _ _	_ _ _ 24.3	ns ns
161	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0	_	0.0	_	0.0	_	ns
162	RAS deassertion to RAS assertion	t _{RP}	$3.25 \times T_{\rm C} - 4.0$	45.2	_	36.6	_	28.5	_	ns
163	RAS assertion pulse width	t _{RAS}	$5.75 \times T_{\rm C} - 4.0$	83.1	_	67.9	_	53.5	_	ns
164	CAS assertion to RAS deassertion	t _{RSH}	$3.25 \times T_{\rm C} - 4.0$	45.2	_	36.6	_	28.5	_	ns
165	RAS assertion to CAS deassertion	t _{CSH}	$4.75 \times T_{\rm C} - 4.0$	68.0	_	55.4	_	43.5		ns
166	CAS assertion pulse width	t _{CAS}	$2.25 \times T_{\text{C}} - 4.0$	30.1	_	24.1	_	18.5	_	ns
167	RAS assertion to CAS assertion	t _{RCD}	$2.5 \times T_C \pm 2$	35.9	39.9	29.3	33.3	23.0	27.0	ns
168	RAS assertion to column address valid	t _{RAD}	$1.75 \times T_{\rm C} \pm 2$	24.5	28.5	19.9	23.9	15.5	19.5	ns
169	CAS deassertion to RAS assertion	t _{CRP}	$4.25 \times T_{\rm C} - 4.0$	59.8	_	49.1	_	38.5	_	ns
170	CAS deassertion pulse width	t _{CP}	$2.75 \times T_C - 4.0$	37.7	—	30.4	—	23.5	_	ns

Table 2-14 DRAM Out-of-Page and Refresh Timings, Eight Wait States^{1, 2} (Continued)

		_	1	ı	_			1		
No.	Characteristics ⁴	Symbol	Expression ³	66 N	ИHz	80 N	ИHz	100 l	MHz	Unit
140.	Characteristics	Symbol	Expression	Min	Max	Min	Max	Min	Max	Ome
171	Row address valid to \overline{RAS} assertion	t _{ASR}	$3.25 \times T_{\rm C} - 4.0$	45.2	1	36.6	1	28.5	_	ns
172	RAS assertion to row address not valid	t _{RAH}	$1.75 \times T_C - 4.0$	22.5		17.9	1	13.5	_	ns
173	Column address valid to CAS assertion	t _{ASC}	$0.75 \times T_C - 4.0$	7.4		5.4	ا ا	3.5		ns
174	CAS assertion to column address not valid	t _{CAH}	$3.25 \times T_C - 4.0$	45.2		36.6	15	<mark>28.</mark> 5		ns
175	RAS assertion to column address not valid	t _{AR}	$5.75 \times T_{\rm C} - 4.0$	83.1	1	67.9	1	53.5	_	ns
176	Column address valid to RAS deassertion	t _{RAL}	$4 \times T_{\rm C} - 4.0$	56.6	-	46.0	_	36.0	_	ns
177	$\overline{\text{WR}}$ deassertion to $\overline{\text{CAS}}$ assertion	t _{RCS}	$2 \times T_C - 3.8$	26.5		21.2	_	16.2	_	ns
178	$\overline{\text{CAS}}$ deassertion to $\overline{\text{WR}}^5$ assertion	t _{RCH}	$1.25 \times T_{\rm C} - 3.7$	15.2		11.9		8.8	_	ns
179	\overline{RAS} deassertion to \overline{WR}^5 assertion	t _{RRH}	66 MHz: 0.25 × T _C - 3.7 80 MHz:	0.1	_	_		_	_	ns
			$0.25 \times T_{C} - 3.0$ 100 MHz: $0.25 \times T_{C} - 2.4$	_	_	0.1	_	0.1	_	ns ns
180	CAS assertion to WR deassertion	t _{WCH}	$3 \times T_{C} - 4.2$	41.3	_	33.3	_	25.8	_	ns
181	RAS assertion to deassertion	t _{WCR}	$5.5 \times T_C - 4.2$	79.1	_	64.6	_	50.8	_	ns
182	WR assertion pulse width	t _{WP}	$8.5 \times T_C - 4.5$	124.3	_	101.8	_	80.5	_	ns
183	WR assertion to RAS deassertion	t _{RWL}	$8.75 \times T_{\rm C} - 4.3$	128.3	_	105.1	_	83.2	_	ns
184	WR assertion to CAS deassertion	t _{CWL}	$7.75 \times T_{\rm C} - 4.3$	113.1	_	92.6	_	73.2	_	ns
185	Data valid to CAS assertion (write)	t _{DS}	$4.75 \times T_{\rm C} - 4.0$	68.0	_	55.4	_	43.5	_	ns
186	CAS assertion to data not valid (write)	t _{DH}	$3.25 \times T_C - 4.0$	45.2	_	36.6	_	28.5	_	ns
187	RAS assertion to data not valid (write)	t _{DHR}	$5.75 \times T_{\rm C} - 4.0$	83.1	_	67.9	_	53.5	_	ns

Table 2-14 DRAM Out-of-Page and Refresh Timings, Eight Wait States^{1, 2} (Continued)

NI-	a	Symbol		66 N	ИHz	80 N	ИHz	100 MHz		T I 24
No.	Characteristics ⁴	Symbol	Expression ³	Min	Max	Min	Max	Min	Max	Unit
188	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ assertion	t _{WCS}	$5.5 \times T_C - 4.3$	79.0	_	64.5	_	50.7	_	ns
189	$\overline{\text{CAS}}$ assertion to $\overline{\text{RAS}}$ assertion (refresh)	t _{CSR}	$1.5 \times T_C - 4.0$	18.7		14.8	ı	11.0	_	ns
190	\overline{RAS} deassertion to \overline{CAS} assertion (refresh)	t _{RPC}	$1.75 \times T_C - 4.0$	22.5	_	17.9	ا ا	13.5	1	ns
191	\overline{RD} assertion to \overline{RAS} deassertion	t _{ROH}	$8.5 \times T_{C} - 4.0$	124.8	_	102.3	15	81.0		ns
192	RD assertion to data valid	t _{GA}	66 MHz : 7.5 × T _C - 7.5 80 MHz :	~	106.1	X	97.9	_		ns
			$7.5 \times T_{C} - 6.5$ 100 MHz : $7.5 \times T_{C} - 5.7$	ĺ			87.3 —		69.3	ns ns
193	RD deassertion to data not valid ⁴	$t_{ m GZ}$	0.0	0.0	_	0.0	l	0.0		ns
194	WR assertion to data active		$0.75 \times T_{\rm C} - 0.3$	11.1		9.1		7.2		ns
195	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$	_	3.8	_	3.1	_	2.5	ns

Notes: 1. The number of wait states for out-of-page access is specified in the DCR.

- 2. The refresh period is specified in the DCR.
- 3. The asynchronous delays specified in the expressions are valid for DSP56301.
- 4. $\overline{\text{RD}}$ deassertion will always occur after $\overline{\text{CAS}}$ deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ} .
- 5. Either t_{RCH} or t_{RRH} must be satisfied for read cycles.



 Table 2-15
 DRAM Out-of-Page and Refresh Timings, Eleven Wait States^{1, 2}

		G 1 1	9	66 N	ИHz	80 N	ИHz	100 I	ИНz	T 7 •.
No.	Characteristics ⁴	Symbol	Expression ³	Min	Max	Min	Max	Min	Max	Unit
157	Random read or write cycle time	t _{RC}	$12 \times T_{\rm C}$	181.8	_	150.0	_	120.0	_	ns
158	RAS assertion to data valid (read)	t _{RAC}	$\begin{array}{c} \textbf{66 MHz:} \\ 6.25 \times T_C - 7.5 \\ \textbf{80 MHz:} \\ 6.25 \times T_C - 6.5 \\ \textbf{100 MHz:} \\ 6.25 \times T_C - 5.7 \end{array}$	_	87.2		71.6	7	56.8	ns ns
159	CAS assertion to data valid (read)	t _{CAC}	$\begin{array}{c} \textbf{66 MHz:} \\ 3.75 \times T_C - 7.5 \\ \textbf{80 MHz:} \\ 3.75 \times T_C - 6.5 \\ \textbf{100 MHz:} \\ 3.75 \times T_C - 5.7 \end{array}$		49.3		40.4		_ _ 31.8	ns ns
160	Column address valid to data valid (read)	t _{AA}	$\begin{array}{c} \textbf{66 MHz:} \\ 4.5 \times T_{C} - 7.5 \\ \textbf{80 MHz:} \\ 4.5 \times T_{C} - 6.5 \\ \textbf{100 MHz:} \\ \textbf{4.5} \times T_{C} - 5.7 \end{array}$		60.7		 49.8 		_ _ 39.3	ns ns
161	CAS deassertion to data not valid (read hold time)	t _{OFF}		0.0		0.0	_	0.0		ns
162	RAS deassertion to RAS assertion	t _{RP}	$4.25 \times T_{\rm C} - 4.0$	60.4	_	49.1		38.5		ns
163	RAS assertion pulse width	t _{RAS}	$7.75 \times T_{\text{C}} - 4.0$	113.4		92.9	1	73.5	1	ns
164	CAS assertion to RAS deassertion	t _{RSH}	$5.25 \times T_{\rm C} - 4.0$	75.5	_	61.6	_	48.5	_	ns
165	RAS assertion to CAS deassertion	t _{CSH}	$6.25 \times T_{\rm C} - 4.0$	90.7	_	74.1	_	58.5	_	ns
166	CAS assertion pulse width	t _{CAS}	$3.75 \times T_C - 4.0$	52.8	_	42.9	_	33.5	_	ns
167	RAS assertion to CAS assertion	t _{RCD}	$2.5 \times T_C \pm 2$	35.9	39.9	29.3	33.3	23.0	27.0	ns
168	RAS assertion to column address valid	t _{RAD}	$1.75 \times T_{\rm C} \pm 2$	24.5	28.5	19.9	23.9	15.5	19.5	ns
169	CAS deassertion to RAS assertion	t _{CRP}	$5.75 \times T_{\rm C} - 4.0$	83.1	_	67.9	_	53.5	_	ns
170	CAS deassertion pulse width	t _{CP}	$4.25 \times T_{\rm C} - 4.0$	60.4	_	49.1	_	38.5	_	ns

Table 2-15 DRAM Out-of-Page and Refresh Timings, Eleven Wait States^{1, 2} (Continued)

N		G 1 1	2	66 N	ИHz	Hz 80 MH		100 1	MHz	T T •.
No.	Characteristics ⁴	Symbol	Expression ³	Min	Max	Min	Max	Min	Max	Unit
171	Row address valid to RAS assertion	t _{ASR}	$4.25 \times T_{\rm C} - 4.0$	60.4	1	49.1	_	38.5	_	ns
172	RAS assertion to row address not valid	t _{RAH}	$1.75 \times T_C - 4.0$	22.5	_	17.9	_	13.5	_	ns
173	Column address valid to CAS assertion	t _{ASC}	$0.75 \times T_{\rm C} - 4.0$	7.4		5.4		3.5		ns
174	CAS assertion to column address not valid	t _{CAH}	$5.25 \times T_{\rm C} - 4.0$	75.5	-	61.6	1	48 <mark>.</mark> 5	_	ns
175	RAS assertion to column address not valid	t _{AR}	$7.75 \times T_{\rm C} - 4.0$	113.4	7	92.9	7	73.5	_	ns
176	Column address valid to RAS deassertion	t _{RAL}	$6 \times T_C - 4.0$	86.9	-	71.0	_	56.0	_	ns
177	WR deassertion to CAS assertion	t _{RCS}	$3.0 \times T_{\rm C} - 3.8$	41.7	_	33.7	_	26.2	_	ns
178	$\overline{\text{CAS}}$ deassertion to $\overline{\text{WR}}^5$ assertion	t _{RCH}	$1.75 \times T_{\rm C} - 3.7$	22.8	_	18.2	_	13.8	_	ns
179	\overline{RAS} deassertion to \overline{WR}^5 assertion	t _{RRH}	66 MHz: 0.25 × T _C - 3.7 80 MHz:	0.1		_	_	_	_	ns
			$0.25 \times T_{C} - 3.0$ 100 MHz:	_	_	0.1	_	_	_	ns
180	CAS assertion to WR		$0.25 \times T_{C} - 2.4$ $5 \times T_{C} - 4.2$	71.6		58.3		0.1 45.8		ns
100	deassertion	t _{WCH}	$3 \times 1_{\rm C} - 4.2$	71.0	_	36.3		43.0		ns
181	RAS assertion to deassertion	t _{WCR}	$7.5 \times T_{C} - 4.2$	109.4	_	89.6	_	70.8	_	ns
182	WR assertion pulse width	t _{WP}	$11.5 \times T_{\rm C} - 4.5$	169.7	_	139.3	_	110.5	_	ns
183	WR assertion to RAS deassertion	t _{RWL}	$11.75 \times T_{C} - 4.3$	173.7	_	142.7	_	113.2	_	ns
184	WR assertion to CAS deassertion	t _{CWL}	$10.25 \times T_C - 4.3$	151.0	_	130.1	_	103.2	_	ns
185	Data valid to CAS assertion (write)	t _{DS}	$5.75 \times T_{\rm C} - 4.0$	83.1	_	67.9	_	53.5	_	ns
186	CAS assertion to data not valid (write)	t _{DH}	$5.25 \times T_{\rm C} - 4.0$	75.5	_	61.6	_	48.5	_	ns
187	RAS assertion to data not valid (write)	t _{DHR}	$7.75 \times T_{\rm C} - 4.0$	113.4	_	92.9	_	73.5	_	ns

 Table 2-15
 DRAM Out-of-Page and Refresh Timings, Eleven Wait States^{1, 2} (Continued)

NI.	a	Ck - 1	. 3	66 N	ИHz	80 N	ИHz	100 N	МНz	T I 24
No.	Characteristics ⁴	Symbol	Expression ³	Min	Max	Min	Max	Min	Max	Unit
188	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ assertion	t _{WCS}	$6.5 \times T_C - 4.3$	94.2		77.0		60.7		ns
189	$\overline{\text{CAS}}$ assertion to $\overline{\text{RAS}}$ assertion (refresh)	t _{CSR}	$1.5 \times T_C - 4.0$	18.7	_	14.8	_	11.0	_	ns
190	\overline{RAS} deassertion to \overline{CAS} assertion (refresh)	t _{RPC}	$2.75 \times T_{\rm C} - 4.0$	37.7	_	30.4		23.5		ns
191	$\overline{\text{RD}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{ROH}	$11.5 \times T_{\rm C} - 4.0$	170.2	_	139.8	1	11 <mark>1</mark> .0	_	ns
192	RD assertion to data valid	t_{GA}	66 MHz : $10 \times T_{C} - 7.5$ 80 MHz :	7	144.0				_	ns
				 -		— —	118.5 —		94.3	ns ns
193	RD deassertion to data not valid ⁴	t _{GZ}		0.0	_	0.0	_	0.0	_	ns
194	WR assertion to data active		$0.75 \times T_{\rm C} - 0.3$	11.1	_	9.1	_	7.2	_	ns
195	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$	_	3.8	_	3.1	_	2.5	ns

Notes: 1. The number of wait states for out-of-page access is specified in the DCR.

- 2. The refresh period is specified in the DCR.
- 3. The asynchronous delays specified in the expressions are valid for DSP56301.
- 4. \overline{RD} deassertion will always occur after \overline{CAS} deassertion; therefore, the restricted timing is t_{OFF} and not t_{GZ} .
- i. Either t_{RCH} or t_{RRH} must be satisfied for read cycles.

 Table 2-16
 DRAM Out-of-Page and Refresh Timings, Fifteen Wait States^{1, 2}

	9	G 1.1		66 MHz		80 N	ИHz	100 MHz		T T •:
No.	Characteristics ³	Symbol	Expression	Min	Max	Min	Max	Min	Max	Unit
157	Random read or write cycle time	t _{RC}	$16 \times T_{\rm C}$	242.4	_	200.0		160.0		ns
158	RAS assertion to data valid (read)	t _{RAC}	$\begin{array}{c} \textbf{66 MHz:} \\ 8.25 \times T_C - 7.5 \\ \textbf{80 MHz:} \\ 8.25 \times T_C - 6.5 \\ \textbf{100 MHz:} \end{array}$	_	117.5	_	96.6		_	ns ns
159	CAS assertion to data valid (read)	t _{CAC}	$8.25 \times T_{C} - 5.7$ 66 MHz: $4.75 \times T_{C} - 7.5$ 80 MHz: $4.75 \times T_{C} - 6.5$ 100 MHz: $4.75 \times T_{C} - 5.7$	_ _ _ _	64.5		52.9		76.8 — — 41.8	ns ns ns
160	Column address valid to data valid (read)	t _{AA}	66 MHz: $5.5 \times T_{C} - 7.5$ 80 MHz: $5.5 \times T_{C} - 6.5$ 100 MHz: $5.5 \times T_{C} - 5.7$		75.8		- 62.3		_ _ 49.3	ns ns
161	CAS deassertion to data not valid (read hold time)	t _{OFF}	0.0	0.0	_	0.0	_	0.0	_	ns
162	RAS deassertion to RAS assertion	t _{RP}	$6.25 \times T_{C} - 4.0$	90.7	_	74.1	_	58.5	_	ns
163	RAS assertion pulse width	t _{RAS}	$9.75 \times T_{C} - 4.0$	143.7		117.9	_	93.5	_	ns
164	CAS assertion to RAS deassertion	t _{RSH}	$6.25 \times T_{\text{C}} - 4.0$	90.7	_	74.1	-	58.5		ns
165	RAS assertion to CAS deassertion	t _{CSH}	$8.25 \times T_{\text{C}} - 4.0$	121.0	_	99.1	_	78.5	_	ns
166	CAS assertion pulse width	t _{CAS}	$4.75 \times T_C - 4.0$	68.0	_	55.4	_	43.5	_	ns
167	RAS assertion to CAS assertion	t _{RCD}	$3.5 \times T_C \pm 2$	51.0	55.0	41.8	45.8	33.0	37.0	ns
168	RAS assertion to column address valid	t _{RAD}	$2.75 \times T_C \pm 2$	39.7	43.7	32.4	36.4	25.5	29.5	ns
169	CAS deassertion to RAS assertion	t _{CRP}	$7.75 \times T_{\text{C}} - 4.0$	113.4	_	92.9	_	73.5	_	ns
170	CAS deassertion pulse width	t _{CP}	$6.25 \times T_C - 4.0$	90.7	_	74.1	_	58.5	_	ns

 Table 2-16
 DRAM Out-of-Page and Refresh Timings, Fifteen Wait States^{1, 2} (Continued)

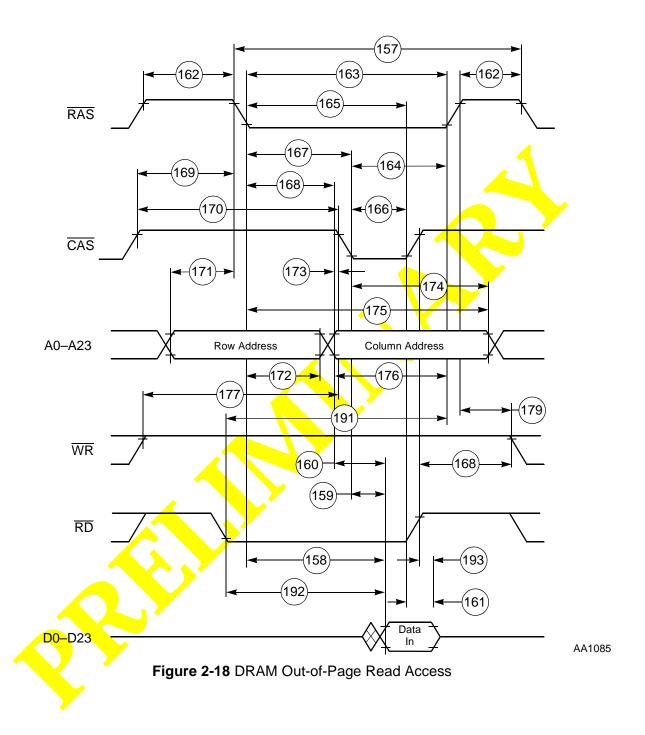
		G 1 1		66 N	ИHz	80 N	ИHz	100 I	МНz	T T 1.
No.	Characteristics ³	Symbol	Expression	Min	Max	Min	Max	Min	Max	Unit
171	Row address valid to \overline{RAS} assertion	t _{ASR}	$6.25 \times T_{\text{C}} - 4.0$	90.7	_	74.1	_	58.5	_	ns
172	RAS assertion to row address not valid	t _{RAH}	$2.75 \times T_{\text{C}} - 4.0$	37.7	_	30.4	_	23.5	_	ns
173	Column address valid to $\overline{\text{CAS}}$ assertion	t _{ASC}	$0.75 \times T_{C} - 4.0$	7.4	_	5.4		3.5		ns
174	CAS assertion to column address not valid	t _{CAH}	$6.25 \times T_{\text{C}} - 4.0$	90.7	_	74.1		5 <mark>8</mark> .5	_	ns
175	RAS assertion to column address not valid	t _{AR}	$9.75 \times T_{\text{C}} - 4.0$	143.7	7	117.9	,	93.5	_	ns
176	Column address valid to \overline{RAS} deassertion	t _{RAL}	$7 \times T_{C} - 4.0$	102.1		83.5	_	66.0		ns
177	WR deassertion to CAS assertion	t _{RCS}	$5 \times T_{\rm C} - 3.8$	72.0		58.7	_	46.2	_	ns
178	$\overline{\text{CAS}}$ deassertion to $\overline{\text{WR}}^4$ assertion	t _{RCH}	$1.75 \times T_{\rm C} - 3.7$	22.8	_	18.2	_	13.8	_	ns
179	\overline{RAS} deassertion to \overline{WR}^4 assertion	t _{RRH}	66 MHz: $0.25 \times T_{C} - 3.7$ 80 MHz :	0.1	_	_	_	_	_	ns
			$0.25 \times T_{C} - 3.0$ 100 MHz : $0.25 \times T_{C} - 2.4$	_	_	0.1	_	0.1	_	ns ns
180	CAS assertion to WR deassertion	t _{WCH}	$6 \times T_{\rm C} - 4.2$	86.7	_	70.8	_	55.8	_	ns
181	RAS assertion to WR deassertion	t _{WCR}	$9.5 \times T_C - 4.2$	139.7	_	114.6		90.8		ns
182	WR assertion pulse width	t _{WP}	$15.5 \times T_C - 4.5$	230.3		189.3		150.5	_	ns
183	WR assertion to RAS deassertion	$t_{ m RWL}$	$15.75 \times T_{\rm C} - 4.3$	234.3	_	192.6	_	153.2	_	ns
184	WR assertion to CAS deassertion	t _{CWL}	$\begin{array}{c} \textbf{66-80 MHz:} \\ \textbf{14.25} \times \textbf{T}_{\text{C}} - \textbf{4.3} \\ \textbf{100 MHz:} \\ \textbf{14.75} \times \textbf{T}_{\text{C}} - \textbf{4.3} \end{array}$	211.6	_	180.1	_	_ 143.2	_	ns ns
185	Data valid to CAS assertion (write)	t _{DS}	$8.75 \times T_{\text{C}} - 4.0$	128.6	_	105.4	_	83.5	_	ns
186	CAS assertion to data not valid (write)	t _{DH}	$6.25 \times T_{\text{C}} - 4.0$	90.7	_	74.1	_	58.5	_	ns

 Table 2-16
 DRAM Out-of-Page and Refresh Timings, Fifteen Wait States^{1, 2} (Continued)

NI-	G1 3	C	F	66 N	ИHz	80 N	ИHz	100 I	МНz	T I ! 4
No.	Characteristics ³	Symbol	Expression	Min	Max	Min	Max	Min	Max	Unit
187	RAS assertion to data not valid (write)	t _{DHR}	$9.75 \times T_C - 4.0$	143.7	_	117.9	_	93.5	_	ns
188	$\overline{\text{WR}}$ assertion to $\overline{\text{CAS}}$ assertion	t _{WCS}	$9.5 \times T_{\rm C} - 4.3$	139.6	_	114.5	_	90.7	_	ns
189	CAS assertion to RAS assertion (refresh)	t _{CSR}	$1.5 \times T_{\rm C} - 4.0$	18.7	_	14.8		11.0		ns
190	\overline{RAS} deassertion to \overline{CAS} assertion (refresh)	t _{RPC}	$4.75 \times T_{\rm C} - 4.0$	68.0		55.4		4 <mark>3</mark> .5	_	ns
191	$\overline{\text{RD}}$ assertion to $\overline{\text{RAS}}$ deassertion	t _{ROH}	$15.5 \times T_{\rm C} - 4.0$	230.8	7	189.8	7	151.0	_	ns
192	RD assertion to data valid	t _{GA}	66 MHz : $14 \times T_C - 7.5$ 80 MHz : $14 \times T_C - 6.5$ 100 MHz :		204.6 —	-	168.5			ns ns
100			$14 \times T_{\rm C} - 5.7$		_	_	_	_	134.3	ns
193	RD deassertion to data not valid ³	t _{GZ}		0.0		0.0		0.0		ns
194	WR assertion to data active		$0.75 \times T_{\rm C} - 0.3$	11.1	_	9.1		7.2	_	ns
195	WR deassertion to data high impedance		$0.25 \times T_{\rm C}$	_	3.8	_	3.1	_	2.5	ns

Notes: 1. The number of wait states for out-of-page access is specified in the DCR.

- 2. The refresh period is specified in the DCR.
- 3. $\overline{\text{RD}}$ deassertion will always occur after $\overline{\text{CAS}}$ deassertion; therefore, the restricted timing is t_{OFF} and not t_{C7} .
- 4. Either t_{RCH} or t_{RRH} must be satisfied for read cycles.



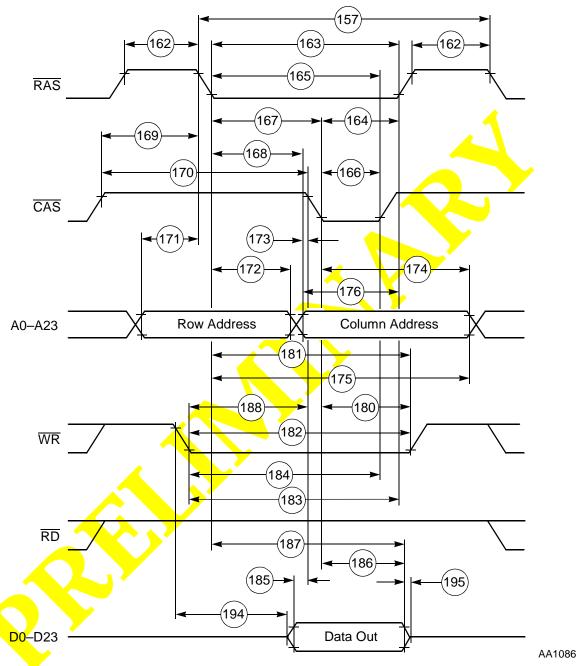


Figure 2-19 DRAM Out-of-Page Write Access

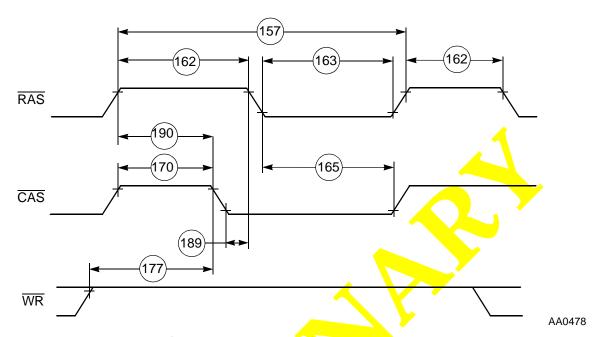


Figure 2-20 DRAM Refresh Access



Synchronous Timings (SRAM)

Table 2-17 External Bus Synchronous Timings (SRAM Access)⁴

No.	Characteristics	. 12	66 N	ИHz	80 N	ИHz	100 1	MHz	Unit
INO.	Characteristics	Expression ^{1, 2}	Min	Max	Min	Max	Min	Max	Unit
196	CLKOUT high to BS assertion	66 MHz: $0.25 \times T_C + 5.0$ 80 MHz :	4.8	8.8	_	_	1	_	ns
		$0.25 \times T_C + 4.5$ $100 \text{ MHz}:$	_	_	4.1	7.6			ns
107	CI KOLIMI I I I I I I I I I I I I I I I I I I	$0.25 \times T_{\rm C} + 4.2$	_				3.5	6.7	ns
197	CLKOUT high to BS deassertion		12.4	16.4	_	7	_	_	ns
		$0.75 \times T_C + 4.5$ 100 MHz :	1	_	10.4	13.9		11.7	ns
198	CI KOI Thigh to address and AA	$0.75 \times T_{C} + 4.2$ 66 MHz :		7	_	_	8.5	11.7	ns
196	CLKOUT high to address and AA valid ⁵	$0.25 \times T_{C} + 5.0$ 80 MHz :	_	8.8	_	_	_	_	ns
		0.25 × T _C + 4.5 100 MHz:		_	_	7.6	_	_	ns
	CLKOUT high to BL valid	$0.25 \times T_{\rm C} + 4.0$	_	5.0	_	5.0	_	6.5 5.0	ns ns
199	CLKOUT high to address and AA invalid ⁵	$0.25 \times T_{\rm C}$	3.8	_	3.1	_	2.5	_	ns
	CLKOUT high to BL invalid	, '	0.0	_	0.0	_	0.0	_	ns
200	time)		6.0	_	5.0	_	4.0		ns
201	CLKOUT high to TA invalid (hold time)		0.0	_	0.0	_	0.0	_	ns
202	CLKOU <mark>T</mark> high to data out active	$0.25 \times T_{\rm C}$	3.8		3.1	_	2.5	_	ns
203	CLKOUT high to data out valid	66 MHz : $0.25 \times T_C + 5.0$ 80 MHz :	4.8	8.8	_	_	_	_	ns
		$\begin{array}{c} \textbf{0.25} \times \textbf{T}_{C} + \textbf{4.5} \\ \textbf{100 MHz} : \end{array}$	_	_	4.1	7.6	_	_	ns
	<u> </u>	$0.25 \times T_{\text{C}} + 4.0$	_		_	_	3.3	6.5	ns
	CLKOUT high to data out invalid	$0.25 \times T_{\rm C}$	3.8		3.1	_	2.5	_	ns
205	CLKOUT high to data out high impedance		_	4.8	_	_	_	_	ns
		$\begin{array}{c} 0.25\times T_C+0.5\\ \textbf{100 MHz}: \end{array}$	_	_	_	3.6	_	_	ns
		$0.25 \times T_{\rm C}$	_	_	_	_	_	2.5	ns

Table 2-17 Ext	ternal Bus Synchronous	Timings (SRAM	Access) ⁴ (Continued)
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No.	Characteristics	. 12	66 N	ИHz	80 MHz		100 MHz		Unit
NO.	Characteristics	Expression ^{1, 2}	Min	Max	Min	Max	Min	Max	Unit
206	Data in valid to CLKOUT high (setup)		6.0	_	5.0	_	4.0		ns
207	CLKOUT high to data in invalid (hold)		0.0	_	0.0	_	0.0	_	ns
208	CLKOUT high to RD assertion	66 MHz : $0.75 \times T_C + 5.0$ 80 MHz : $0.75 \times T_C + 4.5$	12.4	16.4	10.4	13.9	1	—	ns ns
		$0.73 \times T_C + 4.3$ 100 MHz : $0.75 \times T_C + 4.0$		_	—	-	8.2	11.5	ns
209	CLKOUT high to $\overline{\text{RD}}$ deassertion		0.0	5.0	0.0	4.5	0.0	4.0	ns
210	CLKOUT high to WR assertion ³	66 MHz : $0.5 \times T_C + 5.3$ [WS = 1 or WS \geq 4]	8.9	12.9	_	_	_	_	ns
		80 MHz: $0.5 \times T_C + 4.8$ [WS = 1 or WS ≥ 4]		_	7.6	11.1	_	_	ns
		100 MHz: $0.5 \times T_C + 4.3$ [WS = 1 or WS ≥ 4]	_	_	_	_	6.3	9.3	ns
		All frequencies: $[2 \le WS \le 3]$	1.3	5.3	1.3	4.8	1.3	4.3	ns
211	CLKOUT high to WR deassertion		0.0	4.8	0.0	4.3	0.0	3.8	ns

Notes:

- 1. WS is the number of wait states specified in the BCR.
- 2. The asynchronous delays specified in the expressions are valid for DSP56301.
- 3. If $\overline{WS} > 1$, \overline{WR} assertion refers to the next rising edge of CLKOUT.
- 4. External bus synchronous timings should be used only for reference to the clock and *not* for relative timings.
- 5. T198 and T199 are valid for Address Trace mode if the ATE bit in the OMR is set. Use the status of BR (See T212) to determine whether the access referenced by A0–A23 is internal or external, when this mode is enabled.

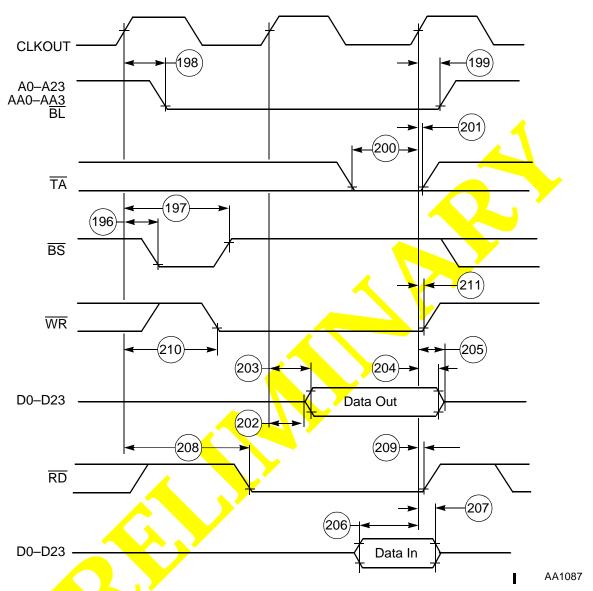


Figure 2-21 Synchronous Bus Timings SRAM 1 WS (BCR Controlled)

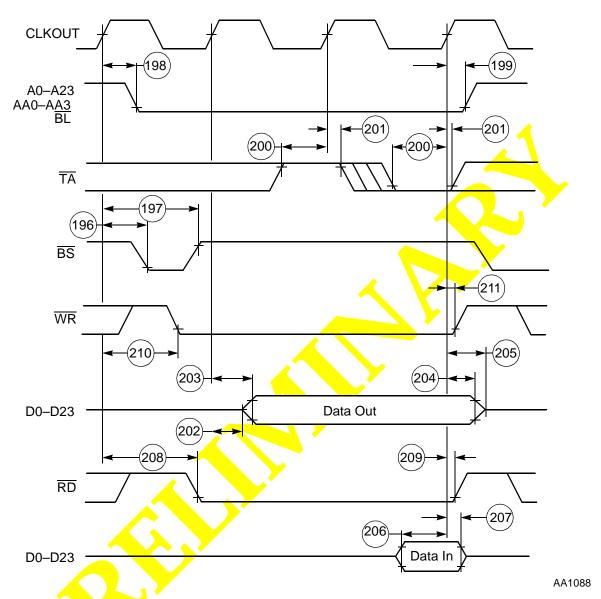


Figure 2-22 Synchronous Bus Timings SRAM 2 WS (TA Controlled)

Arbitration Timings

 $\textbf{Table 2-18} \ \ \, \text{Arbitration Bus Timings}^{1}$

NT-	Characteristics	E	66 N	ИHz	80 N	ИHz	100 I	MHz	Unit
No.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
212	CLKOUT high to \overline{BR} assertion/deassertion ²		1.0	5.0	1.0	4.5	1.0	4.0	ns
213	BG asserted/deasserted to CLKOUT high (setup)		6.0		5.0	۱ <mark>۰</mark>	4.0		ns
214	CLKOUT high to \overline{BG} deasserted/asserted (hold)		0.0		0.0	1/	0.0	_	ns
215	BB deassertion to CLKOUT high (input setup)		6.0	1	5.0	7	4.0	_	ns
216	CLKOUT high to \overline{BB} assertion (input hold)		0.0	1	0.0	_	0.0	_	ns
217	CLKOUT high to \overline{BB} assertion (output)		1.0	5.0	1.0	4.5	1.0	4.0	ns
218	CLKOUT high to \overline{BB} deassertion (output)		1.0	5.0	1.0	4.5	1.0	4.0	ns
219	\overline{BB} high to \overline{BB} high impedance (output)		_	6.8	_	5.6	_	4.5	ns
220	CLKOUT high to address and controls active	$0.25 \times T_{\rm C}$	3.8	_	3.1	_	2.5	_	ns
221	CLKOUT high to address and controls high impedance	66 MHz : 0 :25 × T _C + 1.0 80 MHz :	_	4.8		_	_	_	ns
		$\begin{array}{c} 0.25 \times T_{C} + 0.5 \\ \textbf{100 MHz} \\ 0.25 \times T_{C} \end{array}$	_	_	_	3.6	_	2.5	ns ns
222	CLKOUT high to AA active	$0.25 \times T_{\rm C}$ $0.25 \times T_{\rm C}$	3.8	_	3.1	_	2.5	~.u	ns
223	CLKOUT high to AA deassertion	66 MHz : $0.25 \times T_C + 5.0$ 80 MHz :	4.8	8.8	_	_	_	_	ns
•		$0.25 \times T_C + 4.5$ 100 MHz :	_	_	4.1	7.6	_	_	ns
		$0.25 \times T_{\rm C} + 4.0$	_	_	_	_	3.2	6.5	ns
224	CLKOUT high to AA high impedance	66 MHz : $0.75 \times T_C + 1.0$ 80 MHz :	_	12.4	_	_	_	_	ns
		$0.75 \times T_{C} + 0.5$ 100 MHz :	_	_	_	9.9	_	_	ns
		$0.75 \times T_{\rm C}$		_	_			7.5	ns

Notes: 1. The asynchronous delays specified in the expressions are valid for DSP56301.

2. T212 is valid for Address Trace mode when the ATE bit in the OMR is set. \overline{BR} is deasserted for internal accesses and asserted for external accesses.

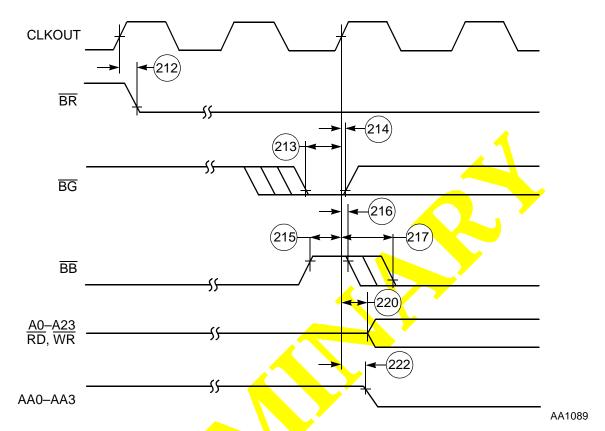


Figure 2-23 Bus Acquisition Timings

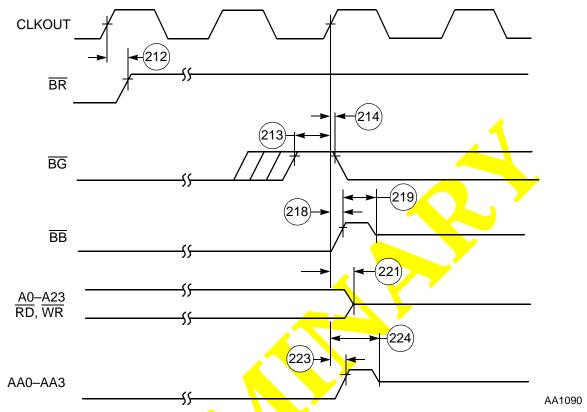


Figure 2-24 Bus Release Timings Case 1 (BRT Bit in OMR Cleared)



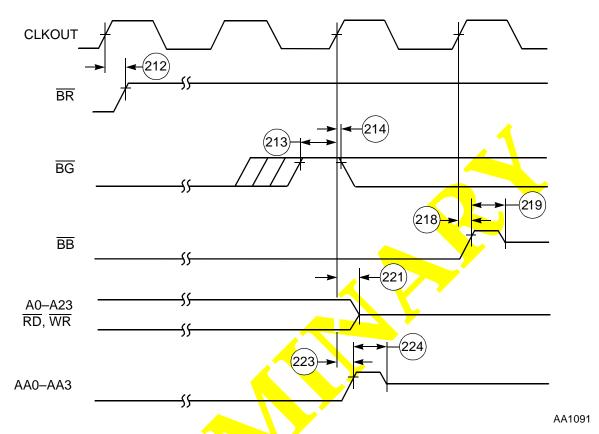


Figure 2-25 Bus Release Timings Case 2 (BRT Bit in OMR Set)



HOST INTERFACE TIMING

 $\textbf{Table 2-19} \quad \textbf{Universal Bus Mode Timing Parameters}$

NT	Characteristic	Г	66 N	ИHz	80 N	ИHz	100 MHz		Unit
No.	Characteristic	Expression	Min	Max	Min	Max	Min	Max	Unit
300	Access Cycle Time	$3 \times T_{C}$	45.5	_	37.5		30.0	_	
301	HA[10:0], HAEN Setup to Data Strobe Assertion ¹		7.0	_	5.8	4	4.6	=	ns
302	HA[10:0], HAEN Valid Hold from Data Strobe Deassertion ¹		0.0	_	0.0	156	0.0		ns
303	HRW Setup to HDS Assertion ²		7.0	1	5.8	1	4.6	_	ns
304	HRW Valid Hold from HDS Deassertion ²		0.0	1	0.0		0.0		ns
305	Data Strobe Deasserted Width ¹		5.0	_	4.1	_	3.3		ns
306	Data Strobe Asserted Pulse Width ¹	$2.5 \times T_{\rm C} + 2.0^{-9}$	39.9		32.9		26.3	_	ns
307	HBS Asserted Pulse Width		3.0		2.5	_	2.0		
308	HBS Assertion to Data Strobe Assertion ¹	$T_{\rm C} - 6.0^{9}$		9.2	_	7.6	_	6.0	ns
309	HBS Assertion to Data Strobe Deassertion ¹	$2.5 \times T_{C} + 3.5^{9}$	41.4	_	34.1	_	27.3	_	
310	HBS Deassertion to Data Strobe Deassertion ¹	$1.5 \times T_{\rm C} + 4.0^{9}$	26.7	_	22.1	_	17.6	_	
311	Data Out Valid to TA Assertion (HBS Not Used—Tied to V _{CC}) ²	$2 \times T_{\rm C} - 14.0$	16.3	_	11.0	_	6.0	_	ns
312	Data Out Active from Read Data Strobe Assertion ³		2.0	_	1.7	_	1.3	_	ns
313	Data O <mark>ut</mark> Vali <mark>d</mark> from Read Data Strobe Assertion (No Wait States Inserted—HTA Asserted) ³		_	21.0	_	18.9	_	16.9	ns
314	Data Out Valid Hold from Read Data Strobe Deassertion3		2.0	_	1.7		1.3	_	ns
315	Data Out High Impedance from Read Data Strobe Deassertion ³		_	14.5	_	12.0	_	9.6	ns
316	Data In Valid Setup to Write Data Strobe Deassertion ⁴		10.0	_	8.3	_	6.6	_	ns
317	Data In Valid Hold from Write Data Strobe Deassertion ⁴		0.0	_	0.0	_	0.0	_	ns

 Table 2-19 Universal Bus Mode Timing Parameters (Continued)

.	Characteristic		66 N	ИHz	80 N	ИHz	100 1	MHz	Unit
No.	Characteristic	Expression	Min	Max	Min	Max	Min	Max	Unit
318	HSAK Assertion from Data Strobe Assertion ¹		_	25.0	_	22.2	_	19.6	ns
319	HSAK Asserted Hold from Data Strobe Deassertion ¹		2.0	_	1.7	_	1.3	_	ns
320	HTA Active from Data Strobe Assertion ^{1,2,5}		3.8	_	3.1		2.5		ns
321	HTA Assertion from Data Strobe Assertion (\overline{HBS} Not Used—Tied to V_{CC}) ^{1,2,5}	$2.0 \times T_{\rm C}$ + 13.8 9	44.1	_	37.8		31.8	_	
322	HTA Assertion from HBS Assertion ^{2,5}	$2.0 \times T_{\rm C}$ + 13.8 ⁹	44.1	+	37.8		31.8		ns
323	HTA Deasserted from Data Strobe Assertion ^{1,2,5}			26.7	_	23.6	_	20.7	ns
324	HTA Assertion to Data Strobe Deassertion ^{1,2}		0.0)I	0.0	_	0.0	_	ns
325	HTA High Impedance from Data Strobe Deassertion ^{1,2}			18.5	_	15.3	_	12.2	ns
326	HIRQ Asserted Pulse Width (HIRH = 0, HIRD = 1)	$\frac{(LT + 1) \times T_C}{6.0^7} -$	9.2	_	6.5	_	4.0	_	ns
327	Data Strobe Deasserted Hold from HIRQ Deassertion (HIRH = 0) ¹		0.0	_	0.0	_	0.0	_	ns
328	HIRQ Asserted Hold from Data Strobe Assertion (HIRH = 1)1	$1.5 \times T_{\rm C}$	22.7	_	18.8	_	15.0	_	ns
329	HIRQ Deassertion from Data Strobe Assertion (HIRH = 1, HIRD = 1) ¹	$2.5 \times T_{C} + 28.0^{9}$	_	65.9	_	55.9	_	46.5	ns
330	HIRQ High Impedance from Data Strobe Assertion (HIRH = 1, HIRD = 0) ^{1,6}	$2.5 \times T_{C} + 28.0^{9}$		65.9		55.9	_	46.5	ns
331	HIRQ Active from Data Strobe Deassertion (HIRH = 1, HIRD = 0) ¹	$2.5 \times T_{\rm C}$	37.9	_	31.3	_	25.0	_	ns
332	HIRQ Deasserted Hold from Data Strobe Deassertion ¹	$2.5 \times T_{\rm C}$	37.9	_	31.3	_	25.0	_	ns
333	HDRQ ² Asserted Hold from Data Strobe Assertion ¹	$1.5 \times T_{\rm C}$	22.7	_	18.8	_	15.0	_	ns
334	HDRQ^2 Deassertion from Data Strobe Assertion 1	$2.5 \times T_{\rm C} + 28.0^{9}$	_	65.9	_	55.9	_	46.5	ns

Table 2-19 Universal Bus Mode Timing Parameters (Continued)

NI-	Characterist's	F	66 N	ИHz	80 N	ИHz	100	MHz	Unit
No.	Characteristic	Expression	Min	Max	Min	Max	Min	Max	Unit
335	HDRQ ² Deasserted Hold from Data Strobe Deassertion ¹	$2.5 \times T_{\rm C} + 4.5^{9}$	42.4	_	35.0		28.0	_	ns
336	HDAK Assertion to Data Strobe Assertion ¹		7.0	_	5.8	_	4.6	_	ns
337	HDAK Asserted Hold from Data Strobe Deassertion ¹		0.0	_	0.0	ا ا	0.0		ns
338	HDBEN Deasserted Hold from Data Strobe Assertion ¹		3.0	_	2.5	16	2.0	_	ns
339	HDBEN Assertion from Data Strobe Assertion ¹		_	25.0		22.2	_	19.6	ns
340	HDBEN Asserted Hold from Data Strobe Deassertion ¹		3.0	-	2.5		2.0	_	ns
341	HDBEN Deassertion from Data Strobe Deassertion ¹		1	25.0		22.2	_	19.6	ns
342	HDBDR High Hold from Read Data Strobe Assertion ³		3.0	_	2.5	_	2.0	_	ns
343	HDBDR Low from Read Data Strobe Assertion ³		_	25.0	_	22.2	_	19.6	ns
344	HDBDR Low Hold from Read Data Strobe Deassertion ³		3.0	_	2.5	_	2.0	_	ns
345	HDBDR High from Read Data Strobe Deassertion ³		_	25.0	_	22.2	_	19.6	ns
346	HRST Assertion to Host Port Pins High Impedance ²		_	25.0	_	22.2	_	19.6	ns

Notes: 1. The Data Strobe is HRD or HWR in the Dual Data Strobe mode and HDS in the Single Data Strobe

- 2. HTA, HDRQ, and HRST may be programmed as active-high or active-low. In the example timing diagrams, HDRQ and HRST are shown as active-high and HTA is shown as active low.
- 3. The Read Data Strobe is HRD in the Dual Data Strobe mode and HDS in the Single Data Strobe mode.
- 4. The Write Data Strobe is HWR in the Dual Data Strobe mode and HDS in the Single Data Strobe mode.
- 5. HTA requires an external pull-down resistor if programmed as active high (HTAP = 0); or an external pull-up resistor if programmed as active low (HTAP = 1). The resistor value should be consistent with the DC specifications.
- 6. HIRQ requires an external pull-up resistor if programmed as open drain (HIRD = 0). The resistor value should be consistent with the DC specifications.
- 7. "LT" is the value of the latency timer register (CLAT) as programmed by the user during self configuration.
- 8. Values are valid for $V_{CC} = 3.3 \pm 0.3 V$
- 9. The Asynchronous delay in this expression is valid only for the 66MHz DSP56301/D (DSP56301PW66 or DSP56301GC66).



 Table 2-20
 Universal Bus Mode, Synchronous Port A Type Host Timing

	Table 2-20 Universal bus M	V		ИHz		ИHz		MHz	Unit
No.	Characteristic	Expression	Min	Max	Min	Max	Min	Max	Unit
300	Access Cycle Time	$3 \times T_{C}$	45.5	_	37.5	_	30.0	_	
301	HA[10:0], HAEN Setup to Data Strobe Assertion ¹		7.0	_	5.8	_	4.6	_	ns
302	HA[10:0], HAEN Valid Hold from Data Strobe Deassertion ¹		0.0	_	0.0		0.0	_	ns
305	Data Strobe Deasserted Width ¹		5.0	_	4.1	-	3.3		ns
307	HBS Asserted Pulse Width		3.0	_	2.5	-	2.0	_	
308	HBS Assertion to Data Strobe Assertion ¹	$T_{\rm C} - 6.0^{9}$	_	9.2	-	7.6	-	6.0	ns
309	HBS Assertion to Data Strobe Deassertion ¹	$2.5 \times T_C + 3.5^{9}$	41.4	T	34.1		27.3		
310	HBS Deassertion to Data Strobe Deassertion ¹	$1.5 \times T_{\rm C} + 4.0^{-9}$	26.7		22.1		17.6		
312	Data Out Active from Read Data Strobe Assertion ³		2.0	_	1.7	_	1.3	_	ns
313	Data Out Valid from Read Data Strobe Assertion (No Wait States Inserted—HTA Asserted) ³		_	21.0	_	18.9	_	16.9	ns
314	Data Out Valid Hold from Read Data Strobe Deassertion ₃		2.0	_	1.7	_	1.3	_	ns
315	Data Out High Imped <mark>ance</mark> from Read Data Strobe Deassertion ³		_	14.5	_	12.0	_	9.6	ns
316	Data In Valid S <mark>etup to Write Dat</mark> a Strobe Deassertion ⁴		10.0	_	8.3	_	6.6	_	ns
317	Data In <mark>V</mark> alid <mark>H</mark> old from Write Data Strobe <mark>Deassertion⁴</mark>		0.0	_	0.0	_	0.0	_	ns
324	HTA Assertion to Data Strobe Deassertion ^{1,2}		0.0	_	0.0	_	0.0	_	ns
325	HTA High Impedance from Data Strobe Deassertion ^{1,2}		_	18.5	_	15.3	_	12.2	ns
326	HIRQ Asserted Pulse Width (HIRH = 0, HIRD = 1)	$(LT + 1) \times T_C - 6.0^7$	9.2	_	6.5	_	4.0	_	ns
327	Data Strobe Deasserted Hold from \overline{HIRQ} Deassertion (HIRH = 0) ¹		0.0	_	0.0	_	0.0	_	ns
328	HIRQ Asserted Hold from Data Strobe Assertion (HIRH = 1) ¹	$1.5 \times T_{\rm C}$	22.7	_	18.8	_	15.0	_	ns

Nic	Characteristic	Expression	66 N	ИHz	80 N	ИHz	100 MHz		Unit
No.	Characteristic	_	Min	Max	Min	Max	Min	Max	Om
329	$\overline{\text{HIRQ}}$ Deassertion from Data Strobe Assertion (HIRH = 1, HIRD = 1) ¹	$2.5 \times T_{\rm C} + 28.0^{9}$	_	65.9	_	55.9	_	46.5	ns
330	HIRQ High Impedance from Data Strobe Assertion (HIRH = 1, HIRD = 0) ^{1,6}	$2.5 \times T_{C} + 28.0^{9}$	Ī	65.9	_	55.9		46.5	ns
331	$\overline{\text{HIRQ}}$ Active from Data Strobe Deassertion (HIRH = 1, HIRD = 0) ¹	$2.5 \times T_{\rm C}$	37.9		31.3	ا 🜔	25.0	1	ns
332	HIRQ Deasserted Hold from Data Strobe Deassertion ¹	$2.5 \times T_{\rm C}$	37.9	_	31.3	1	25.0	_	ns
346	HRST Assertion to Host Port Pins High Impedance ²		_	25.0		22.2	_	19.6	ns
347	HBS Assertion to CLKOUT Rising Edge		5.2	-	4.3	_	3.4	_	ns
348	Data Strobe Deassertion to CLKOUT Rising Edge ¹		9.0		7.4	_	5.9	_	ns

Notes:

- 1. The Data Strobe is HRD or HWR in the Dual Data Strobe mode and HDS in the Single Data Strobe
- 2. HTA, HDRQ, and HRST may be programmed as active-high or active-low. In the example timing diagrams, HDRQ and HRST are shown as active-high and HTA is shown as active low.
- 3. The Read Data Strobe is HRD in the Dual Data Strobe mode and HDS in the Single Data Strobe mode.
- 4. The Write Data Strobe is HWR in the Dual Data Strobe mode and HDS in the Single Data Strobe mode.
- 5. HTA requires an external pull-down resistor if programmed as active high (HTAP = 0); or an external pull-up resistor if programmed as active low (HTAP = 1). The resistor value should be consistent with the DC specifications.
- 6. HIRQ requires an external pull-up resistor if programmed as open drain (HIRD = 0). The resistor value should be consistent with the DC specifications.
- 7. "LT" is the value of the latency timer register (CLAT) as programmed by the user during self configuration.
- 8. Values are valid for $V_{CC} = 3.3 \pm 0.3V$
- 9. The Asynchronous delay in this expression is valid only for the 66MHz DSP56301/D (DSP56301PW66 or DSP56301GC66).

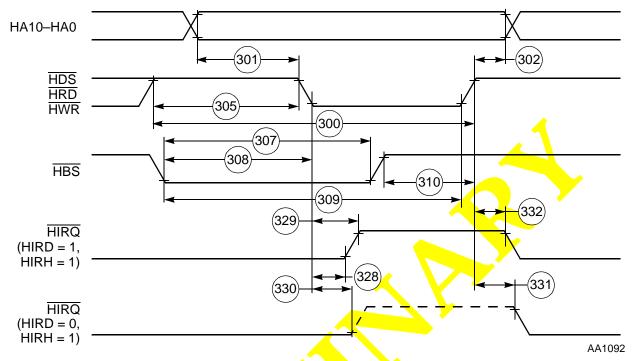
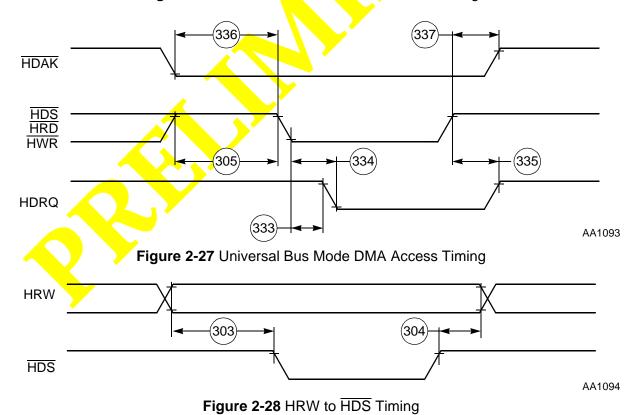
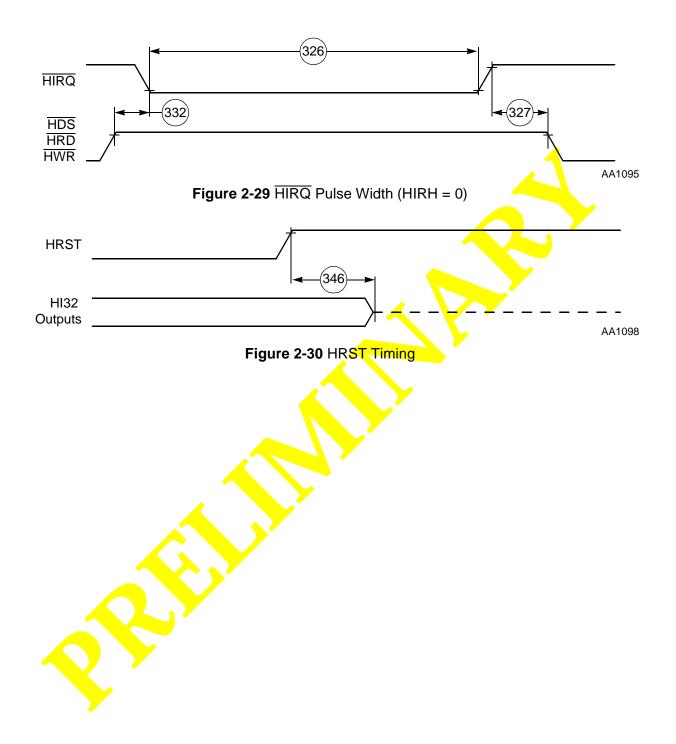
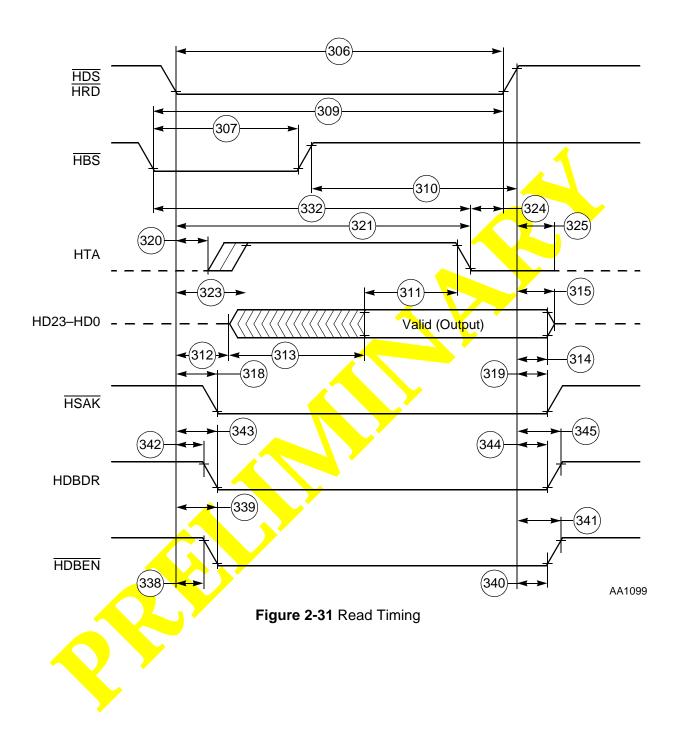


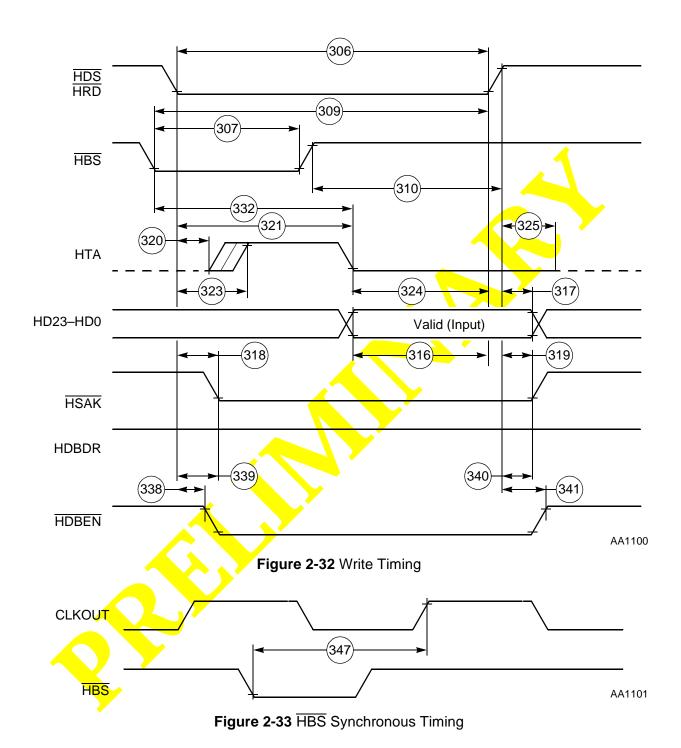
Figure 2-26 Universal Bus Mode I/O Access Timing



Preliminary Data







Preliminary Data

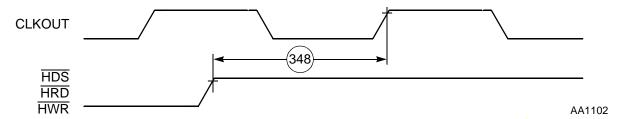


Figure 2-34 Data Strobe Synchronous Timing

Table 2-21 PCI Mode Timing Parameters¹

No.	CI 10	Cumbal	66 M	IHz	80 M	Hz	100 N	ИHz	Unit
INO.	Characteristic ¹⁰	Symbol	Min	Max	Min	Max	Min	Max	Omt
349	HCLK to Signal Valid Delay—Bussed Signals	t _{VAL}	2.0	11.0	2.0	11.0	2.0	11.0	ns
350	HCLK to Signal Valid Delay—Point to Point	t _{VAL(ptp)}	2.0	12.0	2.0	12.0	2.0	12.0	ns
351	Float to Active Delay	t _{ON}	2.0	_	2.0	_	2.0	_	ns
352	Active to Float Delay	t _{OFF}	-	28.0	_	28.0		28.0	ns
353	Input Set Up Time to HCLK—Bussed Signals	t _{SU}	7.0	_	7.0	_	7.0	_	ns
354	Input Set Up Time to HCLK—Point to Point	t _{SU(ptp)}	10.0, 12.0	_	10.0, 12.0	_	10.0, 12.0	_	ns
355	Input Hold Time from HCLK	t _H	0.0	_	0.0	_	0.0	_	ns
356	Reset Active Time After Power Stable	t _{RST}	1.0	_	1.0	_	1.0	_	ms
357	Reset Active Time After HCLK Stable	t _{RST-CLK}	100.0	_	100.0	_	100.0	_	μs
358	Reset Active to Output Float Delay	t _{RST-OFF}	_	40.0	_	40.0	_	40.0	ns
359	HCLK Cycle Time	t _{CYC}	30.0	_	30.0	_	30.0	_	ns
360	HCLK High Time	t _{HIGH}	12.0	_	11.0		11.0		ns
361	HCLK Low Time	t _{LOW}	12.0	_	11.0	_	11.0		ns

Notes: 1. For standard PCI timing, see the PCI Local Bus Specification, Rev. 2.0, especially Chapters 3 and 4.

3. HGNT has a setup time of 10 ns. HREQ has a setup time of 12 ns.

^{2.} The HI32 supports these timings for a PCI bus operating at 33 MHz for a DSP clock frequency of 56 MHz and above. The DSP core operating frequency should be greater than 5/3 of the PCI bus frequency to maintain proper PCI operation.

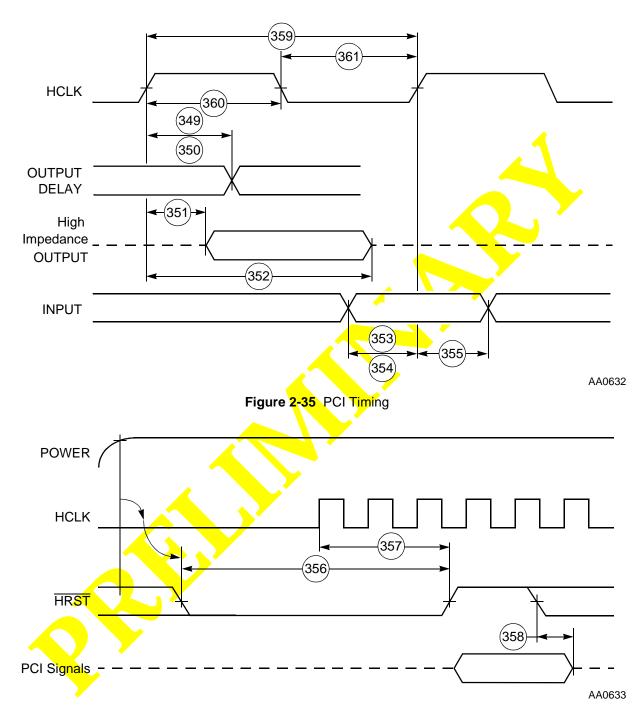


Figure 2-36 PCI Reset Timing

SCI TIMING

Table 2-22 SCI Timing

NI -	a 1	C	E	66 N	ſНz	80 N	ИНz	Hz 100 MI		T 1 24
No.	Characteristics ¹	Symbol	Expression	Min	Max	Min	Max	Min	Max	Unit
400	Synchronous clock cycle	t _{SCC} ²	$8 \times T_{C}$	121.0		100.0		80.0		ns
401	Clock low period		$t_{SCC}/2 - 10.0$	50.5	_	40.0		30.0		ns
402	Clock high period		$t_{SCC}/2-10.0$	50.5	_	40.0	\downarrow	3 <mark>0</mark> .0		ns
403	Output data setup to clock falling edge (internal clock)		$t_{SCC}/4 + 0.5 \times T_C - 17.0$	20.5	16	14.3	4	8.0	ı	ns
404	Output data hold after clock rising edge (internal clock)		$t_{SCC}/4 - 0.5 \times T_C$	22.5	1	18.8		15.0		ns
405	Input data setup time before clock rising edge (internal clock)		$t_{SCC}/4 + 0.5 \times T_C + 25.0$	63.0) l	56.3		50.0		ns
406	Input data not valid before clock rising edge (internal clock)	•	$t_{SCC}/4 + 0.5 \times T_C - 5.5$	_	32.0	_	25.8	_	19.5	ns
407	Clock falling edge to output data valid (external clock)			_	32.0	_	32.0	_	32.0	ns
408	Output data hold after clock rising edge (external clock)		$T_C + 8.0$	23.0	_	20.5	_	18.0	_	ns
409	Input data setup time before clock rising edge (external clock)	>		0.0		0.0		0.0		ns
410	Inp <mark>ut da</mark> ta hold time after clock rising edge (external clock)			9.0		9.0		9.0	_	ns
411	Asynchronous clock cycle	t _{ACC} ³	$64 \times T_{\rm C}$	969.7	_	800.0	_	640.0	_	ns
412	Clock low period		$t_{\rm ACC}/2-10.0$	474.8	_	390.0	_	310.0	_	ns
413	Clock high period		$t_{\rm ACC}/2-10.0$	474.8	_	390.0	_	310.0	_	ns

Table 2-22 SCI Timing (Continued)

Nic	Characteristics ¹	Symbol	Expression	66 MHz		80 MHz		100 MHz		T I *4
No.	Characteristics 1	Symbol	Expression	Min	Max	Min	Max	Min	Max	Unit
	Output data setup to clock rising edge (internal clock)		$t_{\rm ACC}/2-30.0$	458.8	_	370.0	_	290.0	_	ns
	Output data hold afterclockrisingedge (internal clock)		$t_{\rm ACC}/2-30.0$	458.8	_	370.0	7	290.0	-	ns

- Notes: 1. $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$; $T_J = -40^{\circ}\text{C}$ to $+100^{\circ}\text{C}$, $C_L = 50 \text{ pF} + 2 \text{ TTL Loads}$ 2. $t_{SCC} = \text{synchronous clock cycle time (For internal clock, } t_{SCC}$ is determined by the SCI clock control
 - t_{ACC} = asynchronous clock cycle time; value given for 1X Clock mode (For internal clock, t_{ACC} is determined by the SCI clock control register and T_C)



SCI Timing

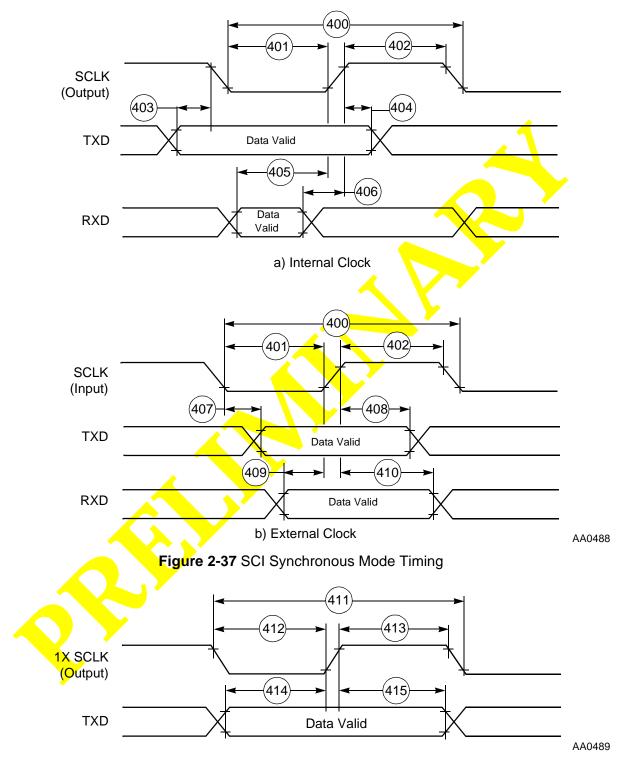


Figure 2-38 SCI Asynchronous Mode Timing

ESSIO/ESSI1 TIMING

 Table 2-23
 ESSI Timings

D.T.		G 1 1		66 MHz		80 N	ИHz	100 l	MHz	Cond-	T T •.
No.	Characteristics ^{4, 6, 7}	Symbol	Expression	Min	Max	Min	Max	Min	Max	ition ⁵	Unit
430	Clock cycle ¹	t _{SSICC}	$4 \times T_{C}$ $3 \times T_{C}$	60.6 45.5	_	50.0 37.5		40.0 30.0	LI	i ck x ck	ns
431	Clock high period For internal clock For external clock		$2 \times T_{\text{C}} - 10.0$ $1.5 \times T_{\text{C}}$	20.3 22.7		15.0 18.8	1	10.0 15.0	17	>	ns ns
432	Clock low period For internal clock For external clock		$2 \times T_C - 10.0$ $1.5 \times T_C$	20.3 22.7	_ /	15.0 18.8	1	10.0 15.0			ns ns
433	RXC rising edge to FSR out (bl) high				37.0 22.0	1]	37.0 22.0		37.0 22.0	x ck i ck a	ns
434	RXC rising edge to FSR out (bl) low			1	37.0 22.0	1	37.0 22.0		37.0 22.0	x ck i ck a	ns
435	RXC rising edge to FSR out (wr) high ²			1	39.0 24.0	_	39.0 24.0		39.0 24.0	x ck i ck a	ns
436	RXC rising edge to FSR out (wr) low ²				39.0 24.0	_	39.0 24.0		39.0 24.0	x ck i ck a	ns
437	RXC rising edge to FSR out (wl) high			_	36.0 21.0	_	36.0 21.0		36.0 21.0	x ck i ck a	ns
438	RXC rising edge to FSR out (wl) low			_	37.0 22.0	_	37.0 22.0		37.0 22.0	x ck i ck a	ns
439	Data in setup time before RXC (SCK in Synchronous mode) falling edge			0.0 19.0	_	0.0 19.0		0.0 19.0	_	x ck i ck	ns
440	Data in hold time after <mark>RX</mark> C falling edge			5.0 3.0	_ _	5.0 3.0		5.0 3.0	<u> </u>	x ck i ck	ns
441	FSR input (bl, wr) high before RXC falling edge ²			23.0 1.0	_	23.0 1.0		23.0 1.0	_	x ck i ck a	ns
442	FSR input (wl) high before RXC falling edge			23.0 1.0	_	23.0 1.0		23.0 1.0	_	x ck i ck a	ns
443	FSR input hold time after RXC falling edge			3.0 0.0	_	3.0 0.0		3.0 0.0	_	x ck i ck a	ns
444	Flags input setup before RXC falling edge			0.0 19.0	_	0.0 19.0		0.0 19.0	_	x ck i ck s	ns

 Table 2-23
 ESSI Timings (Continued)

				66 N	ИHz	80 N	ИНz	100 MHz		Cond-	
No.	Characteristics ^{4, 6, 7}	Symbol	Expression	Min	Max	Min	Max	Min	Max	ition ⁵	Unit
445	Flags input hold time after RXC falling edge			6.0 0.0	_	6.0 0.0	_	6.0 0.0	_	x ck i ck s	ns
446	TXC rising edge to FST out (bl) high			_ _	29.0 15.0	_	29.0 15.0	_ 	29.0 15.0	x ck i ck	ns
447	TXC rising edge to FST out (bl) low			_ _	31.0 17.0	_	31.0 17.0		31.0 17.0	x ck i ck	ns
448	TXC rising edge to FST out (wr) high ²			_ _	31.0 17.0	_	31.0 17.0	141	31.0 17.0	x ck i ck	ns
449	TXC rising edge to FST out (wr) low ²			_	33.0 19.0	7	33.0 19.0	14	33.0 19.0	x ck i ck	ns
450	TXC rising edge to FST out (wl) high			_	30.0 16.0		30.0 16.0	_ _	30.0 16.0	x ck i ck	ns
451	TXC rising edge to FST out (wl) low			1	31.0 17.0	1	31.0 17.0		31.0 17.0	x ck i ck	ns
452	TXC rising edge to data out enable from high impedance			1	31.0 17.0	_	31.0 17.0		31.0 17.0	x ck i ck	ns
453	TXC rising edge to Transmitter #0 drive enable assertion			_ _	34.0 20.0	_	34.0 20.0	_	34.0 20.0	x ck i ck	ns
454	TXC rising edge to data out valid		$35 + 0.5 \times T_{C}$ 21.0	_	42.6 21.0	_	41.3 21.0	_	40.0 21.0	x ck i ck	ns
455	TXC rising edge to data out high impedance ³			_	31.0 16.0	_	31.0 16.0	_	31.0 16.0	x ck i ck	ns
456	TXC rising edge to Transmitter #0 drive enable deassertion ³			_	34.0 20.0	_	34.0 20.0	_	34.0 20.0	x ck i ck	ns
457	FST input (bl, wr) setup time before TXC falling edge ²			2.0 21.0	_	2.0 21.0	_	2.0 21.0	_	x ck i ck	ns
458	FST input (wl) to data out enable from high impedance			_	27.0	_	27.0	_	27.0	_	ns
459	FST input (wl) to Transmitter #0 drive enable assertion			_	31.0	_	31.0	_	31.0	_	ns

Table 2-23 ESSI Timings (Continued)

No.	Characteristics ^{4, 6, 7}	Cumbal	Expression -	66 MHz		80 MHz		z 100 MHz		Cond-	Unit
NO.	Cnaracteristics 3, 3, 7	Symbol	Expression	Min	Max	Min	Max	Min	Max	ition ⁵	Om
460	FST input (wl) setup time before TXC falling edge			2.0 21.0	_	2.0 21.0	<u>-</u>	2.0 21.0	_	x ck i ck	ns
461	FST input hold time after TXC falling edge			4.0 0.0	_	4.0 0.0	_	4.0 0.0	_	x ck i ck	ns
462	Flag output valid after TXC rising edge			_	32.0 18.0	_	32.0 18.0	7	32.0 18.0	x ck i ck	ns

Notes:

- For the internal clock, the external clock cycle is defined by Icyc and the ESSI control register.
- 2. The word-relative frame sync signal waveform relative to the clock operates in the same manner as the bit-length frame sync signal waveform, but spreads from one serial clock before first bit clock (same as Bit Length Frame Sync signal), until the one before last bit clock of the first word in frame.
- 3. Periodically sampled and not 100% tested
- 4. $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$; $T_J = -40 ^{\circ}\text{C}$ to $+100 ^{\circ}\text{C}$, $C_L = 50 \text{ pF} + 2 \text{ TTL Loads}$
- 5. TXC (SCK Pin) = Transmit Clock

 RXC (SC0 or SCK Pin) = Receive Clock

 FST (SC2 Pin) = Transmit Frame Sync

 FSR (SC1 or SC2 Pin) Receive Frame Sync
- 6. i ck = Internal Clock
 - x ck = External Clock
 - i ck a = Internal Clock, Asynchronous mode

(Asynchronous implies that TXC and RXC are two different clocks)

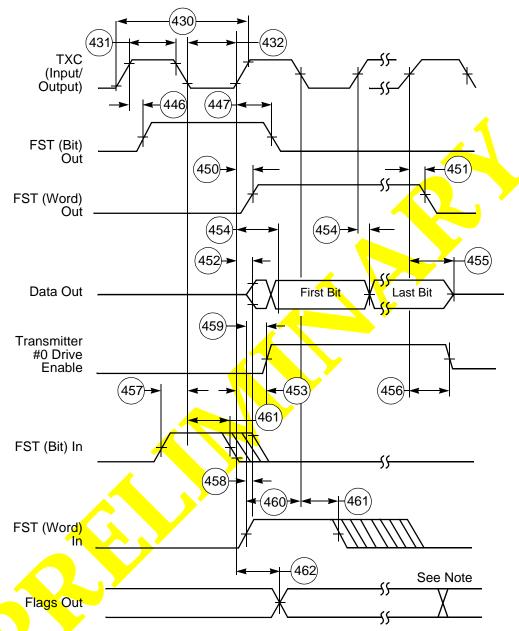
i ck s = Internal Clock, Synchronous mode

(Synchronous implies that TXC and RXC are the same clock)

- 7. bl = bit length
 - wl = word length
 - wr = word length relative



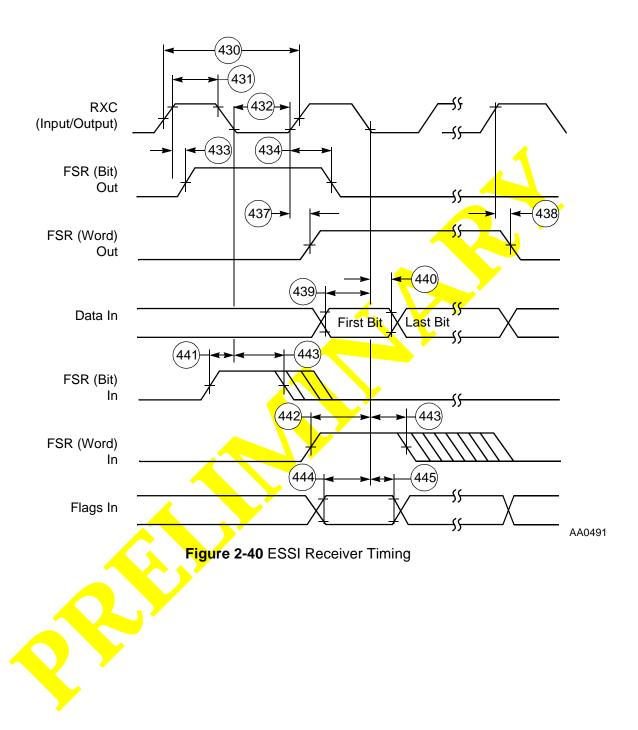
ESSI0/ESSI1 Timing



Note: 1. In Network mode, output flag transitions can occur at the start of each time slot within the frame. In Normal mode, the output flag state is asserted for the entire frame period.

AA0490

Figure 2-39 ESSI Transmitter Timing



TIMER TIMING

Table 2-24 Timer Timing

NI		г.	66 N	ИHz	80 N	1Hz	100 N	МНz	T T •4
No.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
480	TIO Low	$2 \times T_C + 2.0$	32.5	_	27.0	_	22.0	_	ns
481	TIO High	$2 \times T_{\rm C} + 2.0$	32.5	_	27.0		22.0	_	ns
482	Timer setup time from TIO (Input) assertion to CLKOUT rising edge		9.0	15.15	9.0	12.5	9.0	10.0	ns
483	Synchronous timer delay time from CLKOUT rising edge to the external memory access address out valid caused by first interrupt instruction execution	$10.25 \times T_{\rm C} + 1.0$	156.0		129.1		103.5		ns
484	CLKOUT rising edge to TIO (Output) assertion • Minimum • Maximum	$0.5 \times T_{C} + 3.5$ $0.5 \times T_{C} + 19.8$	11.1		9.8	<u> </u>	8.5		ns ns
485	CLKOUT rising edge to TIO (Output) deassertion • Minimum • Maximum	$60.5 \times T_{C} + 3.5$ 66-80 MHz: $0.5 \times T_{C} + 19.8$ 100 MHz: $0.5 \times T_{C} + 19.0$	11.1 —	_ 28.1 _	9.8	_ 26.1 _	8.5	_ _ _ 24.8	ns ns

TIO 480 AA0492

Figure 2-41 TIO Timer Event Input Restrictions

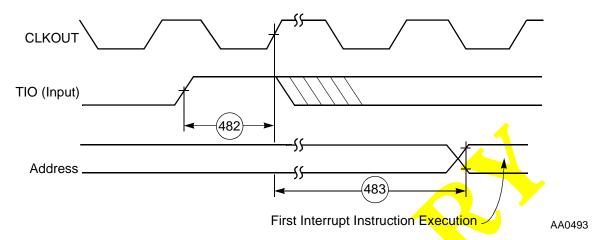


Figure 2-42 Timer Interrupt Generation

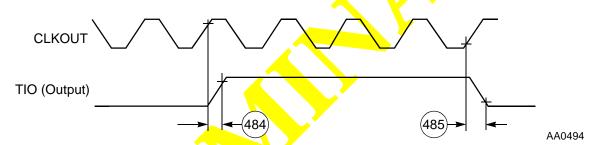


Figure 2-43 External Pulse Generation



GPIO TIMING

Table 2-25 GPIO Timing

Nic	Characteristics	Eumagaign	66 MHz		80 MHz		100 l	MHz	Unit
No.	Characteristics	Expression	Min	Max	Min	Max	Min	Max	Unit
490	CLKOUT edge to GPIO out valid (GPIO out delay time)		_	31.0	_	31.0		31.0	ns
491	CLKOUT edge to GPIO out not valid (GPIO out hold time)		3.0	_	3.0		3.0		ns
492	GPIO In valid to CLKOUT edge (GPIO in set-up time)		12.0	_	12.0	1	12 .0	_	ns
493	CLKOUT edge to GPIO in not valid (GPIO in hold time)		0.0	1	0.0		0.0	_	ns
494	Fetch to CLKOUT edge before GPIO change	$6.75 \times T_{\rm C}$	102.3	-	84.4	_	67.5	_	ns
Note: $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}; T_J = -40^{\circ}\text{C to } +100^{\circ}\text{C}, C_L = 50 \text{ pF} + 2 \text{ TTL Loads}$									

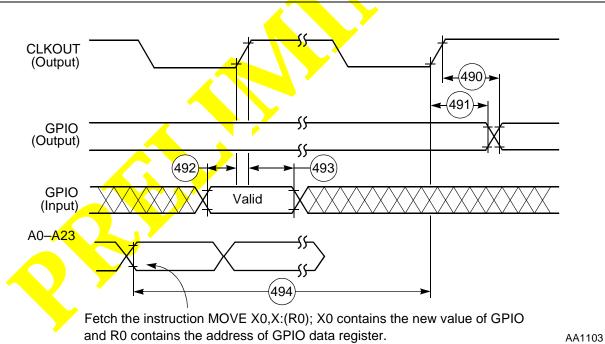


Figure 2-44 GPIO Timing

JTAG TIMING

Table 2-26 JTAG Timing

No	Characteristics	All freq	uencies	T I **4
No.	Characteristics	Min	Max	Unit
500	TCK frequency of operation = $1/(T_C \times 3) \le 22.0 \text{ MHz}$	0.0	22.0	MHz
501	TCK cycle time in Crystal mode	45.0	_	ns
502	TCK clock pulse width measured at 1.5 V	20.0		ns
503	TCK rise and fall times	0.0	3.0	ns
504	Boundary scan input data setup time	5.0	_	ns
505	Boundary scan input data hold time	24.0	_	ns
506	TCK low to output data valid	0.0	40.0	ns
507	TCK low to output high impedance	0.0	40.0	ns
508	TMS, TDI data setup time	5.0	_	ns
509	TMS, TDI data hold time	25.0	_	ns
510	TCK low to TDO data valid	0.0	44.0	ns
511	TCK low to TDO high impedance	0.0	44.0	ns
512	TRST assert time	100.0	_	ns
513	TRST setup time to TCK low	40.0	_	ns
Notes:	1 $V_{CC} = 3.3 \text{ V} + 0.3 \text{ V} \cdot \text{T}_{L} = -40^{\circ}\text{C}$ to $+100^{\circ}\text{C}$. $C_{L} = 50 \text{ pF} + 2 \text{ TTL}$ La	nads		

Notes:

 $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}; T_J = -40 ^{\circ}\text{C}$ to +100 °C, $C_L = 50 \text{ pF} + 2 \text{ TTL Loads}$ All timings apply to OnCE module data transfers because it uses the JTAG port as an interface.

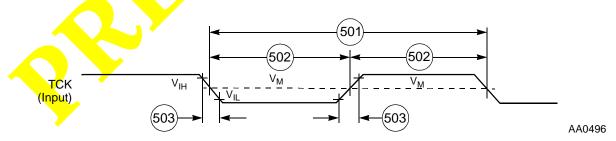


Figure 2-45 Test Clock Input Timing Diagram

JTAG Timing

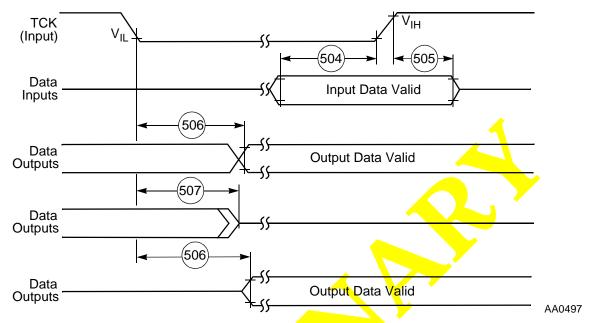


Figure 2-46 Boundary Scan (JTAG) Timing Diagram

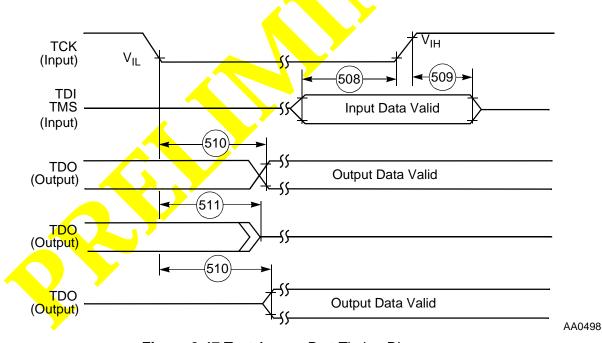


Figure 2-47 Test Access Port Timing Diagram

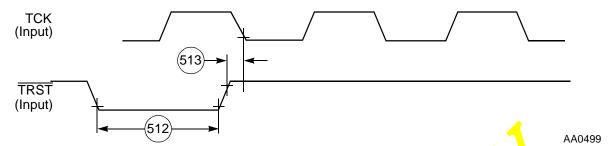


Figure 2-48 TRST Timing Diagram

OnCE MODULE TIMING

Table 2-27 OnCE Module Timing

N T	Characteristics	Г	66 MHz		80 MHz		100 MHz		Unit	
No.	Cnaracteristics	Expression	Min	Max	Min	Max	Min	Max	Unit	
500	TCK frequency of operation	1/(T _C ×3), max 22.0 MHz	0.0	22.0	0.0	22.0	0.0	22.0	MHz	
514	DE assertion time in order to enter Debug mode	$1.5 \times T_{\rm C} + 10.0$	32.7		28.8	_	25.0	_	ns	
515	Response time when DSP56301 is executing NOP instructions from internal memory	$5.5 \times \mathbf{T_C} + 30.0$		113.3	_	98.8	_	85.0	ns	
516	Debug acknowledge assertion time	$3 \times T_{\rm C} + 10.0$	55.5	_	47.5	_	40.0	_	ns	
Note: $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$; $T_{L} = -40 ^{\circ}\text{C}$ to $+100 ^{\circ}\text{C}$, $C_{L} = 50 \text{ pF} + 2 \text{ TTL Loads}$										

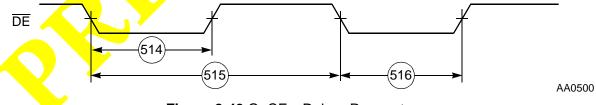


Figure 2-49 OnCE—Debug Request





SECTION 3 PACKAGING

PIN-OUT AND PACKAGE INFORMATION

This sections provides information about the available packages for this product, including diagrams of the package pinouts and tables describing how the signals described in **Section 1** are allocated for each package.

The DSP56301 is available in two package types:

- 208-pin Thin Quad Flat Pack (TQFP)
- 252-pin Plastic Ball Grid Array (PBGA)



TQFP Package Description

Top and bottom views of the TQFP package are shown in **Figure 3-1** and **Figure 3-2** with their pin-outs.

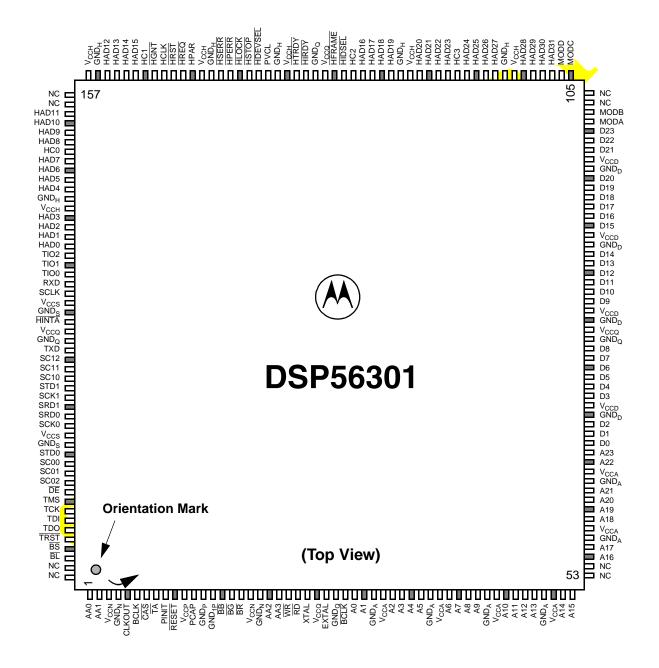


Figure 3-1 DSP56301 Thin Quad Flat Pack (TQFP), Top View

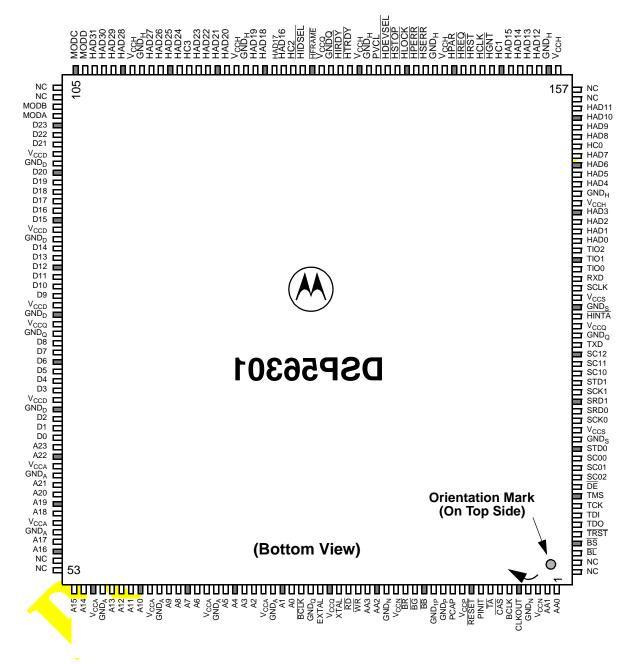


Figure 3-2 DSP56301 Thin Quad Flat Pack (TQFP), Bottom View

 Table 3-1
 DSP56301 TQFP Signal Identification by Pin Number

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
1	AA0/RAS0	26	EXTAL	51	A14
2	$AA1/\overline{RAS1}$	27	$\mathrm{GND}_{\mathrm{Q}}$	52	A15
3	V _{CCN}	28	BCLK	53	NC NC
4	GND_N	29	A0	54	, N <mark>C</mark>
5	CLKOUT	30	A1	55	A16
6	BCLK	31	GND_A	56	A17
7	CAS	32	V_{CCA}	57	GND _A
8	TA	33	A2	58	V_{CCA}
9	PINIT/NMI	34	A3	59	A18
10	RESET	35	A4	60	A19
11	V_{CCP}	36	A5	<mark>61</mark>	A20
12	PCAP	37	GND _A	62	A21
13	GND_P	38	V _C CA	63	GND_A
14	GND _{1P}	39	A6	64	V_{CCA}
15	$\overline{\text{BB}}$	40	A7	65	A22
16	$\overline{\mathrm{BG}}$	41	A8	66	A23
17	BR	42	A9	67	D0
18	V_{CCN}	43	GND_A	68	D1
19	GND_N	44	V _{CCA}	69	D2
20	$AA2/\overline{RAS2}$	45	A10	70	GND_D
21	AA3/ RAS3	46	A11	71	V_{CCD}
22	WR	47	A12	72	D3
23	RD	48	A13	73	D4
24	XTAL	49	GND_A	74	D5
25	V _{CCQ}	50	V_{CCA}	75	D6

 Table 3-1
 DSP56301 TQFP Signal Identification by Pin Number (Continued)

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
76	D7	101	MODA/IRQA	126	HAD17 or HD9
77	D8	102	MODB/IRQB	127	HAD16 or HD8
78	$\mathrm{GND}_{\mathrm{Q}}$	103	NC	128	HC2/ HBE2 , HA2, or PB18
79	$V_{\rm CCQ}$	104	NC	129	HIDSEL or HRD/HDS
80	GND_D	105	MODC/IRQC	130	HFRAME
81	V_{CCD}	106	MODD/IRQD	131	V _{CCQ}
82	D9	107	HAD31 or HD23	132	$\operatorname{GND}_{\operatorname{Q}}$
83	D10	108	HAD30 or HD22	133	HIRDY, HDBDR, or PB21
84	D11	109	HAD29 or HD21	134	HTRDY, HDBEN, or PB20
85	D12	110	HAD28 or HD20	135	V _{CCH}
86	D13	111	V _{CCH}	136	₹ GND _H
87	D14	112	GND _H	137	PVCL
88	GND_D	113	HAD27 or HD19	138	HDEVSEL, HSAK, or PB22
89	V_{CCD}	114	HAD <mark>26 or HD18</mark>	139	$\overline{\text{HSTOP}}$ or $\overline{\text{HWR}}/\text{HRW}$
90	D15	115	HAD25 or HD17	140	HLOCK, HBS, or PB23
91	D16	116	H <mark>AD24</mark> or HD16	141	HPERR or HDRQ
92	D17	117	HC <mark>3/HBE3</mark> or PB19	142	HSERR or HIRQ
93	D18	118	HAD23 or HD15	143	GND_H
94	D19	119	HAD22 or HD14	144	V_{CCH}
95	D20	120	HAD21 or HD13	145	HPAR or HDAK
96	GND _D	121	HAD20 or HD12	146	HREQ or HTA
97	V _{CCD}	122	V _{CCH}	147	HRST or HRST
98	D21	123	GND_H	148	HCLK
99	D22	124	HAD19 or HD11	149	HGNT or HAEN
100	D23	125	HAD18 or HD10	150	HC1/HBE1, HA1, or PB17

 Table 3-1
 DSP56301 TQFP Signal Identification by Pin Number (Continued)

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
151	HAD15, HD7, or PB15	171	HAD2, HA5, or PB2	191	SRD0 or PC4
152	HAD14, HD6, or PB14	172	HAD1, HA4, or PB1	192	SCK0 or PC3
153	HAD13, HD5, or PB13	173	HAD0, HA3, or PB0	193	V _{CCS}
154	HAD12, HD4, or PB12	174	TIO2	194	GND _S
155	$\mathrm{GND}_{\mathrm{H}}$	175	TIO1	195	STD0 or PC5
156	V_{CCH}	176	TIO0	196	SC00 or PC0
157	NC	177	RXD or PE0	197	SC01 or PC1
158	NC	178	SCLK or PE2	198	SC02 or PC2
159	HAD11, HD3, or PB11	179	V _{CCS}	199	DE
160	HAD10, HD2, or PB10	180	GND_S	200	TMS
161	HAD9, HD1, or PB9	181	HINTA	<mark>201</mark>	TCK
162	HAD8, HD0, or PB8	182	V_{CCQ}	202	TDI
163	$HC0/\overline{HBE0}$, HA0, or PB16	183	$\mathrm{GND}_{\mathrm{Q}}$	203	TDO
164	HAD7, HA10, or PB7	184	TXD or PE1	204	TRST
165	HAD6, HA9, or PB6	185	SC12 or PD2	205	BS
166	HAD5, HA8, or PB5	186	SC11 or PD1	206	BL
167	HAD4, HA7, or PB4	187	SC10 or PD0	207	NC
168	GND _H	188	STD1 or PD5	208	NC
169	V _{CCH}	189	SCK1 or PD3		
170	HAD3, HA6, or PB <mark>3</mark>	190	SRD1 or PD4		

Note:

1. Signal names are based on configured functionality. Most pins supply a single signal. Some pins provide a signal with dual functionality, such as the MODx/IRQx pins that select an operating mode after RESET is deasserted, but act as interrupt lines during operation. Some pins have two or more configurable functions; names assigned to these pins indicate the function for a specific configuration. For example, Pin 165 is address/data line HAD6 in PCI bus mode, address line HA9 in non-PCI bus mode, or GPIO line PB6 when the GPIO function is enabled for this pin.

2. NC stands for Not Connected. These pins are reserved for future development. Do not connect and line, component, trace, or via to these pins.

Table 3-2 DSP56301 TQFP Signal Identification by Name

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
A0	29	AA1	2	D21	98
A1	30	AA2	20	D22	99
A10	45	AA3	21	D23	100
A11	46	BB	15	D3	72
A12	47	BCLK	6	D4	73
A13	48	BCLK	28	D5	74
A14	51	BG	16	D6	75
A15	52	BL	206	D7	76
A16	55	BR	17	D8	77
A17	56	BS	205	D9	82
A18	59	CAS	7	DE	199
A19	60	CLKOUT	5	EXTAL	26
A2	33	D0	67	GND _{1P}	14
A20	61	D1	68	GND_A	31
A21	62	D10	83	GND_A	37
A22	65	D11	84	GND_A	43
A23	66	D12	85	GND_A	49
A3	34	D13	86	GND_A	57
A4	35	D14	87	GND_A	63
A5	36	D15	90	GND_D	70
A6	39	D16	91	GND_D	80
A7	40	D17	92	GND_D	88
A8	41	D18	93	GND_D	96
A9	42	D19	94	GND_H	112
	_	D2	69		
AA0	1	D20	95	GND_H	123

 Table 3-2
 DSP56301 TQFP Signal Identification by Name (Continued)

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
GND_H	136	HAD0	173	HAD31	107
GND _H	143	HAD1	172	HAD4	167
GND _H	155	HAD10	160	HAD5	166
GND _H	168	HAD11	159	HAD6 🦯	165
GND_N	4	HAD12	154	HAD7	164
GND_N	19	HAD13	153	HAD8	162
GND_P	13	HAD14	152	HAD9	161
$\mathrm{GND}_{\mathrm{Q}}$	27	HAD15	151	HAEN	149
$\mathrm{GND}_{\mathrm{Q}}$	78	HAD16	127	HBE0	163
$\mathrm{GND}_{\mathrm{Q}}$	132	HAD17	126	HBE1	150
$\mathrm{GND}_{\mathrm{Q}}$	183	HAD18	12 <mark>5</mark>	HBE2	128
$\mathrm{GND}_{\mathrm{Q}}$	183	HAD19	124	HBE3	117
$\mathrm{GND}_{\mathrm{S}}$	180	HAD2	171	HBS	140
$\mathrm{GND}_{\mathrm{S}}$	194	HAD20	121	HC0	163
HA0	163	HAD21	120	HC1	150
HA1	150	HAD <mark>22</mark>	119	HC2	128
HA10	164	HAD2 <mark>3</mark>	118	HC3	117
HA2	128	HAD24	116	HCLK	148
HA3	173	HAD25	115	HD0	162
HA4	172	HAD26	114	HD1	161
HA5	171	HAD27	113	HD10	125
HA6	170	HAD28	110	HD11	124
HA7	167	HAD29	109	HD12	121
HA8	166	HAD3	170	HD13	120
HA9	165	HAD30	108	HD14	119

 Table 3-2
 DSP56301 TQFP Signal Identification by Name (Continued)

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
HD15	118	HIDSEL	129	NC	28
HD16	116	HINTA	181	NC	53
HD17	115	HIRDY	133	NC	54
HD18	114	HIRQ	142	NC 🙏	103
HD19	113	HLOCK	140	NC	104
HD2	160	HPAR	145	NC	157
HD20	110	HPERR	141	NC	158
HD21	109	HRD	129	NC	207
HD22	108	HREQ	146	NC	208
HD23	107	HRST/HRST	147	NMI	9
HD3	159	HRW	139	PB0	173
HD4	154	HSAK	138	PB1	172
HD5	153	HSERR	142	PB10	160
HD6	152	HSTOP	139	PB11	159
HD7	151	HTA	146	PB12	154
HD8	127	HTR <mark>DY</mark>	134	PB13	153
HD9	126	HWR	139	PB14	152
HDAK	145	ĪRQA	101	PB15	151
HDBDR	133	IRQB	102	PB16	163
HDBEN	134	ĪRQC	105	PB17	150
HDEVSEL	138	<u>IRQD</u>	106	PB18	128
HDRQ	141	MODA	101	PB19	117
HDS	129	MODB	102	PB2	171
HFRAME	130	MODC	105	PB20	134
HGNT	149	MODD	106	PB21	133

 Table 3-2
 DSP56301 TQFP Signal Identification by Name (Continued)

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
PB22	138	PINIT	9	TDO	203
PB23	140	PVCL	137	TIO0	176
PB3	170	RAS0	1	TIO1	175
PB4	167	RAS1	2	TIO2	174
PB5	166	RAS2	20	TMS	200
PB6	165	RAS3	21	TRST	204
PB7	164	RD	23	TXD	184
PB8	162	RESET	10	V _{CCA}	32
PB9	161	RXD	177	V_{CCA}	38
PC0	196	SC00	196	V _{CCA}	44
PC1	197	SC01	197	V _{CCA}	50
PC2	198	SC02	198	V _{CCA}	58
PC3	192	SC10	187	V _{CCA}	64
PC4	191	SC11	186	V _{CCD}	71
PC5	195	SC12	185	V_{CCD}	81
PCAP	12	SCK <mark>0</mark>	192	V_{CCD}	89
PD0	187	SCK1	189	V_{CCD}	97
PD1	186	SCLK	178	V_{CCH}	111
PD2	185	SRD0	191	V_{CCH}	122
PD3	189	SRD1	190	V_{CCH}	135
PD4	190	STD0	195	V_{CCH}	144
PD5	188	STD1	188	V _{CCH}	156
PE0	177	TA	8	V_{CCH}	169
PE1	184	TCK	201	V_{CCN}	3
PE2	178	TDI	202	V _{CCN}	18
V_{CCP}	11	V_{CCQ}	131	V_{CCS}	193
V _{CCQ}	25	$V_{\rm CCQ}$	182	WR	22
V _{CCQ}	79	V _{CCS}	179	XTAL	24

Note: NC stands for Not Connected. These pins are reserved for future development. Do not connect and line, component, trace, or via to these pins.

TQFP Package Mechanical Drawing

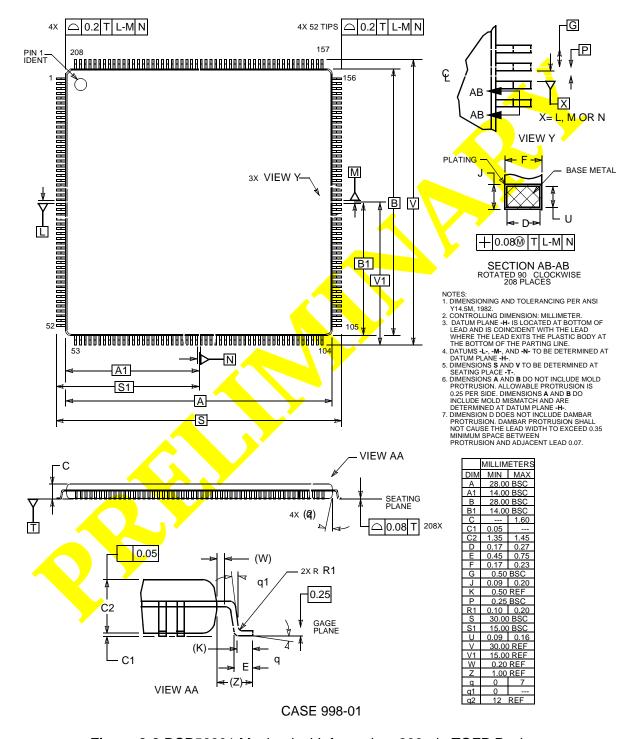


Figure 3-3 DSP56301 Mechanical Information, 208-pin TQFP Package

PBGA Package Description

Top and bottom views of the PBGA package are shown in **Figure 3-1** and **Figure 3-2** with their pin-outs.

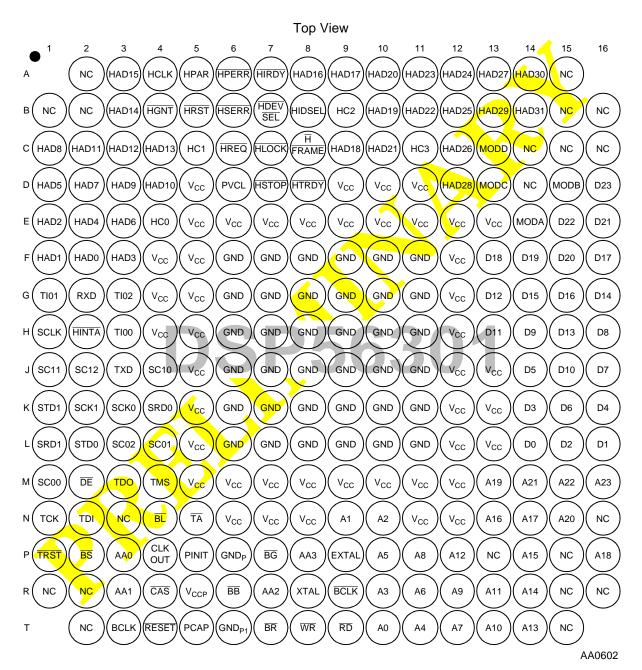


Figure 3-4 DSP56301 Plastic Ball Grid Array (PBGA), Top View

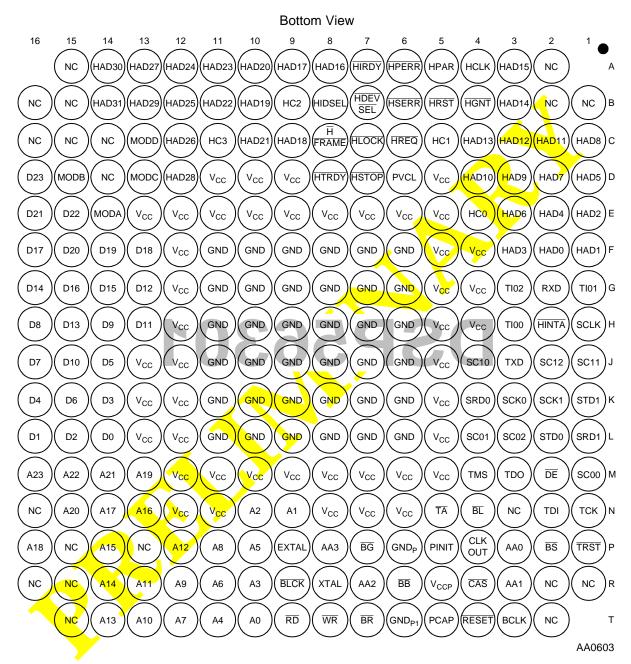


Figure 3-5 DSP56301 Plastic Ball Grid Array (PBGA), Bottom View

 Table 3-3
 DSP56301 PBGA Signal Identification by Pin Number

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
A2	NC	B12	HAD25 or HD17	D5	V_{CC}
A3	HAD15, HD7, or PB15	B13	HAD29 or HD21	D6	PVCL
A4	HCLK	B14	HAD31 or HD23	D7	HSTOP or HWR/HRW
A5	HPAR or HDAK	B15	NC	D8	HTRDY, HDBEN, or PB20
A6	HPERR or HDRQ	B16	NC	D9	V _{CC}
A7	HIRDY, HDBDR, or PB21	C1	HAD8, HD0, or PB8	D10	V _{CC}
A8	HAD16 or HD8	C2	HAD11, HD3, or PB11	D11	V _{CC}
A9	HAD17 or HD9	C3	HAD12, HD4, or PB12	D12	HAD <mark>28</mark> or HD20
A10	HAD20 or HD12	C4	HAD13, HD5, or PB13	D13	MODC/IRQC
A11	HAD23 or HD15	C5	HC1/HBE1, HA1, or PB17	D <mark>14</mark>	NC
A12	HAD24 or HD16	C6	HREQ or HTA	D15	MODB/ IRQB
A13	HAD27 or HD19	C7	HLOCK, HBS, or PB23	D16	D23
A14	HAD30 or HD22	C8	HFRAME	E1	HAD2, HA5, or PB2
A15	NC	C9	HAD <mark>18</mark> or HD10	E2	HAD4, HA7, or PB4
B1	NC	C10	HAD2 <mark>1</mark> or HD13	E3	HAD6, HA9, or PB6
B2	NC	C11	HC3/HBE3 or PB19	E4	$HC0/\overline{HBE0}$, HA0, or PB16
В3	HAD14, HD6, or PB14	C12	HAD26 or HD18	E5	V_{CC}
B4	HGNT or HAEN	C13	MODD/IRQD	E6	V_{CC}
B5	HRST/HRST	C14	NC	E7	V_{CC}
B6	HSERR or HIRQ	C15	NC	E8	V_{CC}
B7	HDEVSEL, HSAK, or PB22	C16	NC	E9	V_{CC}
B8	HIDSEL or HRD/HDS	D1	HAD5, HA8, or PB5	E10	V_{CC}
В9	HC2/HBE2, HA2, or PB18	D2	HAD7, HA10, or PB7	E11	V_{CC}
B10	HAD19 or HD11	D3	HAD9, HD1, or PB9	E12	V_{CC}
B11	HAD22 or HD14	D4	HAD10, HD2, or PB10	E13	V_{CC}

 Table 3-3
 DSP56301 PBGA Signal Identification by Pin Number (Continued)

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
E14	MODA/IRQA	G7	GND	H16	D8
E15	D22	G8	GND	J1	SC11 or PD1
E16	D21	G9	GND	J2	SC12 or PD2
F1	HAD1, HA4, or PB1	G10	GND	J3	TXD or PE1
F2	HAD0, HA3, or PB0	G11	GND	J4	SC10 or PD0
F3	HAD3, HA6, or PB3	G12	V_{CC}	J5	V _{CC}
F4	V_{CC}	G13	D12	J6	GND
F5	V_{CC}	G14	D15	J7	GND
F6	GND	G15	D16	J8	GND
F7	GND	G16	D14	<mark>J9</mark>	GND
F8	GND	H1	SCLK or PE2	J1 <mark>0</mark>	GND
F9	GND	H2	HINTA	J11	GND
F10	GND	H3	TIO0	J12	V_{CC}
F11	GND	H4	V _{CC}	J13	V_{CC}
F12	V_{CC}	H5	V _{CC}	J14	D5
F13	D18	H6	GND	J15	D10
F14	D19	H7	GND	J16	D7
F15	D20	H8	GND	K1	STD1 or PD5
F16	D17	H9	GND	K2	SCK1 or PD3
G1	TIO1	H10	GND	K3	SCK0 or PC3
G2	RXD or PE0	H11	GND	K4	SRD0 or PC4
G3	TIO2	H12	V_{CC}	K5	V_{CC}
G4	V_{CC}	H13	D11	K6	GND
G5	V _{CC}	H14	D9	K7	GND
G6	GND	H15	D13	K8	GND

 Table 3-3
 DSP56301 PBGA Signal Identification by Pin Number (Continued)

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
K9	GND	M2	DE	N11	V_{CC}
K10	GND	M3	TDO	N12	V_{CC}
K11	GND	M4	TMS	N13	A16
K12	V_{CC}	M5	V_{CC}	N14	A17
K13	V_{CC}	M6	V_{CC}	N15	A20
K14	D3	M7	V_{CC}	N16	NC
K15	D6	M8	V_{CC}	P1 🥠	TRST
K16	D4	M9	V_{CC}	P2	BS
L1	SRD1 or PD4	M10	V_{CC}	P3	AA0/ <mark>RAS0</mark>
L2	STD0 or PC5	M11	V _{CC}	P4	CLK OUT
L3	SC02 or PC2	M12	V _{CC}	P <mark>5</mark>	PĬNIT/NMI
L4	SC01 or PC1	M13	A19	P6	GND_P
L5	V_{CC}	M14	A21	P 7	BG
L6	GND	M15	A22	P8	AA3/RAS3
L7	GND	M16	A23	P9	EXTAL
L8	GND	N1	TCK	P10	A5
L9	GND	N2	TDI	P11	A8
L10	GND	N3	NC	P12	A12
L11	GND	N4	BL >	P13	NC
L12	V _{CC}	N5	TA	P14	A15
L13	V _{CC}	N6	V _{CC}	P15	NC
L14	D0	N7	V_{CC}	P16	A18
L15	D2	N8	V_{CC}	R1	NC
L16	D1	N9	A1	R2	NC
M1	SC00 or PC0	N10	A2	R3	AA1/RAS1

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
R4	CAS	R13	A11	T7	BR
R5	V_{CCP}	R14	A14	Т8	WR
R6	BB	R15	NC	Т9	RD
R7	AA2/RAS2	R16	NC	T10	A0
R8	XTAL	T2	NC	T11	A4
R9	BCLK	Т3	BCLK	T12	A7
R10	A3	T4	RESET	T13 🦯	A10
R11	A6	T5	PCAP	T14	A13
R12	A9	T6	GND _{1P}	T15	NC

 Table 3-3
 DSP56301 PBGA Signal Identification by Pin Number (Continued)

- Note: 1. Signal names are based on configured functionality. Most connections supply a single signal. Some connections provide a signal with dual functionality, such as the MODx/IRQx pins that select an operating mode after RESET is deasserted, but act as interrupt lines during operation. Some signals have configurable polarity; these names are shown with and without overbars, such as HAS/HAS. Some connections have two or more configurable functions; names assigned to these connections indicate the function for a specific configuration. For example, connection N2 is data line H7 in non-multiplexed bus mode, data/address line HAD7 in multiplexed bus mode, or GPIO line PB7 when the
 - multiplexed bus mode, data/address line HAD7 in multiplexed bus mode, or GPIO line PB7 when the GPIO function is enabled for this pin. Unlike the TQFP package, most of the GND pins are connected internally in the center of the connection array and act as heat sink for the chip. Therefore, except for GND_P and GND_{P1} that support the PLL, other GND signals do not support individual subsystems in the chip.
 - 2. NC stands for Not Connected. These pins are reserved for future development. Do not connect and line, component, trace, or via to these pins.



Table 3-4 DSP56301 PBGA Signal Identification by Name

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
A0	T10	AA2	R7	D22	E15
A1	N9	AA3	P8	D23	D16
A10	T13	BB	R6	D3	K14
A11	R13	BCLK	Т3	D4	K16
A12	P12	BCLK	R9	D5	J14
A13	T14	$\overline{\mathrm{BG}}$	P7	D6	K15
A14	R14	$\overline{\mathrm{BL}}$	N4	D7	J16
A15	P14	BR	T7 (D8	H16
A16	N13	BS	P2	D9	H14
A17	N14	CAS	R4	DE	M2
A18	P16	CLKOUT	P4	EXTAL	P9
A19	M13	D0	L14	GND	F10
A2	N10	D1	L16	GND	F11
A20	N15	D10	J15	GND	F6
A21	M14	D11	H13	GND	F7
A22	M15	D12	G13	GND	F8
A23	M16	D13	H15	GND	F9
A3	R10	D14	G16	GND	G10
A4	T 11	D15	G14	GND	G11
A5	P10	D16	G15	GND	G6
A6	R11	D17	F16	GND	G7
A7	T12	D18	F13	GND	G8
A8	P11	D19	F14	GND	G9
A9	R12	D2	L15	GND	H10
AA0	P3	D20	F15	GND	H11
AA1	R3	D21	E16		

 Table 3-4
 DSP56301 PBGA Signal Identification by Name (Continued)

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
GND	H6	HA0	E4	HAD21	C10
GND	H7	HA1	C5	HAD22	B11
GND	H8	HA10	D2	HAD23	A11
GND	H9	HA2	В9	HAD24	A12
GND	J10	HA3	F2	HAD25	B12
GND	J11	HA4	F1	HAD26	C12
GND	J6	HA5	E1	HAD27	A13
GND	J7	HA6	F3	HAD28	D12
GND	J8	HA7	E2 (HAD29	B13
GND	J9	HA8	D1	HAD3	F3
GND	K10	HA9	E3	HAD30	A14
GND	K11	HAD0	F2	HAD31	B14
GND	K6	HAD1	F1	HAD4	E2
GND	K7	HAD10	D4	HAD5	D1
GND	K8	HAD11	C2	HAD6	E3
GND	K9	HAD12	C3	HAD7	D2
GND	L10	HAD13	C4	HAD8	C1
GND	L11	HAD14	В3	HAD9	D3
GND	L6	HAD15	A3	HAEN	B4
GND	Ĺ7	HAD16	A8	HBE0	E4
GND	L8	HAD17	A9	HBE1	C5
GND	L9	HAD18	C9	HBE2	В9
GND _{1P}	Т6	HAD19	B10	HBE3	C11
GND _P	P6	HAD2	E1	HBS	C7
		HAD20	A10	HC0	E4

 Table 3-4
 DSP56301 PBGA Signal Identification by Name (Continued)

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
HC1	C5	HD7	A3	HTA	C6
HC2	В9	HD8	A8	HTRDY	D8
HC3	C11	HD9	A9	HWR	D7
HCLK	A4	HDAK	A5	ĪRQĀ	E14
HD0	C1	HDBDR	A7	ĪRQB	D15
HD1	D3	HDBEN	D8	ĪRQC	D13
HD10	C9	HDEVSEL	В7	ĪRQD	C13
HD11	B10	HDRQ	A6	MODA	E14
HD12	A10	HDS	B8 (MODB	D15
HD13	C10	HFRAME	C8	MODC	D13
HD14	B11	HGNT	B4	MODD	C13
HD15	A11	HIDSEL	B8	NC	A15
HD16	A12	HINTA	H2	NC	A2
HD17	B12	HIRDY	A7	NC	B1
HD18	C12	H <mark>IRQ</mark>	B6	NC	B15
HD19	A13	HL <mark>OCK</mark>	C7	NC	B16
HD2	D4	HPAR	A5	NC	B2
HD20	D12	HPERR	A6	NC	C14
HD21	B13	HR D	B8	NC	C15
HD22	A14	HREQ	C6	NC	C16
HD23	B14	HRST/HRST	B5	NC	D14
HD3	C2	HRW	D7	NC	N16
HD4	C3	HSAK	В7	NC	N3
HD5	C4	HSERR	B6	NC	P13
HD6	В3	HSTOP	D7	NC	P15

 Table 3-4
 DSP56301 PBGA Signal Identification by Name (Continued)

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
NC	R1	PB3	F3	RAS0	P3
NC	R2	PB4	E2	RAS1	R3
NC	R15	PB5	D1	RAS2	R7
NC	R16	PB6	E3	RAS3	P8
NC	T2	PB7	D2	RD	Т9
NC	T15	PB8	C1	RESET	T4
NMI	P5	PB9	D3	RXD	G2
PB0	F2	PC0	M1	SC00	M1
PB1	F1	PC1	L4	SC01	L4
PB10	D4	PC2	L3	SC02	L3
PB11	C2	PC3	K 3	SC10	J4
PB12	C3	PC4	K4	SC11	J1
PB13	C4	PC5	L2	SC12	J2
PB14	В3	PCAP	T5	SCK0	K3
PB15	A3	PD0	J4	SCK1	K2
PB16	E4	P <mark>D1</mark>	J1	SCLK	H1
PB17	C5	PD2	J2	SRD0	K4
PB18	В9	PD3	K2	SRD1	L1
PB19	C11	PD4	L1	STD0	L2
PB2	E1	PD5	K1	STD1	K1
PB20	D8	PE0	G2	TA	N5
PB21	A7	PE1	J3	TCK	N1
PB22	В7	PE2	H1	TDI	N2
PB23	C7	PINIT	P5	TDO	M3
		PVCL	D6	TIO0	Н3

 Table 3-4
 DSP56301 PBGA Signal Identification by Name (Continued)

Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.
TIO1	G1	V_{CC}	F12	V_{CC}	M10
TIO2	G3	V_{CC}	F4	V_{CC}	M11
TMS	M4	V_{CC}	F5	V _{CC}	M12
TRST	P1	V_{CC}	G12	V _{CC}	M5
TXD	J3	V_{CC}	G4	V _{CC}	M6
V_{CC}	D10	V_{CC}	G5	V _{CC}	M7
V_{CC}	D11	V_{CC}	H12	V _{CC}	M8
V_{CC}	D5	V_{CC}	H4	V _{CC}	M9
V_{CC}	D9	V_{CC}	H5 (V _{CC}	N11
V_{CC}	E10	V_{CC}	J12	V_{CC}	N12
V_{CC}	E11	V _{CC}	J13	V _{CC}	N6
V_{CC}	E12	V _{CC}	J5	V _{CC}	N7
V_{CC}	E13	V _{CC}	K12	V_{CC}	N8
$V_{\rm CC}$	E5	V _{CC}	K13	V_{CCP}	R5
V_{CC}	E6	V _{CC}	K5	WR	T8
V_{CC}	E7	V _{CC}	L12	XTAL	R8
V_{CC}	E8	V_{CC}	L13		
V _{CC}	E9	V _{CC}	L5		

Note: NC stands for Not Connected. These pins are reserved for future development. Do not connect and line, component, trace, or via to these pins.



PBGA Package Mechanical Drawing

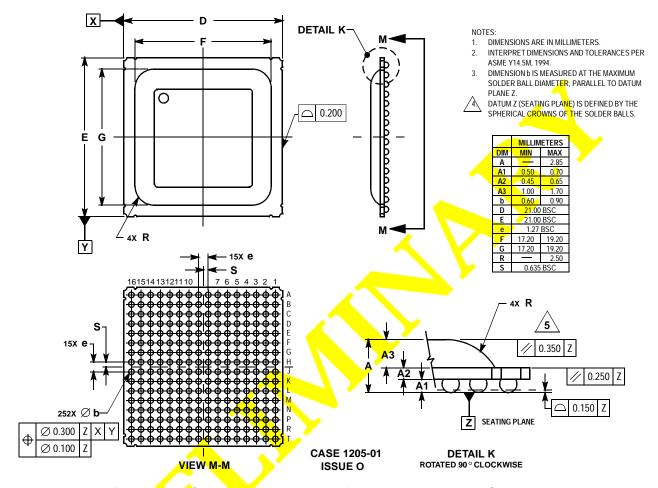


Figure 3-6 DSP56301 Mechanical Information, 252-pin PBGA Package

ORDERING DRAWINGS

Complete mechanical information regarding DSP56301 packaging is available by facsimile through Motorola's MfaxTM system. Call the following number to obtain information by facsimile:

(602) 244-6609

The Mfax automated system requests the following information:

- The receiving facsimile telephone number including area code or country code
- The caller's Personal Identification Number (PIN)

Note: For first time callers, the system provides instructions for setting up a PIN, which requires entry of a name and telephone number.

- The type of information requested:
 - Instructions for using the system
 - A literature order form
 - Specific part technical information or data sheets
 - Other information described by the system messages

A total of three documents may be ordered per call.

The DSP56301 208-pin TQFP package mechanical drawing is referenced as 998-01. The reference number for the 252-pin PBGA package is 1205-01.

SECTION 4

DESIGN CONSIDERATIONS

THERMAL DESIGN CONSIDERATIONS

An estimation of the chip junction temperature, T_J, in °C can be obtained from the equation:

Equation 1:
$$T_J = T_A + (P_D \times R_{\theta JA})$$

Where:

 T_A = ambient temperature °C

 $R_{\theta JA}$ = package junction-to-ambient thermal resistance °C/W

 P_D = power dissipation in package

Historically, thermal resistance has been expressed as the sum of a junction-to-case thermal resistance and a case-to-ambient thermal resistance:

Equation 2:
$$R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$$

Where:

 $R_{\theta JA}$ = package junction-to-ambient thermal resistance °C/W $R_{\theta JC}$ = package junction-to-case thermal resistance °C/W $R_{\theta CA}$ = package case-to-ambient thermal resistance °C/W

 $R_{\theta IC}$ is device-related and cannot be influenced by the user. The user controls the thermal environment to change the case-to-ambient thermal resistance, $R_{\theta CA}$. For example, the user can change the air flow around the device, add a heat sink, change the mounting arrangement on the Printed Circuit Board (PCB), or otherwise change the thermal dissipation capability of the area surrounding the device on a PCB. This model is most useful for ceramic packages with heat sinks; some 90% of the heat flow is dissipated through the case to the heat sink and out to the ambient environment. For ceramic packages, in situations where the heat flow is split between a path to the case and an alternate path through the PCB, analysis of the device thermal performance may need the additional modeling capability of a system level thermal simulation tool.

Thermal Design Considerations

The thermal performance of plastic packages is more dependent on the temperature of the PCB to which the package is mounted. Again, if the estimations obtained from $R_{\theta JA}$ do not satisfactorily answer whether the thermal performance is adequate, a system level model may be appropriate.

A complicating factor is the existence of three common ways for determining the junction-to-case thermal resistance in plastic packages:

- To minimize temperature variation across the surface, the thermal resistance is measured from the junction to the outside surface of the package (case) closest to the chip mounting area when that surface has a proper heat sink.
- To define a value approximately equal to a junction-to-board thermal resistance, the thermal resistance is measured from the junction to where the leads are attached to the case.
- If the temperature of the package case (T_T) is determined by a thermocouple, the thermal resistance is computed using the value obtained by the equation $(T_I T_T)/P_D$.

As noted above, the junction-to-case thermal resistances quoted in this data sheet are determined using the first definition. From a practical standpoint, that value is also suitable for determining the junction temperature from a case thermocouple reading in forced convection environments. In natural convection, using the junction-to-case thermal resistance to estimate junction temperature from a thermocouple reading on the case of the package will estimate a junction temperature slightly hotter than actual temperature. Hence, the new thermal metric, Thermal Characterization Parameter or Ψ_{JT} , has been defined to be $(T_J - T_T)/P_D$. This value gives a better estimate of the junction temperature in natural convection when using the surface temperature of the package. Remember that surface temperature readings of packages are subject to significant errors caused by inadequate attachment of the sensor to the surface and to errors caused by heat loss to the sensor. The recommended technique is to attach a 40-gauge thermocouple wire and bead to the top center of the package with thermally conductive epoxy.

ELECTRICAL DESIGN CONSIDERATIONS

CAUTION

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, normal precautions are advised to avoid application of any voltages higher than maximum rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either GND or V_{CC}).

Use the following list of recommendations to assure correct DSP operation:

- Provide a low-impedance path from the board power supply to each V_{CC} pin on the DSP, and from the board ground to each GND pin.
- Use at least six $0.01-0.1~\mu F$ bypass capacitors positioned as close as possible to the four sides of the package to connect the V_{CC} power source to GND.
- Ensure that capacitor leads and associated printed circuit traces that connect to the chip V_{CC} and GND pins are less than 0.5 in per capacitor lead.
- Use at least a four-layer PCB with two inner layers for V_{CC} and GND.
- Because the DSP output signals have fast rise and fall times, PCB trace lengths should be minimal. This recommendation particularly applies to the address and data buses as well as the IRQA, IRQB, IRQC, IRQD, TA, and BG pins.
 Maximum PCB trace lengths on the order of 6 inches are recommended.
- Consider all device loads as well as parasitic capacitance due to PCB traces when calculating capacitance. This is especially critical in systems with higher capacitive loads that could create higher transient currents in the V_{CC} and GND circuits.
- All inputs must be terminated (i.e., not allowed to float) using CMOS levels, except for the three pins with internal pull-up resistors (TRST, TMS, DE).
- Take special care to minimize noise levels on the V_{CCP} , GND_P , and GND_{P1} pins.
- The following pins must be asserted after power-up: RESET, HRST (default after reset is active low), and TRST.

Preliminary Data

Power Consumption Considerations

- At power-up, the voltage difference between 5 V tolerant pins and the chip V_{CC} should not exceed 3.5 V.
- If multiple DSP56301 devices are on the same board, check for cross-talk or excessive spikes on the supplies due to synchronous operation of the devices.

POWER CONSUMPTION CONSIDERATIONS

Power dissipation is a key issue in portable DSP applications. Some of the factors which affect current consumption are described in this section. Most of the current consumed by CMOS devices is Alternating Current (AC), which is charging and discharging the capacitances of the pins and internal nodes.

Current consumption is described by the formula:

Equation 3: $I = C \times V \times f$

where: C = node/pin capacitance

V = voltage swing

f = frequency of node/pin toggle

Example 4-1 Current Consumption

For a Port A address pin loaded with 50 pF capacitance, operating at 3.3 V, and with a 66 MHz clock, toggling at its maximum possible rate (33 MHz), the current consumption is:

Equation 4:
$$I = 50 \times 10^{-12} \times 3.3 \times 33 \times 10^6 = 5.48 \text{ mA}$$

The Maximum Internal Current (I_{CCI}max) value reflects the typical possible switching of the internal buses on worst-case operation conditions, which is not necessarily a real application case. The Typical Internal Current (I_{CCItyp}) value reflects the average switching of the internal buses on typical operating conditions.

For applications that require very low current consumption:

- Set the EBD bit when not accessing external memory.
- Minimize external memory accesses, and use internal memory accesses.
- Minimize the number of pins that are switching.
- Minimize the capacitive load on the pins.
- Connect the unused inputs to pull-up or pull-down resistors.
- Disable unused peripherals.

Preliminary Data

• Disable unused pin activity (e.g., CLKOUT, XTAL).

One way to evaluate power consumption is to use a current per MIPS measurement methodology to minimize specific board effects (i.e., to compensate for measured board current not caused by the DSP). A benchmark power consumption test algorithm is listed in **Appendix A**. Use the test algorithm, specific test current measurements, and the following equation to derive the current per MIPS value:

Equation 5: $I/MIPS = I/MHz = (I_{typF2} - I_{typF1})/(F2 - F1)$

where: $I_{typF2} = current$ at F2

 I_{typF1} = current at F1

 $F2^{-}$ = high frequency (any specified operating frequency)

F1 = low frequency (any specified operating frequency lower than F2)

Note: F1 should be significantly less than F2. For example, F2 could be 66 MHz and F1 could be 33 MHz. The degree of difference between F1 and F2 determines the amount of precision with which the current rating can be determined for an application.

PLL PERFORMANCE ISSUES

The following explanations should be considered as general observations on expected PLL behavior. There is no testing that verifies these exact numbers. These observations were measured on a limited number of parts and were not verified over the entire temperature and voltage ranges.

Phase Skew Performance

The phase skew of the PLL is defined as the time difference between the falling edges of EXTAL and CLKOUT for a given capacitive load on CLKOUT, over the entire process, temperature and voltage ranges. As defined in **Table 2-5** on page 2-7, for input frequencies greater than 15 MHz and the Multiplication Factor (MF) \leq 4, this skew is greater than or equal to 0.0 ns and less than 1.8 ns; otherwise, this skew is not guaranteed. However, for MF < 10 and input frequencies greater than 10 MHz, this skew is between -1.4 ns and +3.2 ns.

Phase Jitter Performance

The phase jitter of the PLL is defined as the variations in the skew between the falling edges of EXTAL and CLKOUT for a given device in specific temperature, voltage, input frequency, MF, and capacitive load on CLKOUT. These variations are a result of the PLL locking mechanism. For input frequencies greater than 15 MHz and MF \leq 4, this jitter is less than ± 0.6 ns; otherwise, this jitter is not guaranteed. However, for MF < 10 and input frequencies greater than 10 MHz, this jitter is less than ± 2 ns.

Frequency Jitter Performance

The frequency jitter of the PLL is defined as the variation of the frequency of CLKOUT. For small MF (MF < 10) this jitter is smaller than 0.5%. For mid-range MF (10 < MF < 500) this jitter is between 0.5% and \sim 2%. For large MF (MF > 500), the frequency jitter is 2–3%.

Input (EXTAL) Jitter Requirements

The allowed jitter on the frequency of EXTAL is 0.5%. If the rate of change of the frequency of EXTAL is slow (i.e., it does not jump between the minimum and maximum values in one cycle) or the frequency of the jitter is fast (i.e., it does not stay at an extreme value for a long time), then the allowed jitter can be 2%. The phase and frequency jitter performance results are only valid if the input jitter is less than the prescribed values.





SECTION 5 ORDERING INFORMATION

ORDERING PRODUCT

Consult a Motorola Semiconductor sales office or authorized distributor to determine product availability and to place an order.

Table 5-1 Ordering Information

Part	Supply Voltage	Package Type	Pin Count	Frequency (MHz)	Order Number
DSP56301 3 V				66	XC56301PW66
	Thin Quad Flat Pack (TQFP)	208	80	XC56301PW80	
	3 V			100	XC56301PW100
	0 V	Plastic Ball Grid Array (PBGA)	252	66	XC56301GC66
				80	XC56301GC80
				100	XC56301GC100





APPENDIX A

POWER CONSUMPTION BENCHMARK

The following benchmark program permits evaluation of DSP power usage in a test situation. It enables the PLL, disables the external clock, and uses repeated Multiply-Accumulate (MAC) instructions with a set of synthetic DSP application data to emulate intensive sustained DSP operation.

```
; *
          Typical Power Consumption
page
                200,55,0,0,0
        nolist
I_VEC EQU $000000 ; Interrupt vectors for program debug only
START EQU $8000 ; MAIN (external) program starting address
INT_PROG EQU$100  ; INTERNAL program memory starting address
INT_XDAT_EQU$0 ; INTERNAL X-data memory starting address
INT YDAT EOU$0
                ; INTERNAL Y-data memory starting address
        INCLUDE "ioequ.asm"
        INCLUDE "intequ.asm"
        list
        org
                 P:START
        movep #$0123FF, x:M_BCR; BCR: Area 3 : 1 w.s (SRAM)
; Area 2 : 0 w.s (SSRAM)
; Default: 1 w.s (SRAM)
                 #$0d0000,x:M_PCTL; XTAL disable
; PLL enable
; CLKOUT disable
;Load the program
        move
                 #INT_PROG,r0
        move
                #PROG_START,r1
        do
                 #(PROG_END-PROG_START),PLOAD_LOOP
                p:(r1)+,x0
        move
                x0,p:(r0)+
        move
```

```
nop
PLOAD_LOOP
; Load the X-data
                    #INT_XDAT,r0
          move
                    #XDAT_START, r1
          move
          do
                    #(XDAT_END-XDAT_START),XLOAD_LOOP
                    p:(r1)+,x0
          move
                    x0,x:(r0)+
          move
XLOAD_LOOP
;Load the Y-data
                    #INT_YDAT,r0
          move
          move
                    #YDAT_START,r1
                    #(YDAT_END-YDAT_START),YLOAD_LOOP
          do
          move
                    p:(r1)+,x0
          move
                    x0,y:(r0)+
YLOAD_LOOP
;
                    INT_PROG
          jmp
PROG_START
                    #$0,r0
          move
          move
                    #$0,r4
          move
                    #$3f,m0
                    #$3f,m4
          move
          clr
                    а
          clr
                    b
          move
                    #$0,x0
                    #$0,x1
          move
                    #$0,y0
          move
          move
                    #$0,y1
          bset
                    \#4,omr
                                         ; ebd
;
sbr
          dor
                    #60,_end
                    x0,y0,a
          mac
                             x:(r0)+,x1
                                                   y:(r4)+,y1
          mac
                    x1,y1,a
                             x:(r0)+,x0
                                                   y:(r4)+,y0
          add
                    a,b
          {\tt mac}
                    x0,y0,a
                              x:(r0)+,x1
          mac
                    x1,y1,a
                                                   y:(r4)+,y0
          move
                    b1,x:$ff
_end
          bra
                    sbr
          nop
          nop
          nop
          nop
PROG_END
          nop
```

nop

XDAT_START					
;	org	x:0			
	dc	\$262EB9			
	dc	\$86F2FE			
	dc	\$E56A5F			
	dc	\$616CAC			
	dc	\$8FFD75			
	dc	\$9210A			
	dc	\$A06D7B			
	dc	\$CEA798			
	dc	\$8DFBF1			
	dc	\$A063D6			
	dc	\$6C6657			
	dc	\$C2A544			
	dc	\$A3662D			
	dc	\$A4E762			
	dc	\$84F0F3			
	dc	\$E6F1B0			
	dc	\$B3829			
	dc	\$8BF7AE			
	dc	\$63A94F			
	dc	\$EF78DC			
	dc	\$242DE5			
	dc	\$A3E0BA			
	dc	\$EBAB6B			
	dc	\$8726C8			
	dc	\$CA361			
	dc	\$2F6E86			
	dc	\$A57347			
	dc	\$4BE774			
	dc	\$8F349D			
	dc	\$A1ED12			
	dc	\$4BFCE3			
	dc	\$EA26E0			
	dc	\$CD7D99			
	dc	\$4BA85E			
	dc	\$27A43F			
	dc	\$A8B10C			
	dc	\$D3A55			
	dc	\$25EC6A			
	dc	\$2A255B			
	dc	\$A5F1F8			
	dc	\$2426D1			
	dc	\$AE6536			
	dc	\$CBBC37			
	dc	\$6235A4			
	dc	\$37F0D			
	dc	\$63BEC2			
	dc	\$A5E4D3			
	dc	\$8CE810			

de d	\$3FF09 \$60E50E \$CFFB2F \$40753C \$8262C5 \$CA641A \$EB3B4B \$2DA928 \$AB6641 \$28A7E6 \$4E2127 \$482FD4 \$7257D \$E53C72 \$1A8C3 \$E27540
YDAT START	
; organization of the control of the	\$586DA \$C3F70B \$6A39E8 \$81E801 \$C666A6 \$46F8E7 \$AAEC94 \$24233D \$802732 \$2E3C83 \$A43E00 \$C2B639 \$85A47E \$ABFDDF \$F3A2C \$2D7CF5 \$E16A8A \$ECB8FB \$4BED18 \$43F371 \$83A556 \$E1E9D7 \$ACA2C4 \$8135AD \$2CE0E2 \$8F2C73 \$432730 \$A87FA9
dc dc dc dc	\$4A292E \$A63CCF \$6BA65C \$E06D65 \$1AA3A

```
dc
                $A1B6EB
        dc
                $48AC48
                $EF7AE1
        dc
        dc
                $6E3006
                $62F6C7
        dc
                $6064F4
                $87E41D
        dc
        dc
                $CB2692
        dc
                $2C3863
        dc
                $C6BC60
        dc
                $43A519
                $6139DE
        dc
        dc
                $ADF7BF
        dc
                $4B3E8C
        dc
                $6079D5
        dc
                $EOF5EA
        dc
                $8230DB
        dc
                $A3B778
        dc
                $2BFE51
        dc
                $E0A6B6
        dc
                $68FFB7
        dc
                $28F324
                $8F2E8D
        dс
                $667842
        dc
                $83E053
        dc
                $A1FD90
        dc
        dc
                $6B2689
        dc
                $85B68E
                $622EAF
        dc
        dc
                $6162BC
        dc
                $E4A245
YDAT_END
***
        EQUATES for DSP56301 I/O registers and ports
        Reference: DSP56301 Specifications Revision 3.00
        Last update:
                        November 15 1993
                        GPIO for ports C,D and E,
        Changes:
                        HI32
                        DMA status req
                         PLL control reg
                        AAR
                        SCI registers address
                        SSI registers addr. + split TSR from SSISR
        December 19 1993 (cosmetic - page and opt directives)
              9 1994 ESSI and SCI control registers bit update
        August
* * *
```

```
page 132,55,0,0,0
        opt
                mex
ioequ ident 1,0
;-----
     EQUATES for I/O Port Programming
       Register Addresses
M_DATH EQU $FFFFCF ; Host port GPIO data Register
M DIRH EQU $FFFFCE; Host port GPIO direction Register
M_PCRC EQU $FFFFBF ; Port C Control Register
M_PRRC EQU $FFFFBE ; Port C Direction Register
M_PDRC EQU $FFFFBD ; Port C GPIO Data Register
M_PCRD EQU $FFFFAF ; Port D Control register
M_PRRD EQU $FFFFAE ; Port D Direction Data Register
M_PDRD EQU $FFFFAD ; Port D GPIO Data Register
M_PCRE EQU $FFFF9F ; Port E Control register
M_PRRE EQU $FFFF9E ; Port E Direction Register
M_PDRE EQU $FFFF9D ; Port E Data Register
M_OGDB EQU $FFFFFC ; OnCE GDB Register
;-----
    EQUATES for Host Interface
; Register Addresses
M DTXS EQU $FFFFCD ; DSP SLAVE TRANSMIT DATA FIFO (DTXS)
M_DTXM EQU $FFFFCC ; DSP MASTER TRANSMIT DATA FIFO (DTXM)
M_DRXR EQU $FFFFCB ; DSP RECEIVE DATA FIFO (DRXR)
M_DPSR EQU $FFFFCA ; DSP PCI STATUS REGISTER (DPSR)
M_DSR EQU $FFFFC9 ; DSP STATUS REGISTER (DSR)
M_DPAR EQU $FFFFC8 ; DSP PCI ADDRESS REGISTER (DPAR)
M_DPMC EQU $FFFFC7 ; DSP PCI MASTER CONTROL REGISTER (DPMC)
M_DPCR EQU $FFFFC6 ; DSP PCI CONTROL REGISTER (DPCR)
M_DCTR EQU $FFFFC5 ; DSP CONTROL REGISTER (DCTR)
      Host Control Register Bit Flags
             ; Host Command Interrupt Enable
; Slave Transmit Interrupt Enable
M_HCIE EQU 0
M_STIE EQU 1
            ; Slave Receive Interrupt Enable
M_SRIE EQU 2
```

```
M_HF35 EQU $38
                 ; Host Flags 5-3 Mask
M HF3 EQU 3
                 ; Host Flag 3
M_HF4 EQU 4
                 ; Host Flag 4
M_HF5 EQU 5
                ; Host Flag 5
M_HINT EQU 6
M_HDSM EQU 13
                ; Host Interrupt A
; Host Data Strobe Mode
M_HIRP EQU 18
                ; Host Interrupt Request Polarity
M_HIRC EQU 19
                ; Host Interupt Request Control
                 ; Host Interface Mode
M_HM0 EQU 20
                 ; Host Interface Mode
M_HM1 EQU 21
M HM2 EQU 22
                 ; Host Interface Mode
M HM EOU $700000 ; Host Interface Mode Mask
       Host PCI Control Register Bit Flags
M_PMTIE EQU 1
                 ; PCI Master Transmit Interrupt Enable
M_PMRIE EQU 2
                ; PCI Master Receive Interrupt Enable
M_PMAIE EQU 4
                ; PCI Master Address Interrupt Enable
M_PPEIE EQU 5
                ; PCI Parity Error Interrupt Enable
M_PTAIE EQU 7
                 ; PCI Transaction Abort Interrupt Enable
M_PTTIE EQU 9
                ; PCI Transaction Termination Interrupt Enable
M_PTCIE EQU 12 ; PCI Transfer Complete Interrupt Enable
M_CLRT EQU 14
                ; Clear Transmitter
M MTT EOU 15
                ; Master Transfer Terminate
M_SERF EQU 16
                ; HSERR~ Force
                 ; Master Access Counter Enable
M MACE EQU 18
M_MWSD EQU 19
                 ; Master Wait States Disable
M_RBLE EQU 20
                ; Receive Buffer Lock Enable
                 ; Insert Address Enable
M_IAE EQU 21
       Host PCI Master Control Register Bit Flags
M_ARH EQU $00ffff ; DSP PCI Transaction Address (High)
M_BL EQU $3f0000 ; PCI Data Burst Length
M_FC EQU $c00000 ; Data Transfer Format Control
       Host PCI Address Register Bit Flags
M_ARL EQU $00ffff ; DSP PCI Transaction Address (Low)
M_C EQU $0f0000
                 ; PCI Bus Command
M_BE EQU $f00000 ; PCI Byte Enables
       DSP Status Register Bit Flags
M_HCP EQU 0
                ; Host Command pending
M STRO EQU 1
                ; Slave Transmit Data Request
M SRRQ EQU 2
                ; Slave Receive Data Request
                ; Host Flag 0-2 Mask
M_HF02 EQU $38
M_HF0 EQU 3
                ; Host Flag 0
```

```
M_HF1 EQU 4 ; Host Flag 1
M_HF2 EQU 5 ; Host Flag 2
          DSP PCI Status Register Bit Flags
M MWS EOU 0
                        ; PCI Master Wait States
M_MTRQ EQU 1 ; PCI Master Transmit Data Request
M_MRRQ EQU 2 ; PCI Master Receive Data Request
M_MARQ EQU 4 ; PCI Master Address Request
M_APER EQU 5 ; PCI Address Parity Error
M_DPER EQU 6 ; PCI Data Parity Error
M_MAB EQU 7 ; PCI Master Abort
M_TAB EQU 8 ; PCI Target Abort
M_TDIS EQU 9 ; PCI Target Disconnect
M_TRTY EQU 10 ; PCI Target Retry
M_TO EQU 11 ; PCI Time Out Termination
M_MTRQ EQU 1
                        ; PCI Master Transmit Data Request
M RDC EQU $3F0000 ; Remaining Data Count Mask (RDC5-RDC0)
M_RDC1 EQU 16 ; Remaining Data Count 0
M_RDC1 EQU 17 ; Remaining Data Count 1
M_RDC2 EQU 18 ; Remaining Data Count 2
M_RDC3 EQU 19 ; Remaining Data Count 3
M_RDC4 EQU 20 ; Remaining Data Count 4
M_RDC5 EQU 21 ; Remaining Data Count 5
M_HACT EQU 23 ; Hi32 Active
 ;______
           EQUATES for Serial Communications Interface (SCI)
 :-----
          Register Addresses
M_STXH EQU $FFFF97 ; SCI Transmit Data Register (high)
M STXM EQU $FFFF96 ; SCI Transmit Data Register (middle)
M STXL EQU $FFFF95 ; SCI Transmit Data Register (low)
M_SRXH EQU $FFFF9A ; SCI Receive Data Register (high)
M_SRXM EQU $FFFF99 ; SCI Receive Data Register (middle)
M_SRXL EQU $FFFF98 ; SCI Receive Data Register (low)
M_STXA EQU $FFFF94 ; SCI Transmit Address Register
M_SCR EQU $FFFF9C ; SCI Control Register
M_SSR EQU $FFFF93 ; SCI Status Register
M_SCCR EQU $FFFF9B ; SCI Clock Control Register
 ; SCI Control Register Bit Flags
M_WDS EQU $7
                     ; Word Select Mask (WDS0-WDS3)
```

```
M_SSFTD EQU 3
                 ; SCI Shift Direction
M_SBK EQU 4
                  ; Send Break
                 ; Receiver Wakeup Enable
M_SCTE EQU 9 ; SCI Transmitter Enable

M_ILIE EQU 10 ; Idle Line Interrupt Enable

M_SCRIE EQU 11 ; SCI Receive Interrupt Enable
                 ; SCI Transmitter Enable
M_SCTIE EQU 12
                 ; SCI Transmit Interrupt Enable
M_TMIE EQU 13
                 ; Timer Interrupt Enable
M_TIR EQU 14
                 ; Timer Interrupt Rate
M_SCKP EQU 15 ; SCI Clock Polarity
M_REIE EQU 16 ; SCI Error Interrupt Enable (REIE)
      SCI Status Register Bit Flags
                 ; Transmitter Empty
M_TRNE EQU 0
                 ; Transmit Data Register Empty
M_TDRE EQU 1
M_RDRF EQU 2
                 ; Receive Data Register Full
M_IDLE EQU 3
                 ; Idle Line Flag
M_OR EQU 4
                 ; Overrun Error Flag
M_PE EQU 5
                 ; Parity Error
              ; Framing Error Flag
M_FE EQU 6
M_R8 EQU 7
                 ; Received Bit 8 (R8) Address
      SCI Clock Control Register
M_CD EQU $FFF ; Clock Divider Mask (CD0-CD11)
M_COD EQU 12 ; Clock Out Divider
M_SCP EQU 13
                 ; Clock Prescaler
M_RCM EQU 14
                 ; Receive Clock Mode Source Bit
M_TCM EQU 15
                 ; Transmit Clock Source Bit
     EQUATES for Synchronous Serial Interface (SSI)
;-----
      Register Addresses Of SSIO
M TX00 EQU $FFFFBC ; SSI0 Transmit Data Register 0
M_TX01 EQU $FFFFBB ; SSIO Transmit Data Register 1
M_TX02 EQU $FFFFBA; SSIO Transmit Data Register 2
M_TSR0 EQU $FFFFB9 ; SSI0 Time Slot Register
M_RX0 EQU $FFFFB8 ; SSI0 Receive Data Register
M_SSISRO EQU $FFFFB7; SSIO Status Register
M_CRBO EQU $FFFFB6 ; SSIO Control Register B
M_CRAO EQU $FFFFB5 ; SSIO Control Register A
M_TSMA0 EQU $FFFFB4; SSI0 Transmit Slot Mask Register A
```

```
M_TSMB0 EQU $FFFFB3; SSI0 Transmit Slot Mask Register B
M_RSMA0 EQU $FFFFB2; SSI0 Receive Slot Mask Register A
M_RSMB0 EQU $FFFFB1; SSI0 Receive Slot Mask Register B
          Register Addresses Of SSI1
M TX10 EQU $FFFFAC ; SSI1 Transmit Data Register 0
M_TX11 EQU $FFFFAB ; SSI1 Transmit Data Register 1
M_TX12 EQU $FFFFAA ; SSI1 Transmit Data Register 2
M_TSR1 EQU $FFFFA9 ; SSI1 Time Slot Register
M_RX1 EQU $FFFFA8 ; SSI1 Receive Data Register
M_SSISR1 EQU $FFFFA7; SSI1 Status Register
M_CRB1 EQU $FFFFA6 ; SSI1 Control Register B
M_CRA1 EQU $FFFFA5 ; SSI1 Control Register A
M_TSMA1 EQU $FFFFA4; SSI1 Transmit Slot Mask Register A
M_TSMB1 EQU $FFFFA3; SSI1 Transmit Slot Mask Register B
M_RSMA1 EQU $FFFFA2; SSI1 Receive Slot Mask Register A
M RSMB1 EQU $FFFFA1; SSI1 Receive Slot Mask Register B
           SSI Control Register A Bit Flags
M_PM EQU $FF
                       ; Prescale Modulus Select Mask (PMO-PM7)
M_PSR EQU 11
                       ; Prescaler Range
M_DC EQU $1F000 ; Frame Rate Divider Control Mask (DC0-DC7)
                      ; Alignment Control (ALC)
M_ALC EQU 18
M_WL EQU $380000 ; Word Length Control Mask (WL0-WL7)
M_SSC1 EQU 22 ; Select SC1 as TR #0 drive enable (SSC1)
          SSI Control Register B Bit Flags
M_OF EQU $3
                        ; Serial Output Flag Mask
M_OF0 EQU 0
                       ; Serial Output Flag 0
M_OF1 EQU 1
                       ; Serial Output Flag 1
                     ; Serial Control Direction Mask
M_SCD EQU $1C
                       ; Serial Control O Direction
M_SCD0 EQU 2
M_SCD0 EQU 2 ; Serial Control 0 Direction

M_SCD1 EQU 3 ; Serial Control 1 Direction

M_SCD2 EQU 4 ; Serial Control 2 Direction

M_SCKD EQU 5 ; Clock Source Direction

M_SHFD EQU 6 ; Shift Direction

M_FSL EQU $180 ; Frame Sync Length Mask (FSL0-FSL1)

M_FSL0 EQU 7 ; Frame Sync Length 0

M_FSL1 EQU 8 ; Frame Sync Length 1

M_FSR EQU 9 ; Frame Sync Relative Timing

M_FSP EQU 10 ; Frame Sync Polarity

M_CKP EQU 11 ; Clock Polarity

M_SYN EQU 12 ; Sync/Async Control
M_SSTE EQU $1C000 ; SSI Transmit enable Mask
M_SSTE2 EQU 14 ; SSI Transmit #2 Enable
M_SSTE1 EQU 15 ; SSI Transmit #1 Enable
M_SSTE0 EQU 16 ; SSI Transmit #0 Enable
M_SSRE EQU 17 ; SSI Receive Enable
M_SSTIE EQU 18 ; SSI Transmit Interrupt Enable
M_SSRIE EQU 19 ; SSI Receive Interrupt Enable
```

```
M_STLIE EQU 20 ; SSI Transmit Last Slot Interrupt Enable
M_SRLIE EQU 21 ; SSI Receive Last Slot Interrupt Enable
M_STEIE EQU 22 ; SSI Transmit Error Interrupt Enable
M_SREIE EQU 23 ; SSI Receive Error Interrupt Enable
; SSI Status Register Bit Flags
M_IF EQU $3
                    ; Serial Input Flag Mask
M_IF0 EQU 0
                    ; Serial Input Flag 0
M_IF1 EQU 1
                    ; Serial Input Flag 1
M_TFS EQU 2
                    ; Transmit Frame Sync Flag
M_RFS EQU 3 ; Receive Frame Sync Flag
M_TUE EQU 4 ; Transmitter Underrun Error FLag
M_ROE EQU 5 ; Receiver Overrun Error Flag
M_TDE EQU 6 ; Transmit Data Register Empty
M_RDF EQU 7 ; Receive Data Register Full
; SSI Transmit Slot Mask Register A
M_SSTSA EQU $FFFF ; SSI Transmit Slot Bits Mask A (TS0-TS15)
       SSI Transmit Slot Mask Register B
M_SSTSB EQU $FFFF ; SSI Transmit Slot Bits Mask B (TS16-TS31)
       SSI Receive Slot Mask Register A
M_SSRSA EQU $FFFF ; SSI Receive Slot Bits Mask A (RS0-RS15)
         SSI Receive Slot Mask Register B
M_SSRSB EQU $FFFF ; SSI Receive Slot Bits Mask B (RS16-RS31)
;-----
; EQUATES for Exception Processing
;-----
       Register Addresses
M_IPRC EQU $FFFFFF ; Interrupt Priority Register Core
M_IPRP EQU $FFFFFE; Interrupt Priority Register Peripheral
       Interrupt Priority Register Core (IPRC)
M_IAL EQU $7 ; IRQA Mode Mask
```

```
M_IALO EQU 0  ; IRQA Mode Interrupt Priority Level (low)
M_IAL1 EQU 1  ; IRQA Mode Interrupt Priority Level (high)
M_IAL2 EQU 2  ; IRQA Mode Trigger Mode

M_IBL EQU $38  ; IRQB Mode Mask

M_IBLO EQU 3  ; IRQB Mode Interrupt Priority Level (low)
M_IBL1 EQU 4  ; IRQB Mode Interrupt Priority Level (high)
M_IBL2 EQU 5  ; IRQB Mode Trigger Mode

M_ICL EQU $1C0  ; IRQC Mode Mask

M_ICLO EQU 6  ; IRQC Mode Interrupt Priority Level (low)
M_ICL1 EQU 7  ; IRQC Mode Interrupt Priority Level (high)
M_ICL2 EQU 8  ; IRQC Mode Trigger Mode

M_IDL EQU $200  ; IRQD Mode Mask

M_IDLO EQU 9  ; IRQD Mode Interrupt Priority Level (low)
M_IDL1 EQU 10  ; IRQD Mode Interrupt Priority Level (high)
M_IDL2 EQU 11  ; IRQD Mode Trigger Mode

M_DOL EQU $3000  ; DMAO Interrupt Priority Level Mask

M_DOLO EQU 12  ; DMAO Interrupt Priority Level (low)
 M_IALO EQU 0
                                    ; IRQA Mode Interrupt Priority Level (low)
M_D0L0 EQU 12 ; DMA0 Interrupt Priority Level (low)
M_D0L1 EQU 13 ; DMA0 Interrupt Priority Level (high)
M_D1L EQU $C000 ; DMA1 Interrupt Priority Level Mask
M_D1L0 EQU 14 ; DMA1 Interrupt Priority Level (low)
M_D1L1 EQU 15 ; DMA1 Interrupt Priority Level (high)
 M_D2L EQU $30000 ; DMA2 Interrupt priority Level Mask
 M_D2L0 EQU 16 ; DMA2 Interrupt Priority Level (low)
M_D2L1 EQU 17 ; DMA2 Interrupt Priority Level (high)
 M_D3L EQU $C0000 ; DMA3 Interrupt Priority Level Mask
 M_D4L EQU $300000 ; DMA4 Interrupt priority Level Mask
 M_D4L0 EQU 20 ; DMA4 Interrupt Priority Level (low)
M_D4L1 EQU 21 ; DMA4 Interrupt Priority Level (high)
 M_D5L EQU $C00000 ; DMA5 Interrupt priority Level Mask
 M_D5L0 EQU 22 ; DMA5 Interrupt Priority Level (low)
 M_D5L1 EQU 23
                                     ; DMA5 Interrupt Priority Level (high)
                  Interrupt Priority Register Peripheral (IPRP)
M HPL EQU $3 ; Host Interrupt Priority Level Mask
```

```
EQUATES for TIMER
;-----
       Register Addresses Of TIMERO
M_TCSR0 EQU $FFFF8F; TIMER0 Control/Status Register
M_TLR0 EQU $FFFF8E ; TIMER0 Load Reg
M_TCPR0 EQU $FFFF8D; TIMER0 Compare Register
M_TCR0 EQU $FFFF8C ; TIMER0 Count Register
       Register Addresses Of TIMER1
M_TCSR1 EQU $FFFF8B; TIMER1 Control/Status Register
M_TLR1 EQU $FFFF8A ; TIMER1 Load Reg
M_TCPR1 EQU $FFFF89; TIMER1 Compare Register
M_TCR1 EQU $FFFF88 ; TIMER1 Count Register
        Register Addresses Of TIMER2
M_TCSR2 EQU $FFFF87; TIMER2 Control/Status Register
M TLR2 EOU $FFFF8 ; TIMER2 Load Reg
M_TCPR2 EQU $FFFF85; TIMER2 Compare Register
M_TCR2 EQU $FFFF84 ; TIMER2 Count Register
M_TPLR EQU $FFFF83 ; TIMER Prescaler Load Register
M_TPCR EQU $FFFF82 ; TIMER Prescalar Count Register
      Timer Control/Status Register Bit Flags
                 ; Timer Enable
M_TE EQU 0
M_TOIE EQU 1 ; Timer Overtiow Interior:

M_TCIE EQU 2 ; Timer Compare Interrupt Enable

: Timer Control Mask (TC0-TC3)
                 ; Timer Overflow Interrupt Enable
                 ; Inverter Bit
M_INV EQU 8
M_TRM EQU 9
                  ; Timer Restart Mode
                 ; Direction Bit
M_DIR EQU 11
M_DI EQU 12
                 ; Data Input
M_DO EQU 13
                 ; Data Output
M_PCE EQU 15
                 ; Prescaled Clock Enable
M_TOF EQU 20
                  ; Timer Overflow Flag
M_TCF EQU 21
                 ; Timer Compare Flag
      Timer Prescaler Register Bit Flags
M_PS EQU $600000 ; Prescaler Source Mask
M_PS0 EQU 21
```

```
M_PS1 EQU 22
       Timer Control Bits
M\_TC0 EQU 4 ; Timer Control 0
M_TC1 EQU 5 ; Timer Control 1
M_TC2 EQU 6 ; Timer Control 2
M_TC3 EQU 7 ; Timer Control 3
;-----
      EQUATES for Direct Memory Access (DMA)
      Register Addresses Of DMA
M_DSTR EQU $FFFFFF4 ; DMA Status Register
M_DORO EQU $FFFFF3 ; DMA Offset Register 0
M_DOR1 EQU $FFFFFF2 ; DMA Offset Register 1
M_DOR2 EQU $FFFFF1 ; DMA Offset Register 2
M_DOR3 EQU $FFFFF0 ; DMA Offset Register 3
       Register Addresses Of DMA0
M_DSR0 EQU $FFFFEF; DMA0 Source Address Register
M_DDR0 EQU $FFFFEE; DMA0 Destination Address Register
M_DCOO EQU $FFFFED ; DMAO Counter
M_DCR0 EQU $FFFFEC ; DMA0 Control Register
      Register Addresses Of DMA1
M_DSR1 EQU $FFFFEB ; DMA1 Source Address Register
M_DDR1 EQU $FFFFEA ; DMA1 Destination Address Register
M_DC01 EQU $FFFFE9 ; DMA1 Counter
M_DCR1 EQU $FFFFE8 ; DMA1 Control Register
       Register Addresses Of DMA2
M_DSR2 EQU $FFFFE7 ; DMA2 Source Address Register
M_DDR2 EQU $FFFFE6 ; DMA2 Destination Address Register
M_DCO2 EQU $FFFFE5 ; DMA2 Counter
M_DCR2 EQU $FFFFE4 ; DMA2 Control Register
      Register Addresses Of DMA4
M_DSR3 EQU $FFFFE3 ; DMA3 Source Address Register
M DDR3 EQU $FFFFE2; DMA3 Destination Address Register
M_DCO3 EQU $FFFFE1 ; DMA3 Counter
M_DCR3 EQU $FFFFE0 ; DMA3 Control Register
```

```
Register Addresses Of DMA4
M_DSR4 EQU $FFFFDF ; DMA4 Source Address Register
M DDR4 EQU $FFFFDE ; DMA4 Destination Address Register
M_DCO4 EQU $FFFFDD ; DMA4 Counter
M_DCR4 EQU $FFFFDC ; DMA4 Control Register
       Register Addresses Of DMA5
M DSR5 EQU $FFFFDB ; DMA5 Source Address Register
M_DDR5 EQU $FFFFDA ; DMA5 Destination Address Register
M_DCO5 EQU $FFFFD9 ; DMA5 Counter
M_DCR5 EQU $FFFFD8 ; DMA5 Control Register
         DMA Control Register
M_DSS EQU $3
                 ; DMA Source Space Mask (DSS0-Dss1)
M_DSS0 EQU 0
                 ; DMA Source Memory space 0
M_DSS1 EQU 1
                 ; DMA Source Memory space 1
M_DDS EQU $C
                ; DMA Destination Space Mask (DDS-DDS1)
M_DDS0 EQU 2
                 ; DMA Destination Memory Space 0
M_DDS1 EQU 3
                ; DMA Destination Memory Space 1
M_DAM EQU $3F0 ; DMA Address Mode Ma
M_DAMO EQU 4 ; DMA Address Mode 0
M_DAM1 EQU 5 ; DMA Address Mode 1
M_DAM2 EQU 6 ; DMA Address Mode 2
                 ; DMA Address Mode Mask (DAM5-DAM0)
M DAM3 EOU 7
                 ; DMA Address Mode 3
                ; DMA Address Mode 4
M_DAM4 EQU 8
                 ; DMA Address Mode 5
M_DAM5 EQU 9
M_D3D EQU 10 ; DMA Three Dimensional Mode
M_DPR EQU $60000 ; DMA Channel Priority
M_DPR1 EQU 18
                  ; DMA Channel Priority Level (high)
M_DTM EQU $380000 ; DMA Transfer Mode Mask (DTM2-DTM0)
M_DTM0 EQU 19 ; DMA Transfer Mode 0
M DTM1 EQU 20
                ; DMA Transfer Mode 1
                ; DMA Transfer Mode 2
M_DTM2 EQU 21
                 ; DMA Interrupt Enable bit
M DIE EQU 22
M DE EQU 23
                 ; DMA Channel Enable bit
       DMA Status Register
M_DTD EQU $3F
                 ; Channel Transfer Done Status MASK (DTD0-DTD5)
                  ; DMA Channel Transfer Done Status 0
M DTD0 EQU 0
M_DTD1 EQU 1
                 ; DMA Channel Transfer Done Status 1
M_DTD2 EQU 2
                 ; DMA Channel Transfer Done Status 2
M DTD3 EQU 3
                 ; DMA Channel Transfer Done Status 3
                 ; DMA Channel Transfer Done Status 4
M DTD4 EQU 4
M_DTD5 EQU 5
                 ; DMA Channel Transfer Done Status 5
M DACT EQU 8 ; DMA Active State
```

```
M_DCH EQU $E00 ; DMA Active Channel Mask (DCH0-DCH2)
M_DCH0 EQU 9 ; DMA Active Channel 0
M_DCH1 EQU 10 ; DMA Active Channel 1
M_DCH2 EQU 11 ; DMA Active Channel 2
;------
        EQUATES for Phase Lock Loop (PLL)
      Register Addresses Of PLL
M_PCTL EQU $FFFFFD ; PLL Control Register
; PLL Control Register
\label{eq:mmf} $\tt M\_MF EQU \$FFF \qquad ; Multiplication Factor Bits Mask (MF0-MF11)
M_DF EQU $7000
                  ; Division Factor Bits Mask (DF0-DF2)
M_XTLR EQU 15 ; XTAL Range select bit
M_XTLD EQU 16 ; XTAL Disable Bit
M_PSTP EQU 17 ; STOP Processing State Bit
M_PEN EQU 18 ; PLL Enable Bit
M_PCOD EQU 19 ; PLL Clock Output Disable Bit
M PD EOU $F00000 ; PreDivider Factor Bits Mask (PD0-PD3)
       EQUATES for BIU
;-----
      Register Addresses Of BIU
M_BCR EQU $FFFFFB ; Bus Control Register
M_DCR EQU $FFFFFA ; DRAM Control Register
M_AARO EQU $FFFFF9 ; Address Attribute Register 0
M_AAR1 EQU $FFFFF8 ; Address Attribute Register 1
M_AAR2 EQU $FFFFFF7 ; Address Attribute Register 2
M_AAR3 EQU $FFFFF6 ; Address Attribute Register 3
M_IDR EQU $FFFFF5 ; ID Register
; Bus Control Register
```

```
M_BA2W EQU $1C00 ; Area 2 Wait Control Mask (BA2W0-BA2W2)
M_BA3W EQU $E000 ; Area 3 Wait Control Mask (BA3W0-BA3W3)
M_BDFW EQU $1F0000 ; Default Area Wait Control Mask (BDFW0-BDFW4)
M_BBS EQU 21 ; Bus State
M BLH EQU 22
                ; Bus Lock Hold
M BRH EQU 23
               ; Bus Request Hold
       DRAM Control Register
M_BCW EQU $3
                ; In Page Wait States Bits Mask (BCW0-BCW1)
M BRW EQU $C
                ; Out Of Page Wait States Bits Mask (BRW0-BRW1)
M_BPS EQU $300
                ; DRAM Page Size Bits Mask (BPS0-BPS1)
M_BPLE EQU 11
                ; Page Logic Enable
               ; Mastership Enable
M BME EQU 12
M_BRF EQU $7F8000 ; Refresh Rate Bits Mask (BRF0-BRF7)
             ; Refresh prescaler
M BRP EQU 23
       Address Attribute Registers
M_BAT EQU $3
                ; External Access Type and Pin Definition Bits Mask
(BAT0-BAT1)
M_BAAP EQU 2
                ; Address Attribute Pin Polarity
M_BPEN EQU 3
                ; Program Space Enable
               ; X Data Space Enable
M BXEN EQU 4
M BYEN EQU 5
               ; Y Data Space Enable
M BAM EOU 6
                ; Address Muxing
M_BAC EQU $FFF000 ; Address to Compare Bits Mask (BAC0-BAC11)
       control and status bits in SR
M_CP EQU $c00000 ; mask for CORE-DMA priority bits in SR
M_CA EQU 0
                ; Carry
                ; Overflow
M_V EQU 1
M Z EQU 2
                ; Zero
M N EQU 3
                ; Negative
M_U EQU 4
                ; Unnormalized
                ; Extension
M E EQU 5
M_L EQU 6
                ; Limit
M_S EQU 7
                ; Scaling Bit
M_IO EQU 8
               ; Interupt Mask Bit 0
M_I1 EQU 9
                ; Interupt Mask Bit 1
M_S0 EQU 10
               ; Scaling Mode Bit 0
               ; Scaling Mode Bit 1
M_S1 EQU 11
             ; Sixteen_Bit Compatibility; Double Precision Multiply; DO-Loop Flag
M_SC EQU 13
M_DM EQU 14
M_LF EQU 15
               ; DO-Forever Flag
M_FV EQU 16
M_SA EQU 17
               ; Sixteen-Bit Arithmetic
M CE EQU 19 ; Instruction Cache Enable
```

```
; Arithmetic Saturation
M_SM EQU 20
                 ; Rounding Mode
; bit 0 of priority bits in SR
; bit 1 of ---
M_RM EQU 21
M_CP0 EQU 22
                      ; bit 1 of priority bits in SR
M_CP1 EQU 23
         control and status bits in OMR
M_CDP EQU $300 ; mask for CORE-DMA priority bits in OMR
M_MA EQU 0 ; Operating Mode A
M_MB EQU 1 ; Operating Mode B
M_MC EQU 2 ; Operating Mode C
M_MD EQU 3 ; Operating Mode D
M_EBD EQU 4 ; External Bus Disable bit in OMR
M_SD EQU 6 ; Stop Delay
M_CDP0 EQU 8 ; bit 0 of priority bits in OMR
M_CDP1 EQU 9 ; bit 1 of priority bits in OMR
M_BEN EQU 10 ; Burst Enable
M_TAS EQU 11 ; TA Synchronize Select
M_BRT EQU 12 ; Bus Release Timing
M_XYS EQU 16 ; Stack Extension space select bit in OMR.
M_EUN EQU 17 ; Extensed stack UNderflow flag in OMR.
M_EOV EQU 18 ; Extended WRAP flag in OMR.
M_WRP EQU 19 ; Extended WRAP flag in OMR.
                   ; mask for CORE-DMA priority bits in OMR
M_CDP EQU $300
                   ; Extended WRaP flag in OMR.
M_WRP EQU 19
M_SEN EQU 20
                      ; Stack Extension Enable bit in OMR.
 * *
 ;
 ;
        EQUATES for DSP56301 interrupts
       Reference: DSP56301 Specifications Revision 3.00
        Last update: November 15 1993 (Debug request & HI32 interrupts)
                        December 19 1993 (cosmetic - page and opt directives)
                        August 16 1994 (change interrupt addresses to be
                                   relative to I_VEC)
 page 132,55,0,0,0
            opt
                      mex
 intequ ident 1,0
            if @DEF(I_VEC)
            ; leave user definition as is.
                       $0
 I_VEC
            equ
            endif
 ; Non-Maskable interrupts
 ;-----
```

```
I_RESET EQU I_VEC+$00 ; Hardware RESET
I_STACK EQU I_VEC+$02 ; Stack Error
I TRAP EQU I VEC+$08 ; Trap
I NMI EQU I VEC+$0A ; Non Maskable Interrupt
;-----
; Interrupt Request Pins
I_IRQA EQU I_VEC+$10 ; IRQA
I_IRQB EQU I_VEC+$12 ; IRQB
I_IRQC EQU I_VEC+$14 ; IRQC
I_IRQD EQU I_VEC+$16 ; IRQD
;-----
; DMA Interrupts
;-----
EQU I_VEC+$1A
                ; DMA Channel 1
I_DMA1
    EQU I_VEC+$1C ; DMA Channel 2
I_DMA2
I_DMA3      EQU      I_VEC+$1E      ; DMA Channel 3
I_DMA4 EQU I_VEC+$20 ; DMA Channel 4
I DMA5 EOU I VEC+$22 ; DMA Channel 5
;-----
; Timer Interrupts
;-----
I_TIMOC EQU I_VEC+$24 ; TIMER 0 compare
I_TIMOOF EQU I_VEC+$26  ; TIMER 0 overflow
I_TIM1C EQU I_VEC+$28 ; TIMER 1 compare
I_TIM1OF EQU I_VEC+$2A ; TIMER 1 overflow
I_TIM2C EQU I_VEC+$2C ; TIMER 2 compare
I_TIM2OF EQU I_VEC+$2E ; TIMER 2 overflow
;-----
; ESSI Interrupts
I_SIORD EQU I_VEC+$30  ; ESSIO Receive Data
I SIORDE EQU I VEC+$32 ; ESSIO Receive Data With Exception Status
I_SIORLS EQU I_VEC+$34   ; ESSIO Receive last slot
I_SIOTD EQU I_VEC+$36  ; ESSIO Transmit data
I_SIOTDE EQU I_VEC+$38 ; ESSIO Transmit Data With Exception Status
```

```
I_SIOTLS EQU I_VEC+$3A ; ESSIO Transmit last slot
I_SI1RD EQU I_VEC+$40    ; ESSI1 Receive Data
I_SI1RDE EQU I_VEC+$42    ; ESSI1 Receive Data With Exception Status
I_SI1RLS EQU I_VEC+$44   ; ESSI1 Receive last slot
I_SI1TD EQU I_VEC+$46 ; ESSI1 Transmit data
I_SI1TDE EQU I_VEC+$48 ; ESSI1 Transmit Data With Exception Status
I_SI1TLS EQU I_VEC+$4A  ; ESSI1 Transmit last slot
; SCI Interrupts
;-----
I_SCIRD EQU I_VEC+$50 ; SCI Receive Data
I_SCIRDE EQU I_VEC+$52 ; SCI Receive Data With Exception Status
I_SCITD EQU I_VEC+$54 ; SCI Transmit Data
I_SCIIL EQU I_VEC+$56 ; SCI Idle Line
I_SCITM EQU I_VEC+$58 ; SCI Timer
;______
; HOST Interrupts
;-----
I_HPTT EQU I_VEC+$60 ; Host PCI Transaction Termination
I_HPTA EQU I_VEC+$62 ; Host PCI Transaction Abort
I_HPPE EQU I_VEC+$64 ; Host PCI Parity Error
I HPTC EOU I VEC+$66 ; Host PCI Transfer Complete
I_HSR EQU I_VEC+$6A ; Host Slave Receive I_HPMT EQU I_VEC+$6C ; Host PCI Master Transmit
I_HCNMI EQU I_VEC+$72  ; Host Command/Host NMI (Default)
; INTERRUPT ENDING ADDRESS
;-----
I_INTEND EQU I_VEC+$FF ; last address of interrupt vector space
```



APPENDIX B

DSP56301 BOOSTRAP CODE LISTING

```
; BOOTSTRAP CODE FOR DSP56301 - (C) Copyright 1996 Motorola Inc.
; Revised June 18, 1996.
; Bootstrap through the Host Interface, External EPROM or SCI.
; This is the Bootstrap program contained in the DSP56301 192-word Boot
; ROM. This program can load any program RAM segment from an external
; EPROM, from the Host Interface or from the SCI serial interface.
; If MD:MC:MB:MA=x000, then the Boot ROM is bypassed and the DSP56301
; will start fetching instructions beginning with address $C00000 (MD=0)
; or $008000 (MD=1) assuming that an external memory of SRAM type is
; used. The accesses will be performed using 31 wait states with no address
; attributes selected (default area).
; If MD:MC:MB:MA=x001, then it loads a program RAM segment
; consecutive byte-wide P memory locations, starting at P:$D00000 (bits
; 7-0). The memory is selected by the Address Attribute AA1 and is
; accessed with 31 wait states.
; The EPROM bootstrap code expects first to read 3 bytes specifying the
; number of program words, afterwards 3 bytes specifying the address to
; start loading the program words and then 3 bytes for each program word
; to be loaded. The number of words, the starting address and the program
; words are read least significant byte first followed by the mid and
; then by the most significant byte.
; The program words will be condensed into 24-bit words and stored in
; contiguous PRAM memory locations starting at the specified starting
; address. After reading the program words, program execution starts
; from the same address where loading started.
; If MD:MC:MB:MA=x010, then it loads the program RAM from the SCI interface.
```

```
; The SCI bootstrap code expects first to receive 3 bytes specifying the
; number of program words, afterwards 3 bytes specifying the address to
; start loading the program words and then 3 bytes for each program word
; to be loaded. The number of words, the starting address and the program
; words are received least significant byte first followed by the mid and
; then by the most significant byte.
; The program words will be condensed into 24-bit words and stored in
; contiguous PRAM memory locations starting at the specified starting
           After reading the program words, program execution starts
; from the same address where loading started.
; The SCI is programmed to work in asynchronous mode with 8 data bits, 1
; stop bit and no parity. The clock source is external and the clock
; frequency must be 16x the baud rate. After each byte is received, it
; is echoed back through the SCI transmitter.
; If MD:MC:MB:MA=x011, then it loads the program RAM from the Host Interface
; programmed to operate in the Universal Bus mode supporting 56301-to-56301
; glue less connection.
; The HI32 bootstrap code expects first to read a 24-bit word specifying
; the number of program words, afterwards a 24-bit word specifying the
; address to start loading the program words and then 24-bit word for
; each program word to be loaded.
; The
                                          in contiguous
                words
                       will
                             be
                                 stored
       program
                                                          PRAM
; locations
             starting
                       at the
                                 specified starting
                                                     address.
                                                                 After
; reading the program words,
                              program execution starts from the same
; address where loading started.
; The Host Interface bootstrap load program may be stopped by setting the
; Host Flag 0 (HF0) in HCTR register. This will start execution of the
; loaded program from the specified starting address.
; During the access, the HAEN and HA10-HA3 pins must be driven low; pins
; HA2-HA0 select the HI32 registers.
; Before booting through the Host Interface it is recommended that the
; Host boot program will verify that the HI32 is operational, by reading
; the status register (HSTR) and confirm that its value is $3.
; Suggested 56301-to-56301 connection:
   slave master
;
   56301/HI32 56301/PortA
```

```
;
   HA[10:3] <- A[10:3]
                             ; selects HI32 (base address 00000000)
;
   HA[2:0]
            <- A[2:0]
                              ; selects HTXR registers
   HD[24:0]
             <-> D[24:0]
                              ; Data bus
;
                             ; Bus Strobe (optional, see Notel)
;
   HBS
             <- BS_
                             ; DMA cycle disable (AAx is active low)
   HAEN
             <- AAx
;
;
   HTA
             -> TA
                             ; Transfer Acknowledge (optional, see Note2)
                            ; Interrupt Request (active low, open drain)
;
   HIRO
             -> IRQx_
   HWR_
             <- WR_
                             ; Write strobe
   HRD
             <- RD
                              ; Read strobe
   HRST
             <- system reset ; Reset (active low)
; Pins HP31, HP32 and HDAK_ must be tied to Vcc. Pins HP[22:20] may be
; used as GPIO pins. Pin HINTA_ may be used as software driven interrupt
; request pin.
; Notel: If HBS_ to BS_ connection is used, the synchronous connection of
; the HI32 is used and therefore the 56301/master should access the
; 56301/slave as SRAM with 2 wait states.
                                           In addition the CLKOUT of
; 56301/master should be connected to EXTAL of 56301/slave, and both
; master and slave should enable the PLL while in the case of slave
; multiplication,
                 division and pre-division factors should be one to
; guarantee synchronization between master and slave.
; In the case of asynchronous connection, HBS_ must be tied to Vcc.
; Note2: If HTA to HTA_ connection is not used, it is recommended that
; the HOST Processor's boot program will verify that the Host Interface
; is ready, by reading the status register (HSTR) and confirm that TRDY=1
; or HTRQ=1.
; If MD:MC:MB:MA=x100, then it loads the program RAM from the Host
; Interface programmed to operate in the PCI target (slave) mode.
; The HI32 bootstrap code expects first to read a 24-bit word specifying
; the number of program words, afterwards a 24-bit word specifying the
; address to start loading the program words and then 24-bit word for
; each program word to be loaded.
; The
       program
                words
                     will
                             be
                                  stored
                                          in contiguous
                                                          PRAM
; locations
                       at the
                                           starting
             starting
                                 specified
                                                      address.
                                                                 After
; reading the program words, program execution starts from the same
; address where loading started.
; The Host Interface bootstrap load program may be stopped by setting the
; Host Flag 0 (HF0) in HCTR register. This will start execution of the
```

```
; loaded program from the specified starting address.
; The HOST Processor must first configure the Host Interface as PCI slave
; and then start writing data to the Host Interface. The HOST Processor
; must program the HCTR HTF1-HTF0
                                   bits as 01,
                                                   10 or 11 and then
; correspondingly drive the 24-bit data mapped into 32-bit PCI bus word.
; Note that for the synchronization purposes, the DSP to PCI clock ratio
; should be more then 5/3.
; If MD:MC:MB:MA=x101, then it loads the program RAM from the Host
; Interface programmed to operate in the Universal Bus mode supporting
; ISA (slave) glue less connection.
; Using self configuration mode, the base address in CBMA is initially
; written with $2f which corresponds to an ISA HTXR address of $2fe
; (Serial Port 2 Modem Status read only register).
; The HI32 bootstrap code expects to read 32 consecutive times the "magic
; number" $0037. Subsequently the bootstrap code expects to read a 16-bit word
; which is the designated ISA Port Address; this address is written into the
; CBMA. The HOST Processor must poll for the Host Interface to be re-configured.
; This must be done by reading the HSTR and verifying that the value $0013 is
; read. From this moment the HOST Processor may start writing data to the
; Host Interface.
; The HI32 bootstrap code expects first to read a 24-bit word (see
; Note below)
               specifying the number of program words,
                                                           afterwards a
                          the address
                                        to start loading
; 24-bit word specifying
                                                            the program
; words and then 24-bit word for each program word to be loaded.
       program
                words
                       will
                              be
                                   stored
                                           in contiquous
                                                           PRAM
                                                                  memory
                                             starting
; locations
             starting at
                            the
                                  specified
                                                      address.
; reading the program words,
                               program execution starts from the same
; address where loading started.
; The Host Interface bootstrap load program may be stopped by setting the
; Host Flag 0 (HF0) in HCTR register. This will start execution of the
; loaded program from the specified starting address.
; Note: This ISA connection implies 16 bit data width access only and
; that the number of 16-bit wide words that are transferred must be
; even.
; The 24-bit words has to be packed into 16-bit ISA words and then sent
```

```
; by the HOST Processor in the following sequence:
     MO
         | L0
      L1 |
            H0
     H1 | M1
; The boot program will convert every three 16-bit wide host words to two
; 24-bit wide 56301 opcodes in the following format:
      H0
            MO |
                  L0
      H1 | M1
; The Host Processor must program the Host Interface to operate in the
; zero fill mode (HTF1-HTF0 = 01 in HCTR).
; Suggested 56301 to ISA connection:
;
   HA[10] <- SBHE_
                            ; selects HI32 (base address 10011111)
;
                            ; selects HI32 (base address 10011111)
;
   HA[9]
          <- SA[0]
   HA[8:3] <- SA[9:4]
                           ; selects HI32 (base address 10011111)
   HA[2:0] <- SA[3:1]
                             ; selects HTXR registers
   HD[15:0] - SD[15:0]
                            ; Data bus
   HD[23:16] - Not connected ; High Data Bus - Should be pulled up or down
   HDBEN -> OE
                           ; Output enable of transceivers
          -> DIR
                            ; Direction of transceivers
   HDBDR
   HSAK_
          -> IO16_
                           ; 16 bit data word
          <- Vcc
                            ; Bus Strobe disabled
   HBS
   HAEN <- AEN
                            ; DMA cycle enable
;
         -> CHRDY
                           ; Channel ready
   HTA
   HWR_
          <- IOWC_
                            ; IO/DMA write strobe
;
          <- IORC
                            ; IO/DMA read strobe
   HRD_
   HRST
          <- inverted RSTDRV ; invert ISA reset
;
; If MD:MC:MB:MA=x110, then it loads the program RAM from the Host
; Interface programmed to operate in the Universal Bus (UB) mode, in
; double-strobe pin configuration.
; The HI32 bootstrap code expects first to receive 3 bytes specifying the
; number of program words, afterwards 3 bytes specifying the address to
; start loading the program words and then 3 bytes for each program word
; to be loaded. The number of words, the starting address and the program
; words are received least significant byte first followed by the mid and
; then by the most significant byte.
; The program words will be condensed into 24-bit words and stored in
```

```
; contiguous PRAM memory locations starting at the specified starting
            After reading the program words, program execution starts
; address.
; from the same address where loading started.
; The Host Interface bootstrap load program may be stopped by setting the
; Host Flag 0 (HF0) in HCTR register. This will start execution of the
; loaded program from the specified starting address.
; The user must externally decode the port address with active low logic and
; connect the select line to HAEN; all the address lines shall be pulled down
; except for HA3, HA2 and HA1 that select the HOST Interface registers.
; When booting through the Host Interface it is recommended that the Host
; boot program will verify that the Host Interface is operational, by
; reading the status register (HSTR) and confirm that TRDY=1.
; When booting through the Host Interface, it is recommended that the
; HOST Processor's boot program will verify that the Host Interface is
; ready, by reading the status register (HSTR) and confirm that TRDY=1
; or HTRQ=1.
; If MD:MC:MB:MA=x111,
                      then it loads the program RAM from the Host
; Interface programmed to operate in the Universal Bus
                                                         (UB) mode, in
; single-strobe pin configuration.
; Other than the single-strobe pin configuration, this mode is identical to
; the double-strobe pin configuration UB mode (MD:MC:MB:MA=x110).
BOOT
               $D00000
                              ; this is the location in P memory
       eau
                              ; on the external memory bus
                              ; where the external byte-wide
                              ; EPROM would be located
AARV
               $D00409
                              ; AAR1 selects the EPROM as CE~
       equ
                              ; mapped as P from $D00000 to
                              ; $DFFFFF, active low
M_SSR
       EQU
               $FFFF93
                              ; SCI Status Register
                              ; SCI Transmit Data Register (low)
M_STXL EQU
               $FFFF95
                             ; SCI Receive Data Register (low)
M_SRXL EQU
               $FFFF98
M_SCCR EQU
               $FFFF9B
                             ; SCI Clock Control Register
M_SCR
       EQU
               $FFFF9C
                             ; SCI Control Register
M PCRE EQU
               $FFFF9F
                             ; Port E Control register
                             ; DSP Control Register (DCTR)
M_DCTR EQU
               $FFFFC5
```

```
M_DPMC EQU
                            ; DSP PCI Master Control Register (DPMC)
              $FFFFC7
                            ; DSP PCI Address Register (DPAR)
M_DPAR EQU
              $FFFFC8
M_DSR
      EQU
              $FFFFC9
                             ; DSP Status Register (DSR)
M_DRXR EQU
                             ; DSP Receive Data FIFO (DRXR)
              $FFFFCB
                            ; Address Attribute Register 1
M_AAR1 EQU
              $FFFFF8
       ORG PL:$ff0000,PL:$ff0000
                                  ; bootstrap code starts at $ff0000
START
       jclr #3,omr,CONT
                             ; If MD:MC:MB:MA=xxxx continue boot
CONT
       clr a #$0a,X0
                             ; clear a and load X0 with constant $0a0000
programmimqve #$3e,x1
                             ; X1=$3E0000 prepare for UB mode host
                             ; HM=$3 (UB)
                             ; HIRD=1 (HIRQ_ pin - drive high enabled)
                             ; HIRH=1 (HIRQ_ pin - handshake enabled)
                             ; HRSP=1 (HRST pin - active low)
                             ; HTAP=0 (HTA pin - active high)
                             ; HDSM=0 (Double-strobe pin mode enabled)
       jclr #2,omr,EPRSCILD
                             ; If MD:MC:MB:MA=x0xx,
                             ; go load from EPROM/SCI/56301-56301
       jclr #1,omr,IHOSTLD
                             ; If MD:MC:MB:MA=x10x, go load from PCI/ISA HOST
       jclr #0,omr,UB2HOSTLD ; If MD:MC:MB:MA=x110, go load from
                              ; double-strobe UB Host
                             ; If MD:MC:MB:MA=x111, go load from
                              ;single-strobe UB Host
; This is the routine that loads from the Host Interface in UB (UNIVERSAL) mode,
; with single-strobe pin configuration (RD/WR,DS).
; MD:MC:MB:MA=x111 - Host UB
UB1HOSTLD
  bset #13,x1
                        ; HDSM=1 (Double-strobe pin mode disabled)
; This is the routine that loads from the Host Interface in UB (UNIVERSAL) mode,
; with double-strobe pin configuration (RD,WR).
; MD:MC:MB:MA=x110 - Host UB
UB2HOSTLD
        movep x1, X:M_DCTR; Configure HI32 in UB mode Single or Double strobe
       do #6,_LOOP0
                            ; read # of words and start address
       jclr #2,X:M_DSR,*
                            ; Wait for SRRQ to go high (i.e. data ready)
       movep X:M_DRXR,a2
       asr #8,a,a
                             ; Shift 8 bit data into A1
LOOP0
```

```
; starting address for load
       move a1,r0
                             ; save it in r1
       move al,rl
                             ; a0 holds the number of words
; Download P memory through UB
       do a0, LOOP1
                             ; Load instruction words
       do #3,_LOOP2
                            ; for each byte
_LBLA
       jset #2,X:M DSR, LBLB; Wait for SRRQ to go high (i.e. data ready)
       jclr #3,X:M_DSR,_LBLA ; If HF0=1, stop loading new data.
                             ; Must terminate the do loop
       enddo
       bra <TERMINATE
                            ; Terminate loop (enddo) and finish
_LBLB
                            ; Store 16-bit data in accumulator
       movep X:M_DRXR,a2
                             ; Shift 8 bit data into Al
       asr #8,a,a
                             ; and go get another 24-bit word.
_LOOP2
       movem al,p:(r0)+
                            ; Store 24-bit data in P mem
                             ; movem cannot be at LA.
        nop
LOOP1
                             ; and go get another 24-bit word.
                             ; finish bootstrap
       bra <FINISH
IHOSTLD
       jclr #0,omr,PCIHOSTLD ; If MD:MC:MB:MA=x100, go load from PCI HOST
; This routine loads from the Host Interface in ISA (UNIVERSAL) mode.
; MD:MC:MB:MA=x101 - Host ISA
; Using self configuration mode, the base address in CBMA is written with
; $2f which corresponds to an ISA HTXR address of $2fe (Serial Port 2 Modem
; Status read only register).
ISAHOSTLD
       move #$5a,b
                             ; b1=$5a0000
       movep b1,X:M_DCTR
                         ; Configure HI32 as Self-Config
       movep #$00002f, X:M_DPMC; write to DPMC
       rep #4
      movep X0,X:M DPAR
                           ; write to DPAR (CSTR+CCMR, CCCR+CRID, CLAT, CBMA)
                            ; completing 32 bit write
; Switch to ISA mode
       movep X0,X:M DCTR
                           ; Software personal reset
       move #$010020,y1
                            ; width 16, offset 32
                            ; (also used as replacement to needed NOP after
                              ;sw reset!)
       movep \#$3a0000,X:M_DCTR ; HM=$3 (UB)
```

```
; HIRD=1 (HIRQ_ pin - drive high enabled)
                               ; HIRH=0 (HIRQ_ pin - handshake disabled)
                               ; HRSP=1 (HRST pin - active low)
                               ; HDRP=0 (HDRQ pin - active high)
                               ; HTAP=0 (HTA pin - active high)
                               ; HDSM=0 (Data-strobe pin mode enabled)
; read the "magic sequence" 32 consecutive words with value $37
_LBLC
       do #32, LOOP3
       jclr #2,X:M_DSR,*
                              ; Wait for SRRQ to go high (i.e. data ready)
       movep X:M_DRXR,A1
                              ; Store 24-bit data into A1
       and #$00ffff,A
                              ; Mask upper byte
       cmp #$37,A
                              ; Compare the 24-bit dat to $000037
                             ; If data = $37 then go back to loop
       beq <_LBLD
       enddo
                              ; else break the loop and retry
       bra <_LBLC
_LBLD
       nop
_LOOP3
; read new CBMA value ("ISA base address")
       jclr #2,X:M_DSR,*
                           ; Wait for SRRQ to go high (i.e. data ready)
       movep X:M_DRXR,A1
                             ; Store 24-bit data into A1
; Switch to Self Configuration mode
       movep X0,X:M_DCTR
                           ; Software personal reset
       movep A1,X:M_DPMC
                              ; write to DPMC
                    ; (also used as replacement to needed NOP after sw reset!)
       movep b1,X:M_DCTR ; Configure HI32 as Self-Config
       rep #4
       movep X0, X:M_DPAR ; write to DPAR (CSTR+CCMR, CCCR+CRID, CLAT, CBMA)
; Switch to ISA mode
       movep X0,X:M DCTR
                              ; Software personal reset
       move #$010010,x1
                               ; width 16, offset 16
                    ; (also used as replacement to needed NOP after sw reset!)
       movep #$3a0010,x:M_DCTR ; HM=$3 (UB)
                               ; HIRD=1 (HIRQ_ pin - drive high enabled)
                               ; HIRH=0 (HIRQ pin - handshake disabled)
                               ; HRSP=1 (HRST pin - active low)
                               ; HDRP=0 (HDRQ pin - active high)
                               ; HTAP=0 (HTA pin - active high)
                               ; HDSM=0 (Double-strobe pin mode enabled)
                               ; HF4 =1 (turn on flag 4 for handshake)
        jclr #2,X:M_DSR,* ; Wait for SRRQ to go high (i.e. data ready)
```

```
; Store number of words
       movep X:M_DRXR,a0
       jclr #2,X:M_DSR,*
                            ; Wait for SRRQ to go high (i.e. data ready)
       movep X:M_DRXR,x0
                            ; Store starting address
       jclr #2,X:M_DSR,*
                            ; Wait for SRRQ to go high (i.e. data ready)
       movep X:M_DRXR,y0
                            ; Store starting address
       insert x1,x0,a
                            ; concatenate next 16-bit word
       insert y1,y0,a
                            ; concatenate next 16-bit word
       move al,r0
                             ; start to p-mem
       move a0,a1
                             ; number of words to transfer
; Download P memory through UB
                              ; divide loop count by 2 and save r0
       lsr a
              r0,r1
                              ; Load instruction words
       do a1,_LOOP4
LBLE
       jset #2,X:M_DSR,_LBLF ; Wait for SRRQ to go high (i.e. data ready)
       jclr #3,X:M_DSR,_LBLE ; If HF0=1, stop loading new data.
       bra <TERMINATE
                             ; Terminate loop (enddo) and finish
LBLF
       movep X:M_DRXR,a0
                             ; Store 16-bit data in accumulator
LBLG
       jset #2,X:M_DSR,_LBLH ; Wait for SRRQ to go high (i.e. data ready)
       jclr #3,X:M_DSR,_LBLG ; If HF0=1, stop loading new data.
       bra <TERMINATE
                             ; Terminate loop (enddo) and finish
LBLH
       movep X:M_DRXR,x0 ; Store 16-bit data in register
\_{	t LBLI}
       jset #2,X:M_DSR,_LBLJ ; Wait for SRRQ to go high (i.e. data ready)
       jclr #3,X:M_DSR,_LBLI ; If HF0=1, stop loading new data.
       bra <TERMINATE
                             ; Terminate loop (enddo) and finish
_LBLJ
       movep X:M_DRXR,y0
                            ; Store 16-bit data in register
       insert x1,x0,a
                            ; concatenate next 16-bit word
                             ; concatenate next 16-bit word
       insert y1,y0,a
                             ; Store 24-bit data in P mem.
       movem a0,p:(r0)+
       movem al,p:(r0)+
                              ; Store 24-bit data in P mem.
                              ; movem cannot be at LA.
LOOP4
                              ; and go get another 24-bit word.
       bra <FINISH
                              ; finish bootstrap
; This is the routine that loads from the Host Interface in PCI mode.
; MD:MC:MB:MA=x100 - Host PCI
PCIHOSTLD
       bset #20,X:M DCTR ; Configure HI32 as PCI
UB3_CONT
```

```
; Wait for SRRQ to go high (i.e. data ready)
       jclr #2,X:M_DSR,*
                          ; Store number of words
      movep X:M_DRXR,a0
      jclr #2,X:M_DSR,*
                          ; Wait for SRRQ to go high (i.e. data ready)
      movep X:M_DRXR,r0
                          ; Store starting address
      move r0,r1
                           ; save r0
      do a0, LOOP5
                          ; Load instruction words
_LBLK
      jset #2,X:M_DSR,_LBLL ; Wait for SRRQ to go high (i.e. data ready)
      jclr #3,X:M_DSR,_LBLK ; If HF0=1, stop loading data. Else check SRRQ.
      bra <TERMINATE
                          ; Terminate loop (enddo) and finish
_LBLL
      movep X:M DRXR,P:(R0)+ ; Store 24-bit data in P mem.
                           ; movem cannot be at LA.
_LOOP5
                           ; and go get another 24-bit word.
                           ; finish bootstrap
      bra <FINISH
                           ;
EPRSCILD
      jclr #1,omr,EPROMLD ; If MD:MC:MB:MA=x001, go load from EPROM
      jclr #0,omr,SCILD
                          ; If MD:MC:MB:MA=x010, go load from SCI
                           ; If MD:MC:MB:MA=x011, 56301-to-56301 boot
; This is the routine for 56301-to-56301 boot.
; MD:MC:MB:MA=x011 - HI32 in UB mode, double strobe, HTA pin active low
UB3HOSTLD
      movep #$268000, x:M_DCTR; HM=$2 (UB)
                  ; HIRD=0 (HIRQ_ pin - drive high disabled, open drain)
                           ; HIRH=1 (HIRQ_ pin - handshake enabled)
                           ; HRSP=1 (HRST pin - active low)
                           ; HDRP=0 (HDRQ pin - active high)
                           ; HTAP=1 (HTA pin - active low)
                           ; HDSM=0 (Double-strobe pin mode enabled)
      bra <UB3_CONT
                          ; continue
; This is the routine that loads from the SCI.
; MD:MC:MB:MA=x010 - external SCI clock
SCILD
      movep #$0302,X:M SCR ; Configure SCI Control Reg
      movep #$C000,X:M_SCCR ; Configure SCI Clock Control Reg
```

```
; Configure SCLK, TXD and RXD
       movep #7,X:M_PCRE
       do #6,_LOOP6
                            ; get 3 bytes for number of
                            ; program words and 3 bytes
                            ; for the starting address
       jclr #2,X:M_SSR,*
                            ; Wait for RDRF to go high
                           ; Put 8 bits in A2
       movep X:M SRXL,A2
       jclr #1,X:M_SSR,*
                            ; Wait for TDRE to go high
       movep A2,X:M_STXL
                            ; echo the received byte
       asr #8,a,a
_LOOP6
                            ; starting address for load
       move a1,r0
       move al,rl
                            ; save starting address
       do a0,_LOOP7
                           ; Receive program words
       do #3,_LOOP8
       jclr #2,X:M_SSR,*
                          ; Wait for RDRF to go high
       movep X:M_SRXL,A2
                           ; Put 8 bits in A2
       jclr #1,X:M_SSR,*
                            ; Wait for TDRE to go high
       movep a2,X:M_STXL
                            ; echo the received byte
       asr #8,a,a
LOOP8
       movem al,p:(r0)+
                            ; Store 24-bit result in P mem.
                            ; movem cannot be at LA.
LOOP7
       bra <FINISH
                            ; Boot from SCI done
; This is the routine that loads from external EPROM.
; MD:MC:MB:MA=x001
EPROMLD
       move #BOOT,r2
       do #6,_LOOP9
                            ; read number of words and starting address
                            ; Get the 8 LSB from ext. P mem.
       movem p:(r2)+,a2
                            ; Shift 8 bit data into Al
       asr #8,a,a
LOOP9
       move a1,r0
                            ; starting address for load
                            ; save it in r1
       move al,rl
                            ; a0 holds the number of words
       do a0,_LOOP10
                           ; read program words
      do #3,_LOOP11
                           ; Each instruction has 3 bytes
       movem p:(r2)+,a2
                           ; Get the 8 LSB from ext. P mem.
```

```
asr #8,a,a
                          ; Shift 8 bit data into Al
_LOOP11
                          ; Go get another byte.
      movem al,p:(r0)+ ; Store 24-bit result in P mem.
                           ; movem cannot be at LA.
      nop
_LOOP10
                          ; and go get another 24-bit word.
      bra <FINISH
                           ; Boot from EPROM done
TERMINATE
      enddo
                           ; End the loop before exit.
FINISH
; This is the exit handler that returns execution to normal
; expanded mode and jumps to the RESET vector.
      andi #$0,ccr
                           ; Clear CCR as if RESET to 0.
      jmp (r1)
                           ; Then go to starting Prog addr.
; End of bootstrap code. Number of program words: 191.
```

dsp

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